# Freescale Semiconductor Technical Data

Document Number: MPC8379EEC

Rev. 4, 11/2010

# MPC8379E PowerQUICC II Pro Processor Hardware Specifications

This document provides an overview of the MPC8379E PowerQUICC II Pro processor features, including a block diagram showing the major functional components. The device is a cost-effective, low-power, highly integrated host processor that addresses the requirements of several printing and imaging, consumer, and industrial applications, including main CPUs and I/O processors in printing systems, networking switches and line cards, wireless LANs (WLANs), network access servers (NAS), VPN routers, intelligent NIC, and industrial controllers. The MPC8379E extends the PowerQUICC family, adding higher CPU performance, additional functionality, and faster interfaces while addressing the requirements related to time-to-market, price, power consumption, and package size.

# 1 Overview

The MPC8379E incorporates the e300c4s core, which includes 32 Kbytes of L1 instruction and data caches and on-chip memory management units (MMUs). The device offers two enhanced three-speed 10, 100, 1000 Mbps Ethernet interfaces, a DDR1/DDR2 SDRAM memory controller, a flexible, a 32-bit local bus controller, a 32-bit PCI controller, an optional dedicated security engine, a USB

#### Contents

1.	Overview
2.	Electrical Characteristics
3.	Power Characteristics
4.	Clock Input Timing
5.	RESET Initialization
6.	DDR1 and DDR2 SDRAM
7.	DUART
8.	Ethernet: Enhanced Three-Speed Ethernet (eTSEC) 23
9.	USB
10.	Local Bus 34
11.	Enhanced Secure Digital Host Controller (eSDHC) . 43
12.	JTAG 52
13.	$I^2C$ 50
14.	PCI 58
15.	Serial ATA (SATA) 60
16.	Timers 65
17.	GPIO 60
18.	IPIC 6'
19.	SPI 6
20.	High-Speed Serial Interfaces (HSSI)
21.	Package and Pin Listings 79
22.	Clocking9
23.	Thermal
24.	System Design Information
25.	Ordering Information
26.	Document Revision History

© Freescale Semiconductor, Inc., 2008-2010. All rights reserved.



#### Overview

2.0 dual-role controller, a programmable interrupt controller, dual I<sup>2</sup>C controllers, a 4-channel DMA controller, an enhanced secured digital host controller, and a general-purpose I/O port. Figure 1 shows the block diagram of the MPC8379E.

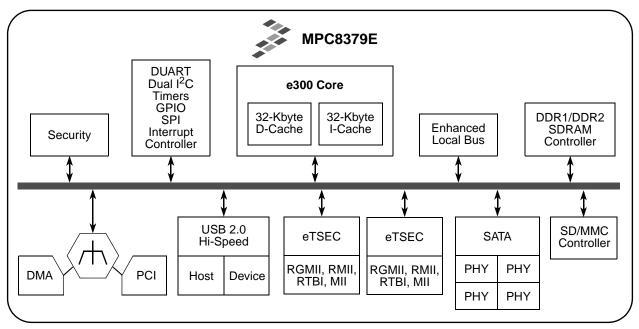


Figure 1. MPC8379E Block Diagram and Features

The following features are supported in the MPC8379E:

- e300c4s core built on Power Architecture® technology with 32-Kbyte instruction cache and 32-Kbyte data cache, a floating point unit, and two integer units
- DDR1/DDR2 memory controller supporting a 32/64-bit interface
- Peripheral interfaces, such as a 32-bit PCI interface with up to 66-MHz operation
- 32-bit local bus interface running up to 133-MHz
- USB 2.0 (full/high speed) support
- Power management controller for low-power consumption
- High degree of software compatibility with previous-generation PowerQUICC processor-based designs for backward compatibility and easier software migration
- Optional security engine provides acceleration for control and data plane security protocols

The optional security engine (SEC 3.0) is noted with the extension "E" at the end. It allows CPU-intensive cryptographic operations to be offloaded from the main CPU core. The security-processing accelerator provides hardware acceleration for the DES, 3DES, AES, SHA-1, and MD-5 algorithms.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Freescale Semiconductor

2

In addition to the security engine, a new high-speed interface, such as SATA, is included. Table 1 compares the differences between MPC837xE derivatives and provides the number of ports available for each interface.

Table 1. High-Speed Interfaces on the MPC8377E, MPC8378E, and MPC8379E

Descriptions	MPC8377E	MPC8378E	MPC8379E
SGMII	0	2	0
PCI Express®	2	2	0
SATA	2	0	4

# 1.1 DDR Memory Controller

The DDR1/DDR2 memory controller includes the following features:

- Single 32- or 64-bit interface supporting both DDR1 and DDR2 SDRAM
- Support for up to 400-MHz data rate
- Support up to 4 chip selects
- 64-Mbit to 2-Gbit (for DDR1) and to 4-Gbit (for DDR2) devices with ×8/×16/×32 data ports (no direct ×4 support)
- Support for up to 32 simultaneous open pages
- Supports auto refresh
- On-the-fly power management using CKE
- 1.8-/2.5-V SSTL2 compatible I/O

# 1.2 USB Dual-Role Controller

The USB controller includes the following features:

- Supports USB on-the-go mode, including both device and host functionality, when using an external ULPI (UTMI + low-pin interface) PHY
- Complies with USB Specification, Rev. 2.0
- Supports operation as a stand-alone USB device
  - Supports one upstream facing port
  - Supports three programmable USB endpoints
- Supports operation as a stand-alone USB host controller
  - Supports USB root hub with one downstream-facing port
  - Enhanced host controller interface (EHCI) compatible
- Supports high-speed (480 Mbps), full-speed (12 Mbps), and low-speed (1.5 Mbps) operation; low-speed operation is supported only in host mode
- Supports UTMI + low pin interface (ULPI)

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 1.3 Dual Enhanced Three-Speed Ethernet Controllers (eTSECs)

The eTSECs include the following features:

- Two enhanced Ethernet interfaces can be used for RGMII/MII/RMII/RTBI
- Two controllers conform to IEEE Std 802.3®, IEEE 802.3u, IEEE 802.3x, IEEE 802.3z, IEEE 802.3au, IEEE 802.3ab, and IEEE Std 1588<sup>TM</sup> standards
- Support for Wake-on-Magic Packet<sup>TM</sup>, a method to bring the device from standby to full operating mode
- MII management interface for external PHY control and status

# 1.4 Integrated Programmable Interrupt Controller (IPIC)

The integrated programmable interrupt controller (IPIC) implements the necessary functions to provide a flexible solution for general-purpose interrupt control. The IPIC programming model is compatible with the MPC8260 interrupt controller, and it supports 8 external and 34 internal discrete interrupt sources. Interrupts can also be redirected to an external interrupt controller.

# 1.5 Power Management Controller (PMC)

The power management controller includes the following features:

- Provides power management when the device is used in both host and agent modes
- Supports PCI Power Management 1.2 D0, D1, D2, and D3hot states
- Support for PME generation in PCI agent mode, PME detection in PCI host mode
- Supports Wake-on-LAN (Magic Packet), USB, GPIO, and PCI (PME input as host)
- Supports MPC8349E backward-compatibility mode

# 1.6 Serial Peripheral Interface (SPI)

The serial peripheral interface (SPI) allows the device to exchange data between other PowerQUICC family chips, Ethernet PHYs for configuration, and peripheral devices such as EEPROMs, real-time clocks, A/D converters, and ISDN devices.

The SPI is a full-duplex, synchronous, character-oriented channel that supports a four-wire interface (receive, transmit, clock, and slave select). The SPI block consists of transmitter and receiver sections, an independent baud-rate generator, and a control unit.

# 1.7 DMA Controller, Dual I<sup>2</sup>C, DUART, Enhanced Local Bus Controller (eLBC), and Timers

The device provides an integrated four-channel DMA controller with the following features:

- Allows chaining (both extended and direct) through local memory-mapped chain descriptors (accessible by local masters)
- Supports misaligned transfers

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

There are two I<sup>2</sup>C controllers. These synchronous, multi-master buses can be connected to additional devices for expansion and system development.

The DUART supports full-duplex operation and is compatible with the PC16450 and PC16550 programming models. 16-byte FIFOs are supported for both the transmitter and the receiver.

The main component of the enhanced local bus controller (eLBC) is its memory controller, which provides a seamless interface to many types of memory devices and peripherals. The memory controller is responsible for controlling eight memory banks shared by a NAND Flash control machine (FCM), a general-purpose chip-select machine (GPCM), and up to three user-programmable machines (UPMs). As such, it supports a minimal glue logic interface to SRAM, EPROM, NOR Flash EPROM, NAND Flash, EPROM, burstable RAM, regular DRAM devices, extended data output DRAM devices, and other peripherals. The eLBC external address latch enable (LALE) signal allows multiplexing of addresses with data signals to reduce the device pin count.

The enhanced local bus controller also includes a number of data checking and protection features, such as data parity generation and checking, write protection, and a bus monitor to ensure that each bus cycle is terminated within a user-specified period. The local bus can operate at up to 133 MHz.

The system timers include the following features: periodic interrupt timer, real time clock, software watchdog timer, and two general-purpose timer blocks.

# 1.8 Security Engine

The optional security engine is optimized to handle all the algorithms associated with IPSec, IEEE 802.11i, and iSCSI. The security engine contains one crypto-channel, a controller, and a set of crypto execution units (EUs). The execution units are as follows:

- Data encryption standard execution unit (DEU), supporting DES and 3DES
- Advanced encryption standard unit (AESU), supporting AES
- Message digest execution unit (MDEU), supporting MD5, SHA1, SHA-256, and HMAC with any algorithm
- One crypto-channel supporting multi-command descriptor chains

## 1.9 PCI Controller

The PCI controller includes the following features:

- *PCI Specification Revision 2.3* compatible
- Single 32-bit data PCI interface operates at up to 66 MHz
- PCI 3.3-V compatible (not 5-V compatible)
- Support for host and agent modes
- On-chip arbitration, supporting 5 external masters on PCI
- Selectable hardware-enforced coherency

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 1.10 Serial ATA (SATA) Controllers

The serial ATA (SATA) controllers have the following features:

- Supports Serial ATA Rev 2.5 Specification
- Spread spectrum clocking on receive
- Asynchronous notification
- Hot Plug including asynchronous signal recovery
- Link power management
- Native command queuing
- Staggered spin-up and port multiplier support
- Port multiplier support
- SATA 1.5 and 3.0 Gb/s operation
- Interrupt driven
- Power management support
- Error handling and diagnostic features
  - Far end/near end loopback
  - Failed CRC error reporting
  - Increased ALIGN insertion rates
- Scrambling and CONT override

# 1.11 Enhanced Secured Digital Host Controller (eSDHC)

The enhanced SD host controller (eSDHC) has the following features:

- Conforms to SD Host Controller Standard Specification, Rev 2.0 with Test Event register support.
- Compatible with the MMC System Specification, Rev 4.0
- Compatible with the *SD Memory Card Specification, Rev 2.0*, and supports High Capacity SD memory cards
- Compatible with the SDIO Card Specification Rev, 1.2
- Designed to work with SD Memory, miniSD Memory, SDIO, miniSDIO, SD Combo, MMC, MMCplus, MMC 4x, and RS-MMC cards
- SD bus clock frequency up to 50 MHz
- Supports 1-/4-bit SD and SDIO modes, 1-/4-bit MMC modes
- Supports internal DMA capabilities

# 2 Electrical Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the MPC8379E. The device is currently targeted to these specifications. Some of these specifications are independent of the I/O cell, but are included for a more complete reference. These are not purely I/O buffer design specifications.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 2.1 Overall DC Electrical Characteristics

This section covers the ratings, conditions, and other characteristics.

# 2.1.1 Absolute Maximum Ratings

Table 2 provides the absolute maximum ratings.

Table 2. Absolute Maximum Ratings<sup>1</sup>

	Characteristic	Symbol	Max Value	Unit	Notes
Core supply volta	age	V <sub>DD</sub>	-0.3 to 1.1	V	_
PLL supply volta	ge (e300 core, eLBC, and system)	AV <sub>DD</sub>	-0.3 to 1.1	V	_
DDR1 and DDR	2 DRAM I/O voltage	GV <sub>DD</sub>	-0.3 to 2.75 -0.3 to 1.98	V	_
Three-speed Eth	nernet I/O, MII management voltage	LV <sub>DD</sub> [1,2]	-0.3 to 3.63	V	_
PCI, DUART, sys JTAG I/O voltage	stem control and power management, I <sup>2</sup> C, and	OV <sub>DD</sub>	-0.3 to 3.63	V	_
Local bus		LBV <sub>DD</sub>	-0.3 to 3.63	V	_
SerDes		L[1,2]_ <i>n</i> V <sub>DD</sub>	-0.3 to 1.1	V	6
Input voltage	DDR DRAM signals	MV <sub>IN</sub>	-0.3 to (GV <sub>DD</sub> + 0.3)	V	2, 4
	DDR DRAM reference	$MV_REF$	-0.3 to (GV <sub>DD</sub> + 0.3)	V	2, 4
	Three-speed Ethernet signals	LV <sub>IN</sub>	-0.3 to (LV <sub>DD</sub> + 0.3)	V	_
	PCI, DUART, CLKIN, system control and power management, I <sup>2</sup> C, and JTAG signals	OV <sub>IN</sub>	-0.3 to (OV <sub>DD</sub> + 0.3)	V	3, 4
Local Bus		LB <sub>IN</sub>	-0.3 to (LBV <sub>DD</sub> + 0.3)	V	5
Storage tempera	ture range	T <sub>STG</sub>	-55 to 150	°C	

### Notes:

Functional and tested operating conditions are given in Table 3. Absolute maximum ratings are stress ratings only, and functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.

<sup>&</sup>lt;sup>2</sup> Caution: MV<sub>IN</sub> must not exceed GV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.

<sup>&</sup>lt;sup>3</sup> Caution: OV<sub>IN</sub> must not exceed OV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.

<sup>&</sup>lt;sup>4</sup> (M,O)V<sub>IN</sub> and MV<sub>REF</sub> may overshoot/undershoot to a voltage and for a maximum duration as shown in Figure 2.

<sup>&</sup>lt;sup>5</sup> OV<sub>IN</sub> on the PCI interface may overshoot/undershoot according to the *PCI Electrical Specification* for 3.3-V operation, as shown in Figure 2.

 $<sup>^{6}</sup>$  L[1,2]\_nV\_DD includes SDAVDD\_0, XCOREVDD, and XPADVDD power inputs.

# 2.1.2 Power Supply Voltage Specification

Table 3 provides the recommended operating conditions for the device. Note that the values in Table 3 are the recommended and tested operating conditions. Proper device operation outside of these conditions is not guaranteed.

**Table 3. Recommended Operating Conditions** 

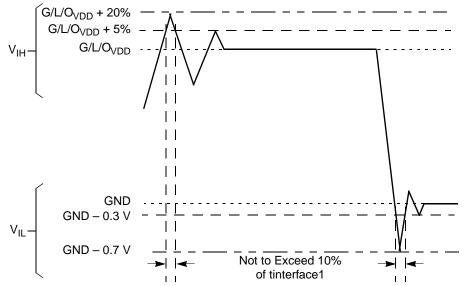
Characteristic		Symbol	Recommended Value	Unit	Notes
Core supply voltage	up to 667 MHz	$V_{DD}$	1.0 ± 50 mV	V	1
	800 MHz		1.05 ± 50 mV	V	1
PLL supply voltage (e300 core, eLBC and	up to 667 MHz	$AV_DD$	1.0 ± 50 mV	V	1
system)	800 MHz		1.05 ± 50 mV	V	1
DDR1 and DDR2 DRAM I/O voltage		GV <sub>DD</sub>	2.5 V ± 125 mV 1.8 V ± 90 mV	V	1
Three-speed Ethernet I/O, MII management vo	oltage	LV <sub>DD</sub> [1,2]	3.3 V ± 165 mV 2.5 V ± 125 mV	V	_
PCI, local bus, DUART, system control and pow JTAG I/O voltage	ver management, I <sup>2</sup> C, and	OV <sub>DD</sub>	3.3 V ± 165 mV	V	1
Local Bus		LBV <sub>DD</sub>	1.8 V ± 90 mV 2.5 V ± 125 mV 3.3 V ± 165 mV	V	_
SerDes	up to 667 MHz	L[1,2]_ <i>n</i> V <sub>DD</sub>	1.0 ± 50 mV	V	1, 2
	800 MHz		1.05 V ± 50 mV	V	1, 2
Operating temperature range	commerical	T <sub>a</sub> T <sub>j</sub>	T <sub>a</sub> =0 (min)— T <sub>j</sub> =125 (max)	°C	_
	extended temperature	T <sub>a</sub> T <sub>j</sub>	T <sub>a</sub> =–40 (min)— T <sub>j</sub> =125 (max)	°C	_

#### Notes:

<sup>&</sup>lt;sup>1</sup> GV<sub>DD</sub>, OV<sub>DD</sub>, AV<sub>DD</sub>, and V<sub>DD</sub> must track each other and must vary in the same direction—either in the positive or negative direction.

 $<sup>^2</sup>$  L[1,2]\_nV<sub>DD</sub>, SDAV<sub>DD</sub>\_0, XCOREV<sub>DD</sub>, and XPADV<sub>DD</sub> power inputs.

Figure 2 shows the undershoot and overshoot voltages at the interfaces of the device.



#### Note:

- 1. Note that t<sub>interface</sub> refers to the clock period associated with the bus clock interface.
- 2. Please note that with the PCI overshoot allowed (as specified above), the device does not fully comply with the maximum AC ratings and device protection guideline outlined in the PCI Rev. 2.3 Specification (Section 4.2.2.3).

Figure 2. Overshoot/Undershoot Voltage for  $GV_{DD}/OV_{DD}/LV_{DD}$ 

# 2.1.3 Output Driver Characteristics

Table 4 provides information on the characteristics of the output driver strengths. The values are preliminary estimates.

Driver Type 1 Output Impedance ( $\Omega$ ) **Supply Voltage** 45 Local bus interface utilities signals  $LBV_{DD} = 2.5 \text{ V}, 3.3 \text{ V}$ 40  $LBV_{DD} = 1.8 V$ PCI signals 25  $OV_{DD} = 3.3 V$ DDR1 signal 18  $GV_{DD} = 2.5 V$  $GV_{DD} = 1.8 V$ DDR2 signal 18 eTSEC 10/100/1000 signals  $LV_{DD} = 2.5 \text{ V}, 3.3 \text{ V}$ 45 DUART, system control, I<sup>2</sup>C, JTAG, SPI, and USB 45  $OV_{DD} = 3.3 V$ 45 GPIO signals  $OV_{DD} = 3.3 V$ 

**Table 4. Output Drive Capability** 

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Specialized SerDes output capabilities are described in the relevant section of the specification (such as SATA)

# 2.2 Power Sequencing

The device requires its power rails to be applied in a specific sequence in order to ensure proper device operation. During the power ramp up, before the power supplies are stable and if the I/O voltages are supplied before the core voltage, there may be a period of time that all input and output pins will actively be driven and cause contention and excessive current. To avoid actively driving the I/O pins and to eliminate excessive current draw, apply the core voltages ( $V_{DD}$  and  $AV_{DD}$ ) before the I/O voltages and assert  $\overline{PORESET}$  before the power supplies fully ramp up.  $V_{DD}$  and  $AV_{DD}$  must reach 90% of their nominal value before  $GV_{DD}$ ,  $LV_{DD}$ , and  $OV_{DD}$  reach 10% of their value, see Figure 3. I/O voltage supplies— $GV_{DD}$ ,  $LV_{DD}$ , and  $OV_{DD}$ —do not have any ordering requirements with respect to one another.

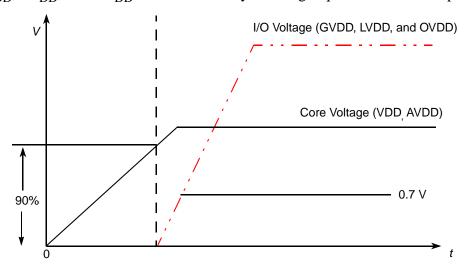


Figure 3. Power-Up Sequencing Example

Please note that the SerDes power supply ( $L[1,2]_nV_{DD}$ ) should follow the same timing as the core supply ( $V_{DD}$ ).

The opposite sequence applies to the power down requirements. The I/O supplies must go down first and immediately followed by the core and PLL supplies.

# 3 Power Characteristics

The estimated typical power dissipation for the MPC8379E device is shown in Table 5.

Core Frequency (MHz)	CSB/DDR Frequency (MHz)	Sleep Power at $T_j = 65^{\circ}C$ (W) <sup>2</sup>	Typical Application at $T_j = 65^{\circ}C$ (W) <sup>2</sup>	Typical Application at $T_j = 125^{\circ}C$ (W) <sup>3</sup>	Max Application at $T_j = 125^{\circ}C$ (W) <sup>4</sup>
333	333	1.45	1.9	3.2	3.8
333	167	1.45	1.8	3.0	3.6
400	400	1.45	2.0	3.3	4.0
400	266	1.45	1.9	3.1	3.8

Table 5. MPC8379E Power Dissipation <sup>1</sup>

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 5. MPC8379E Power Dissipation <sup>1</sup> (continued)

Core Frequency (MHz)	CSB/DDR Frequency (MHz)	Sleep Power at $T_j = 65^{\circ}C$ (W) <sup>2</sup>	Typical Application at $T_j = 65^{\circ}C$ (W) <sup>2</sup>	Typical Application at T <sub>j</sub> = 125°C (W) <sup>3</sup>	Max Application at T <sub>j</sub> = 125°C (W) <sup>4</sup>
450	300	1.45	2.0	3.2	3.8
450	225	1.45	1.9	3.1	3.7
500	333	1.45	2.0	3.3	3.9
300	250	1.45	1.9	3.2	3.8
533	355	1.45	2.0	3.3	4.0
333	266	1.45	2.0	3.2	3.9
600	400	1.45	2.1	3.4	4.1
600	300	1.45	2.0	3.3	4.0
667	333	1.45	2.1	3.3	4.1
667	266	1.45	2.0	3.3	3.9
800	400	1.45	2.5	3.8	4.3

#### Note:

 $<sup>^{1}~</sup>$  The values do not include I/O supply power (OV  $_{\rm DD}$ , LV  $_{\rm DD}$ , GV  $_{\rm DD}$ ) or AV  $_{\rm DD}$ . For I/O power values, see Table 6.

 $<sup>^2</sup>$  Typical power is based on a voltage of  $V_{DD}$  = 1.0 V for core frequencies  $\leq$  667 MHz or  $V_{DD}$  = 1.05 V for core frequencies of 800 MHz, and running a Dhrystone benchmark application.

 $<sup>^3</sup>$  Typical power is based on a voltage of  $V_{DD}$  = 1.0 V for core frequencies  $\leq$  667 MHz or  $V_{DD}$  = 1.05 V for core frequencies of 800 MHz, and running a Dhrystone benchmark application.

<sup>&</sup>lt;sup>4</sup> Maximum power is based on a voltage of V<sub>DD</sub> = 1.0 V for core frequencies ≤ 667 MHz or V<sub>DD</sub> = 1.05 V for core frequencies of 800 MHz, worst case process, and running an artificial smoke test.

#### **Power Characteristics**

Table 6 shows the estimated typical I/O power dissipation for the device.

Table 6. MPC8379E Typical I/O Power Dissipation

Interface	Parameter	GV <sub>DD</sub> (1.8 V)	GV <sub>DD</sub> /LBV <sub>DD</sub> (2.5 V)	OV <sub>DD</sub> (3.3 V)	LV <sub>DD</sub> (3.3 V)	LV <sub>DD</sub> (2.5 V)	L[1,2]_ <i>n</i> V <sub>DD</sub> (1.0 V)	Unit	Comments
	200 MHz data rate, 32-bit	0.28	0.35	_	_	_	_	W	_
	200 MHz data rate, 64-bit	0.41	0.49	_	_	_	_	W	
	266 MHz data rate, 32-bit	0.31	0.4	_	_	_	_	W	
	266 MHz data rate, 64-bit	0.46	0.56	_	_	_	_	W	
DDR I/O 65%	300 MHz data rate, 32-bit	0.33	0.43	_	_	_	_	W	
utilization 2 pair of	300 MHz data rate, 64-bit	0.48	0.6	_	_	_	_	W	
clocks	333 MHz data rate, 32-bit	0.35	0.45	_	_	_	_	W	
	333 MHz data rate, 64-bit	0.51	0.64	_	_	_	_	W	
	400 MHz data rate, 32-bit	0.38	_	_	_	_		W	
	400 MHz data rate, 64-bit	0.56	_	_	_	_	_	W	
PCI I/O Load =	33 MHz, 32-bit	_	_	0.04	_	_	_	W	_
30 pf	66 MHz, 32-bit	_	_	0.07	_	_	_	W	
	167 MHz, 32-bit	0.09	0.17	0.29	_	_	_	W	_
Local Bus	133 MHz, 32-bit	0.07	0.14	0.24	_	_	_	W	
I/O Load =	83 MHz, 32-bit	0.05	0.09	0.15	_	_	_	W	
25 pf	66 MHz, 32-bit	0.04	0.07	0.13	_	_	_	W	
	50 MHz, 32-bit	0.03	0.06	0.1	_	_	_	W	

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 6. MPC8379E Typical I/O Power Dissipation (continued)

Interface	Parameter	GV <sub>DD</sub> (1.8 V)	GV <sub>DD</sub> /LBV <sub>DD</sub> (2.5 V)	OV <sub>DD</sub> (3.3 V)	LV <sub>DD</sub> (3.3 V)	LV <sub>DD</sub> (2.5 V)	L[1,2]_ <i>n</i> V <sub>DD</sub> (1.0 V)	Unit	Comments
-T0F0 1/0	MII or RMII	-	1		0.02	_	1		Multiply by number of interfaces used.
eTSEC I/O Load = 25 pf	RGMII or RTBI	_	_	_	_	0.05	_	W	_
USB	12 Mbps		_	0.01	_	_	_	W	_
(60MHz Clock)	480 Mbps	_	_	0.2	_	_	_	W	
SerDes	per lane	_	_		_	_	0.029	W	_
Other I/O	_	_	_	0.01	_	_	_	W	

Note: The values given are for typical, and not worst case, switching.

# 4 Clock Input Timing

This section provides the clock input DC and AC electrical characteristics for the MPC8379E. Note that the PCI\_CLK/PCI\_SYNC\_IN signal or CLKIN signal is used as the PCI input clock depending on whether the device is configured as a host or agent device. CLKIN is used when the device is in host mode.

# 4.1 DC Electrical Characteristics

Table 7 provides the clock input (CLKIN/PCI\_CLK) DC timing specifications for the device.

Table 7. CLKIN DC Electrical Characteristics

Parameter	Condition	Symbol	Min	Max	Unit	Notes
Input high voltage	_	V <sub>IH</sub>	2.7	OV <sub>DD</sub> + 0.3	V	1
Input low voltage	_	V <sub>IL</sub>	-0.3	0.4	V	1
CLKIN Input current	$0\ V \leq V_{IN} \leq OV_{DD}$	I <sub>IN</sub>	_	± 10	μΑ	_
PCI_CLK Input current	$\begin{array}{c} 0 \text{ V} \leq \text{V}_{IN} \leq 0.5 \text{ V or} \\ \text{OV}_{DD} - 0.5 \text{ V} \leq \text{V}_{IN} \leq \text{OV}_{DD} \end{array}$	I <sub>IN</sub>	_	± 30	μΑ	_

#### Note:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

In PCI agent mode, this specification does not comply with PCI 2.3 Specification.

# 4.2 AC Electrical Characteristics

The primary clock source for the device can be one of two inputs, CLKIN or PCI\_CLK, depending on whether the device is configured in PCI host or PCI agent mode. Table 8 provides the clock input (CLKIN/PCI\_CLK) AC timing specifications for the device.

**Table 8. CLKIN AC Timing Specifications** 

Parameter	Symbol	Min	Typical	Max	Unit	Notes
CLKIN/PCI_CLK frequency	f <sub>CLKIN</sub>	25	_	66.666	MHz	1, 6
CLKIN/PCI_CLK cycle time	t <sub>CLKIN</sub>	15	_	40	ns	_
CLKIN/PCI_CLK rise and fall time	t <sub>KH</sub> , t <sub>KL</sub>	0.6	1.0	2.3	ns	2
CLKIN/PCI_CLK duty cycle	t <sub>KHK</sub> /t <sub>CLKIN</sub>	40	_	60	%	3
CLKIN/PCI_CLK jitter	_	_	_	± 150	ps	4, 5

#### Notes

# 4.3 eTSEC Gigabit Reference Clock Timing

Table 9 provides the eTSEC gigabit reference clocks (EC\_GTX\_CLK125) AC timing specifications.

## Table 9. EC\_GTX\_CLK125 AC Timing Specifications

At recommended operating conditions with LV<sub>DD</sub> =  $2.5 \pm 0.125$  mV/ 3.3 V  $\pm 165$  mV

Parameter/Condition	Symbol	Min	Typical	Max	Unit	Notes
EC_GTX_CLK125 frequency	t <sub>G125</sub>	_	125	_	MHz	_
EC_GTX_CLK125 cycle time	t <sub>G125</sub>	_	8	_	ns	_
EC_GTX_CLK rise and fall time	<sup>t</sup> G125R <sup>/t</sup> G125F	_	_	0.75 1.0	ns	1
EC_GTX_CLK125 duty cycle 1000Base-T for RGMII, RTBI	t <sub>G125H</sub> /t <sub>G125</sub>	47	_	53	%	2
EC_GTX_CLK125 jitter	_	_	_	±150	ps	2

#### Notes:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Caution: The system, core and security block must not exceed their respective maximum or minimum operating frequencies.

 $<sup>^{2}\,</sup>$  Rise and fall times for CLKIN/PCI\_CLK are measured at 0.4 V and 2.7 V.

<sup>&</sup>lt;sup>3</sup> Timing is guaranteed by design and characterization.

<sup>&</sup>lt;sup>4</sup> This represents the total input jitter-short term and long term-and is guaranteed by design.

The CLKIN/PCI\_CLK driver's closed loop jitter bandwidth should be < 500 kHz at -20 dB. The bandwidth must be set low to allow cascade-connected PLL-based devices to track CLKIN drivers with the specified jitter.</p>

Spread spectrum is allowed up to 1% down-spread on CLKIN/PCI\_CLK up to 60 KHz.

<sup>&</sup>lt;sup>1</sup> Rise and fall times for EC\_GTX\_CLK125 are measured from 0.5 and 2.0 V for  $LV_{DD}$  = 2.5 V and from 0.6 and 2.7 V for  $LV_{DD}$  = 3.3 V.

<sup>&</sup>lt;sup>2</sup> EC\_GTX\_CLK125 is used to generate the GTX clock for the eTSEC transmitter with 2% degradation. The EC\_GTX\_CLK125 duty cycle can be loosened from 47%/53% as long as the PHY device can tolerate the duty cycle generated by the eTSEC GTX\_CLK. See Section 8.2.2, "RGMII and RTBI AC Timing Specifications," for the duty cycle for 10Base-T and 100Base-T reference clock.

# 5 RESET Initialization

This section describes the DC and AC electrical specifications for the reset initialization timing and electrical requirements of the MPC8379E.

# 5.1 RESET DC Electrical Characteristics

Table 10 provides the DC electrical characteristics for the RESET pins of the device.

**Table 10. RESET Pins DC Electrical Characteristics** 

Characteristic	Symbol	Condition	Min	Max	Unit
Input high voltage	V <sub>IH</sub>	_	2.0	OV <sub>DD</sub> + 0.3	V
Input low voltage	V <sub>IL</sub>	_	-0.3	0.8	V
Input current	I <sub>IN</sub>	_	_	± 30	μА
Output high voltage	V <sub>OH</sub>	$I_{OH} = -8.0 \text{ mA}$	2.4	_	V
Output low voltage	V <sub>OL</sub>	I <sub>OL</sub> = 8.0 mA	_	0.5	V
Output low voltage	V <sub>OL</sub>	I <sub>OL</sub> = 3.2 mA	_	0.4	V

#### Note:

- This table applies for pins PORESET and HRESET. The PORESET is input pin, thus stated output voltages are not relevant.
- ullet HRESET and  $\overline{\text{SRESET}}$  are open drain pin, thus  $V_{OH}$  is not relevant for these pins.

# 5.2 RESET AC Electrical Characteristics

Table 11 provides the reset initialization AC timing specifications of the device.

**Table 11. RESET Initialization Timing Specifications** 

Parameter/Condition	Min	Max	Unit	Notes
Required assertion time of HRESET to activate reset flow	32	_	t <sub>PCI_SYNC_IN</sub>	1
Required assertion time of PORESET with stable clock applied to CLKIN when the device is in PCI host mode	32	_	t <sub>CLKIN</sub>	2
Required assertion time of PORESET with stable clock applied to PCI_CLK when the device is in PCI agent mode	32	_	t <sub>PCI_SYNC_IN</sub>	1
HRESET assertion (output)	512	_	t <sub>PCI_SYNC_IN</sub>	1
HRESET negation to negation (output)	16	_	t <sub>PCI_SYNC_IN</sub>	1
Input setup time for POR config signals (CFG_RESET_SOURCE[0:3], CFG_CLKIN_DIV, and CFG_LBMUX) with respect to negation of PORESET when the device is in PCI host mode	4	_	<sup>t</sup> CLKIN	2
Input setup time for POR config signals (CFG_RESET_SOURCE[0:3], CFG_CLKIN_DIV, and CFG_LBMUX) with respect to negation of PORESET when the device is in PCI agent mode	4	_	tPCI_SYNC_IN	1
Input hold time for POR config signals with respect to negation of HRESET	0	_	ns	_

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 11. RESET Initialization Timing Specifications (continued)

Parameter/Condition	Min	Max	Unit	Notes
Time for the device to turn off POR config signals with respect to the assertion of HRESET	_	4	ns	3
Time for the device to start driving functional output signals multiplexed with the POR configuration signals with respect to the negation of HRESET	1	_	t <sub>PCI_SYNC_IN</sub>	1, 3

#### Note:

Table 12 provides the PLL lock times.

**Table 12. PLL Lock Times** 

Parameter	Min	Мах	Unit	Notes
PLL lock times	_	100	μS	_

#### Note:

• The device guarantees the PLL lock if the clock settings are within spec range. The core clock also depends on the core PLL ratio. See Section 22, "Clocking," for more information.

# 6 DDR1 and DDR2 SDRAM

This section describes the DC and AC electrical specifications for the DDR SDRAM interface of the MPC8379E. Note that DDR1 SDRAM is  $GV_{DD}(typ) = 2.5 \text{ V}$  and DDR2 SDRAM is  $GV_{DD}(typ) = 1.8 \text{ V}$ .

# 6.1 DDR1 and DDR2 SDRAM DC Electrical Characteristics

Table 13 provides the recommended operating conditions for the DDR2 SDRAM component(s) of the device when  $GV_{DD}(typ) = 1.8 \text{ V}$ .

Table 13. DDR2 SDRAM DC Electrical Characteristics for GV<sub>DD</sub>(typ) = 1.8 V

Parameter	Symbol	Min Max		Unit	Notes
I/O supply voltage	GV <sub>DD</sub>	1.71	1.89	V	1
I/O reference voltage	$MV_REF$	$0.49 \times \text{GV}_{\text{DD}}$	$0.51 \times \text{GV}_{\text{DD}}$	V	2, 5
I/O termination voltage	V <sub>TT</sub>	MV <sub>REF</sub> - 0.04	MV <sub>REF</sub> + 0.04	V	3
Input high voltage	V <sub>IH</sub>	MV <sub>REF</sub> + 0.140	GV <sub>DD</sub> + 0.3	V	_
Input low voltage	V <sub>IL</sub>	-0.3	MV <sub>REF</sub> – 0.140	V	_
Output leakage current	l <sub>OZ</sub>	-40	40	μΑ	4
Output high current (V <sub>OUT</sub> = 1.40 V)	I <sub>OH</sub>	-13.4	_	mA	_

#### MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

t<sub>PCI\_SYNC\_IN</sub> is the clock period of the input clock applied to PCI\_SYNC\_IN. When the device is In PCI host mode the primary clock is applied to the CLKIN input, and PCI\_SYNC\_IN period depends on the value of CFG\_CLKIN\_DIV. See the MPC8379E Integrated Host Processor Reference Manual for more details.

<sup>2</sup> t<sub>CLKIN</sub> is the clock period of the input clock applied to CLKIN. It is only valid when the device is in PCI host mode. See the MPC8379E Integrated Host Processor Reference Manual for more details.

<sup>&</sup>lt;sup>3</sup> POR config signals consists of CFG\_RESET\_SOURCE[0:3], CFG\_LBMUX, and CFG\_CLKIN\_DIV.

Table 13. DDR2 SDRAM DC Electrical Characteristics for GV<sub>DD</sub>(typ) = 1.8 V (continued)

Parameter	Symbol	Min	Мах	Unit	Notes
Output low current (V <sub>OUT</sub> = 0.3 V)	I <sub>OL</sub>	13.4	_	mA	_

#### Note:

- $^{1}\,$  GV  $_{DD}$  is expected to be within 50 mV of the DRAM GV  $_{DD}$  at all times.
- MV<sub>REF</sub> is expected to be equal to 0.5 × GV<sub>DD</sub>, and to track GV<sub>DD</sub> DC variations as measured at the receiver. Peak-to-peak noise on MV<sub>REF</sub> may not exceed ±2% of the DC value.
- V<sub>TT</sub> is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV<sub>REF</sub>. This rail should track variations in the DC level of MV<sub>REF</sub>.
- <sup>4</sup> Output leakage is measured with all outputs disabled, 0 V  $\leq$  V<sub>OUT</sub>  $\leq$  GV<sub>DD</sub>.
- <sup>5</sup> See AN3665, "MPC837xE Design Checklist," for proper DDR termination.

Table 14 provides the DDR2 capacitance when  $GV_{DD}(typ) = 1.8 \text{ V}$ .

Table 14. DDR2 SDRAM Capacitance for GV<sub>DD</sub>(typ) = 1.8 V

Parameter	Symbol	Min	Max	Unit	Notes
Input/output capacitance: DQ, DQS, DQS	C <sub>IO</sub>	6	8	pF	1
Delta input/output capacitance: DQ, DQS, DQS	C <sub>DIO</sub>	_	0.5	pF	1

#### Note:

Table 15 provides the recommended operating conditions for the DDR SDRAM component(s) when  $GV_{DD}(typ) = 2.5 \text{ V}$ .

Table 15. DDR SDRAM DC Electrical Characteristics for GV<sub>DD</sub> (typ) = 2.5 V

Parameter	Symbol	Min	Max	Unit	Notes
I/O supply voltage	GV <sub>DD</sub>	2.375	2.625	V	1
I/O reference voltage	MV <sub>REF</sub>	$0.49 \times \text{GV}_{\text{DD}}$	$0.51 \times \text{GV}_{\text{DD}}$	V	2, 5
I/O termination voltage	V <sub>TT</sub>	MV <sub>REF</sub> - 0.04	MV <sub>REF</sub> + 0.04	V	3
Input high voltage	V <sub>IH</sub>	MV <sub>REF</sub> + 0.18	GV <sub>DD</sub> + 0.3	V	_
Input low voltage	V <sub>IL</sub>	-0.3	MV <sub>REF</sub> - 0.18	V	_
Output leakage current	I <sub>OZ</sub>	-40	40	μА	4
Output high current (V <sub>OUT</sub> = 1.9 V)	I <sub>OH</sub>	-15.2	_	mA	_
Output low current (V <sub>OUT</sub> = 0.38 V)	I <sub>OL</sub>	15.2	_	mA	_

#### Note:

- <sup>1</sup> GV<sub>DD</sub> is expected to be within 50 mV of the DRAM GV<sub>DD</sub> at all times.
- $^{2}$  MV<sub>REF</sub> is expected to be equal to  $0.5 \times \text{GV}_{\text{DD}}$ , and to track GV<sub>DD</sub> DC variations as measured at the receiver. Peak-to-peak noise on MV<sub>REF</sub> may not exceed  $\pm 2\%$  of the DC value.
- <sup>3</sup> V<sub>TT</sub> is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV<sub>REF</sub>. This rail should track variations in the DC level of MV<sub>REF</sub>.
- <sup>4</sup> Output leakage is measured with all outputs disabled,  $0 \text{ V} \leq V_{OUT} \leq GV_{DD}$ .
- <sup>5</sup> See AN3665, "MPC837xE Design Checklist," for proper DDR termination.

#### MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> This parameter is sampled.  $GV_{DD} = 1.8 \text{ V} \pm 0.090 \text{ V}$ , f = 1 MHz,  $T_A = 25^{\circ}\text{C}$ ,  $V_{OUT} = GV_{DD}/2$ ,  $V_{OUT}$  (peak-to-peak) = 0.2 V.

#### DDR1 and DDR2 SDRAM

Table 16 provides the DDR capacitance when  $GV_{DD}(typ) = 2.5 \text{ V}$ .

Table 16. DDR SDRAM Capacitance for GV<sub>DD</sub> (typ) = 2.5 V

Parameter	Symbol	Min	Max	Unit	Notes
Input/output capacitance: DQ, DQS	C <sub>IO</sub>	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C <sub>DIO</sub>	_	0.5	pF	1

#### Note:

Table 17 provides the current draw characteristics for MV<sub>REF</sub>.

Table 17. Current Draw Characteristics for MV<sub>REF</sub>

Parameter	Symbol	Min	Тур	Max	Unit	Note
Current draw for MV <sub>REF</sub> DDR1  DDR2			250 150	600 400	μА	1, 2

#### Note:

# 6.2 DDR1 and DDR2 SDRAM AC Electrical Characteristics

This section provides the AC electrical characteristics for the DDR SDRAM interface.

# 6.2.1 DDR1 and DDR2 SDRAM Input AC Timing Specifications

Table 18 provides the input AC timing specifications for the DDR2 SDRAM when GVDD(typ) = 1.8 V.

Table 18. DDR2 SDRAM Input AC Timing Specifications for 1.8-V Interface

Parameter	Symbol	Min	Max	Unit
AC input low voltage	V <sub>IL</sub>	_	MV <sub>REF</sub> – 0.25	V
AC input high voltage	V <sub>IH</sub>	MV <sub>REF</sub> + 0.25	_	V

Table 19 provides the input AC timing specifications for the DDR1 SDRAM when  $GV_{DD}(typ) = 2.5 \text{ V}$ .

Table 19. DDR1 SDRAM Input AC Timing Specifications for 2.5-V Interface

Parameter	Symbol	Min	Max	Unit
AC input low voltage	V <sub>IL</sub>	_	MV <sub>REF</sub> – 0.31	V
AC input high voltage	V <sub>IH</sub>	MV <sub>REF</sub> + 0.31		V

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> This parameter is sampled.  $GV_{DD} = 2.5 \text{ V} \pm 0.125 \text{ V}$ , f = 1 MHz,  $T_A = 25^{\circ}\text{C}$ ,  $V_{OUT} = GV_{DD}/2$ ,  $V_{OUT}$  (peak-to-peak) = 0.2 V.

<sup>&</sup>lt;sup>1</sup> The voltage regulator for MV<sub>RFF</sub> must be able to supply up to the stated maximum current.

<sup>&</sup>lt;sup>2</sup> This current is divided equally between MVREF1 and MVREF2, where half the current flows through each pin.

Table 20 provides the input AC timing specifications for the DDR1 and DDR2 SDRAM interface.

Table 20. DDR1 and DDR2 SDRAM Input AC Timing Specifications

Parameter	Symbol	Min	Max	Unit	Notes
Controller skew for MDQS-MDQ/MECC/MDM 400 MHz data rate 333 MHz data rate 266 MHz data rate		-500 -750 -750	500 750 750	ps	1, 2 3 —

#### Note:

# 6.2.2 DDR1 and DDR2 SDRAM Output AC Timing Specifications

Table 21 shows the DDR1 and DDR2 SDRAM output AC timing specifications.

Table 21. DDR1 and DDR2 SDRAM Output AC Timing Specifications

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
MCKn cycle time, MCKn/MCKn crossing	t <sub>MCK</sub>	5	10	ns	2
ADDR/CMD output setup with respect to MCK 400 MHz data rate 333 MHz data rate 266 MHz data rate 200 MHz data rate	t <sub>DDKHAS</sub>	1.95 2.40 3.15 4.20	_ _ _ _ _	ns	3, 7
ADDR/CMD output hold with respect to MCK 400 MHz data rate 333 MHz data rate 266 MHz data rate 200 MHz data rate	t <sub>DDKHAX</sub>	1.95 2.40 3.15 4.20	_ _ _ _	ns	3, 7
MCSn output setup with respect to MCK 400 MHz data rate 333 MHz data rate 266 MHz data rate 200 MHz data rate	<sup>t</sup> DDKHCS	1.95 2.40 3.15 4.20	_ _ _ _	ns	3
MCSn output hold with respect to MCK  400 MHz data rate 333 MHz data rate 266 MHz data rate 200 MHz data rate	<sup>t</sup> DDKHCX	1.95 2.40 3.15 4.20	- - - -	ns	3
MCK to MDQS skew	t <sub>DDKHMH</sub>	-0.6	0.6	ns	4, 8

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

t<sub>CISKEW</sub> represents the total amount of skew consumed by the controller between MDQS*n* and any corresponding bit that will be captured with MDQS*n*. This should be subtracted from the total timing budget.

<sup>&</sup>lt;sup>2</sup> The amount of skew that can be tolerated from MDQS to a corresponding MDQ signal is called t<sub>DISKEW</sub>. This can be determined by the following equation: t<sub>DISKEW</sub> = ±[T/4 – |t<sub>CISKEW</sub>|] where T is the MCK clock period and |t<sub>CISKEW</sub>| is the absolute value of t<sub>CISKEW</sub>.

<sup>&</sup>lt;sup>3</sup> This specification applies only to DDR2 interface.

#### DDR1 and DDR2 SDRAM

Table 21. DDR1 and DDR2 SDRAM Output AC Timing Specifications (continued)

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
MDQ//MDM output setup with respect to MDQS 400 MHz data rate 333 MHz data rate 266 MHz data rate 200 MHz data rate	<sup>t</sup> DDKHDS, <sup>t</sup> DDKLDS	550 800 1100 1200		ps	5, 8
MDQ//MDM output hold with respect to MDQS 400 MHz data rate 333 MHz data rate 266 MHz data rate 200 MHz data rate	<sup>t</sup> DDKHDX, <sup>t</sup> DDKLDX	700 800 1100 1200	_ _ _ _	ps	5, 8
MDQS preamble start	t <sub>DDKHMP</sub>	$-0.5 \times t_{MCK} -0.6$	$-0.5 \times t_{MCK} + 0.6$	ns	6, 8
MDQS epilogue end	t <sub>DDKHME</sub>	-0.6	0.6	ns	6, 8

#### Note:

- The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)</sub> for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state)</sub> for outputs. Output hold time can be read as DDR timing (DD) from the rising or falling edge of the reference clock (KH or KL) until the output went invalid (AX or DX). For example, t<sub>DDKHAS</sub> symbolizes DDR timing (DD) for the time t<sub>MCK</sub> memory clock reference (K) goes from the high (H) state until outputs (A) are setup (S) or output valid time. Also, t<sub>DDKLDX</sub> symbolizes DDR timing (DD) for the time t<sub>MCK</sub> memory clock reference (K) goes low (L) until data outputs (D) are invalid (X) or data output hold time.
- <sup>2</sup> All MCK/MCK referenced measurements are made from the crossing of the two signals ±0.1 V.
- <sup>3</sup> ADDR/CMD includes all DDR SDRAM output signals except MCK/MCK, MCS, and MDQ//MDM/MDQS.
- Note that t<sub>DDKHMH</sub> follows the symbol conventions described in Note 1. For example, t<sub>DDKHMH</sub> describes the DDR timing (DD) from the rising edge of the MCK[n] clock (KH) until the MDQS signal is valid (MH). t<sub>DDKHMH</sub> can be modified through control of the DQSS override bits in the TIMING\_CFG\_2 register. This will typically be set to the same delay as the clock adjust in the CLK\_CNTL register. The timing parameters listed in the table assume that these 2 parameters have been set to the same adjustment value. See the MPC8379E PowerQUICC II Pro Host Processor Reference Manual for a description and understanding of the timing modifications enabled by use of these bits.
- Determined by maximum possible skew between a data strobe (MDQS) and any corresponding bit of data MDQ, ECC, or data mask (MDM). The data strobe should be centered inside of the data eye at the pins of the microprocessor.
- <sup>6</sup> All outputs are referenced to the rising edge of MCK*n* at the pins of the microprocessor. Note that t<sub>DDKHMP</sub> follows the symbol conventions described in Note 1.
- Clock Control register is set to adjust the memory clocks by 1/2 the applied cycle.
- <sup>8</sup> See AN3665, "MPC837xE Design Checklist," for proper DDR termination.

The minimum frequency for DDR2 is 250 MHz data rate (125 MHz clock), 167 MHz data rate (83 MHz clock) for DDR1.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Figure 4 shows the DDR1 and DDR2 SDRAM output timing for the MCK to MDQS skew measurement (t<sub>DDKHMH</sub>).

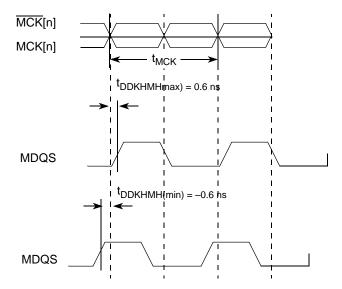


Figure 4. DDR Timing Diagram for t<sub>DDKHMH</sub>

Figure 5 shows the DDR1 and DDR2 SDRAM output timing diagram.

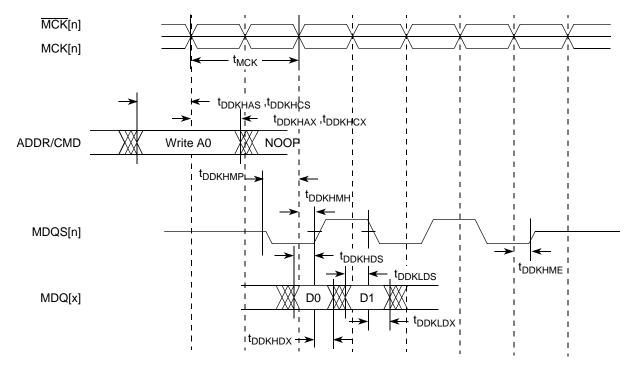


Figure 5. DDR1 and DDR2 SDRAM Output Timing Diagram

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Figure 6 provides the AC test load for the DDR bus.

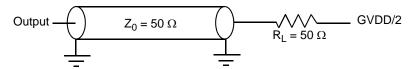


Figure 6. DDR AC Test Load

# 7 DUART

This section describes the DC and AC electrical specifications for the DUART interface of the MPC8379E.

# 7.1 DUART DC Electrical Characteristics

Table 22 provides the DC electrical characteristics for the DUART interface of the device.

**Parameter Symbol** Min Max Unit ٧ High-level input voltage  $V_{\text{IH}}$  $OV_{DD} + 0.3$ Low-level input voltage OVDD ٧ -0.30.8  $V_{IL}$ High-level output voltage,  $V_{OH}$  $OV_{DD} - 0.2$ ٧  $I_{OH} = -100 \mu A$ Low-level output voltage,  $V_{OL}$ 0.2 V  $I_{OL} = 100 \mu A$ Input current,  $I_{IN}$ ±30 μΑ  $(0 \text{ V} \leq \text{V}_{IN} \leq \text{OV}_{DD})$ 

**Table 22. DUART DC Electrical Characteristics** 

#### Note

# 7.2 DUART AC Electrical Specifications

Table 23 provides the AC timing parameters for the DUART interface of the device.

**Table 23. DUART AC Timing Specifications** 

Parameter	Value	Unit	Notes
Minimum baud rate	256	baud	_
Maximum baud rate	> 1,000,000	baud	1
Oversample rate	16	_	2

#### Notes:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

ullet The symbol  $V_{IN}$ , in this case, represents the  $OV_{IN}$  symbol referenced in Table 2.

Actual attainable baud rate will be limited by the latency of interrupt processing.

<sup>&</sup>lt;sup>2</sup> The middle of a start bit is detected as the 8<sup>th</sup> sampled 0 after the 1-to-0 transition of the start bit. Subsequent bit values are sampled each 16<sup>th</sup> sample.

# 8 Ethernet: Enhanced Three-Speed Ethernet (eTSEC)

This section provides the AC and DC electrical characteristics for the enhanced three-speed Ethernet controller.

# 8.1 Enhanced Three-Speed Ethernet Controller (eTSEC) (10/100/1000 Mbps)—MII/RGMII/RTBI/RMII DC Electrical Characteristics

The electrical characteristics specified here apply to media independent interface (MII), reduced gigabit media independent interface (RGMII), reduced ten-bit interface (RTBI), reduced media independent interface (RMII) signals, management data input/output (MDIO) and management data clock (MDC).

The MII and RMII interfaces are defined for 3.3 V, while the RGMII and RTBI interfaces can be operated at 2.5 V. The RGMII and RTBI interfaces follow the *Reduced Gigabit Media-Independent Interface* (*RGMII*) Specification Version 1.3. The RMII interface follows the *RMII Consortium RMII Specification* Version 1.2.

# 8.1.1 MII, RMII, RGMII, and RTBI DC Electrical Characteristics

MII and RMII drivers and receivers comply with the DC parametric attributes specified in Table 24 and Table 25. The RGMII and RTBI signals in Table 25 are based on a 2.5 V CMOS interface voltage as defined by JEDEC EIA/JESD8-5.

Parameter	Symbol	Min	Max	Unit	Notes
Supply voltage 3.3 V	LV <sub>DD1</sub> LV <sub>DD2</sub>	3.13	3.47	V	
Output high voltage $(LV_{DD1}/LV_{DD2} = Min, I_{OH} = -4.0 mA)$	V <sub>OH</sub>	2.40	$LV_{DD1}/LV_{DD2} + 0.3$	V	_
Output low voltage (LV <sub>DD1</sub> /LV <sub>DD2</sub> = Min, I <sub>OL</sub> = 4.0 mA)	V <sub>OL</sub>	GND	0.50	V	_
Input high voltage	V <sub>IH</sub>	2.0	LV <sub>DD1</sub> /LV <sub>DD2</sub> + 0.3	V	_
Input low voltage	V <sub>IL</sub>	-0.3	0.90	V	_
Input high current (V <sub>IN</sub> = LV <sub>DD1</sub> , V <sub>IN</sub> = LV <sub>DD2</sub> )	I <sub>IH</sub>	_	30	μА	
Input low current (V <sub>IN</sub> = GND)	I <sub>IL</sub>	-600	_	μА	_

Table 24. MII and RMII DC Electrical Characteristics

#### Note:

 $\ensuremath{\mathsf{LV}_{\mathsf{DD2}}}$  supports eTSEC 2.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>1.</sup>  $LV_{DD1}$  supports eTSEC 1.

**Ethernet: Enhanced Three-Speed Ethernet (eTSEC)** 

Table 25. RGMII and RTBI DC Electrical Characteristics

Parameter	Symbol	Min	Мах	Unit	Notes
Supply voltage 2.5 V	LV <sub>DD1</sub> LV <sub>DD2</sub>	2.37	2.63	V	1, 2
Output high voltage (LV <sub>DD1</sub> /LV <sub>DD2</sub> = Min, IOH = -1.0 mA)	V <sub>OH</sub>	2.00	LV <sub>DD1</sub> /LV <sub>DD2</sub> + 0.3	V	_
Output low voltage (LV <sub>DD1</sub> /LV <sub>DD2</sub> = Min, I <sub>OL</sub> = 1.0 mA)	V <sub>OL</sub>	GND - 0.3	0.40	V	_
Input high voltage	V <sub>IH</sub>	1.7	$LV_{DD1}/LV_{DD2} + 0.3$	V	_
Input low voltage	V <sub>IL</sub>	-0.3	0.70	V	_
Input high current $(V_{IN} = LV_{DD1}, V_{IN} = LV_{DD2})$	I <sub>IH</sub>	_	-20	μА	1, 2
Input low current (V <sub>IN</sub> = GND)	I <sub>IL</sub>	-20	_	μΑ	_

#### Note:

# 8.2 MII, RGMII, RMII, and RTBI AC Timing Specifications

The AC timing specifications for MII, RGMII, RMII, and RTBI are presented in this section.

# 8.2.1 MII AC Timing Specifications

This section describes the MII transmit and receive AC timing specifications.

# 8.2.1.1 MII Transmit AC Timing Specifications

Table 26 provides the MII transmit AC timing specifications.

### **Table 26. MII Transmit AC Timing Specifications**

At recommended operating conditions with LV<sub>DD</sub> of 3.3 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit
TX_CLK clock period 10 Mbps	t <sub>MTX</sub>	_	400	_	ns
TX_CLK clock period 100 Mbps	t <sub>MTX</sub>	_	40	_	ns
TX_CLK duty cycle	t <sub>MTXH</sub> /t <sub>MTX</sub>	35	_	65	%
TX_CLK to MII data TXD[3:0], TX_ER, TX_EN delay	t <sub>MTKHDX</sub>	1	5	15	ns

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> LV<sub>DD1</sub> supports eTSEC 1.

<sup>&</sup>lt;sup>2</sup> LV<sub>DD2</sub> supports eTSEC 2.

#### Table 26. MII Transmit AC Timing Specifications (continued)

At recommended operating conditions with LV<sub>DD</sub> of 3.3 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit
TX_CLK data clock rise (20%–80%)	t <sub>MTXR</sub>	1.0	_	4.0	ns
TX_CLK data clock fall (80%–20%)	t <sub>MTXF</sub>	1.0	_	4.0	ns

<sup>1.</sup> The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>MTKHDX</sub> symbolizes MII transmit timing (MT) for the time t<sub>MTX</sub> clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of t<sub>MTX</sub> represents the MII(M) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

Figure 7 shows the MII transmit AC timing diagram.

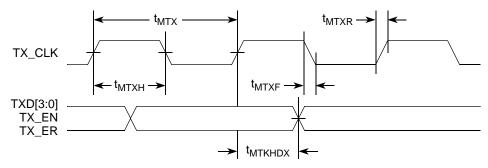


Figure 7. MII Transmit AC Timing Diagram

# 8.2.1.2 MII Receive AC Timing Specifications

Table 27 provides the MII receive AC timing specifications.

#### **Table 27. MII Receive AC Timing Specifications**

At recommended operating conditions with LV  $_{DD}$  of 3.3 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit
Input low voltage	V <sub>IL</sub>	_	_	0.7	V
Input high voltage	V <sub>IH</sub>	1.9	_	_	V
RX_CLK clock period 10 Mbps	t <sub>MRX</sub>	_	400	_	ns
RX_CLK clock period 100 Mbps	t <sub>MRX</sub>	_	40	_	ns
RX_CLK duty cycle	t <sub>MRXH</sub> /t <sub>MRX</sub>	35	_	65	%
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	t <sub>MRDVKH</sub>	10.0	_	_	ns
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	t <sub>MRDXKH</sub>	10.0	_	_	ns

#### Table 27. MII Receive AC Timing Specifications (continued)

At recommended operating conditions with LV<sub>DD</sub> of 3.3 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit
RX_CLK clock rise time (20%–80%)	t <sub>MRXR</sub>	1.0	_	4.0	ns
RX_CLK clock fall time (80%–20%)	t <sub>MRXF</sub>	1.0	_	4.0	ns

1. The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>MRDVKH</sub> symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>MRX</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>MRDXKL</sub> symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>MRX</sub> clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t<sub>MRX</sub> represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

#### Figure 8 provides the AC test load for eTSEC.

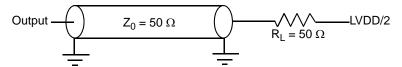


Figure 8. eTSEC AC Test Load

Figure 9 shows the MII receive AC timing diagram.

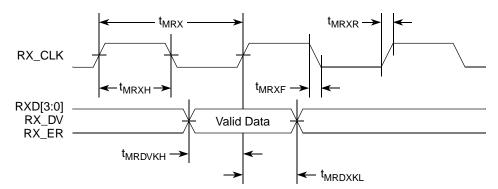


Figure 9. MII Receive AC Timing Diagram

# 8.2.2 RGMII and RTBI AC Timing Specifications

Table 28 presents the RGMII and RTBI AC timing specifications.

#### Table 28. RGMII and RTBI AC Timing Specifications

At recommended operating conditions with LV<sub>DD</sub> of 2.5 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit	Notes
Data to clock output skew (at transmitter)	t <sub>SKRGT</sub>	-600	0	600	ps	_
Data to clock input skew (at receiver)	t <sub>SKRGT</sub>	1.0	_	2.8	ns	2
Clock period	t <sub>RGT</sub>	7.2	8.0	8.8	ns	3

#### MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Ethernet: Enhanced Three-Speed Ethernet (eTSEC)

#### Table 28. RGMII and RTBI AC Timing Specifications (continued)

At recommended operating conditions with LV<sub>DD</sub> of 2.5 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit	Notes
Duty cycle for 1000Base-T	t <sub>RGTH</sub> /t <sub>RGT</sub>	45	50	55	%	4
Duty cycle for 10BASE-T and 100BASE-TX	t <sub>RGTH</sub> /t <sub>RGT</sub>	40	50	60	%	3, 4
Rise time (20%–80%)	t <sub>RGTR</sub>	_	_	0.75	ns	_
Fall time (20%–80%)	t <sub>RGTF</sub>	_	_	0.75	ns	_
EC_GTX_CLK125 reference clock period	t <sub>G12</sub>	_	8.0	_	ns	5
EC_GTX_CLK125 reference clock duty cycle measured at $0.5 \times \text{LV}_{DD1}$	t <sub>G125H</sub> /t <sub>G125</sub>	47	_	53	%	_

#### Note:

- Note that, in general, the clock reference symbol representation for this section is based on the symbols RGT to represent RGMII and RTBI timing. Note also that the notation for rise (R) and fall (F) times follows the clock symbol that is being represented. For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (RGT).
- <sup>2</sup> This implies that PC board design will require clocks to be routed such that an additional trace delay of greater than 1.5 ns will be added to the associated clock signal.
- $^3$  For 10 and 100 Mbps,  $t_{RGT}$  scales to 400 ns ± 40 ns and 40 ns ± 4 ns, respectively.
- <sup>4</sup> Duty cycle may be stretched/shrunk during speed changes or while transitioning to a received packet's clock domains as long as the minimum duty cycle is not violated and stretching occurs for no more than three t<sub>RGT</sub> of the lowest speed transitioned between
- <sup>5</sup> This symbol represents the external EC\_GTX\_CLK125 and does not follow the original signal naming convention.

Figure 10 provides the AC test load for eTSEC.

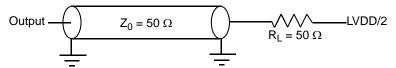


Figure 10. eTSEC AC Test Load

Figure 11 shows the RGMII and RTBI AC timing and multiplexing diagrams.

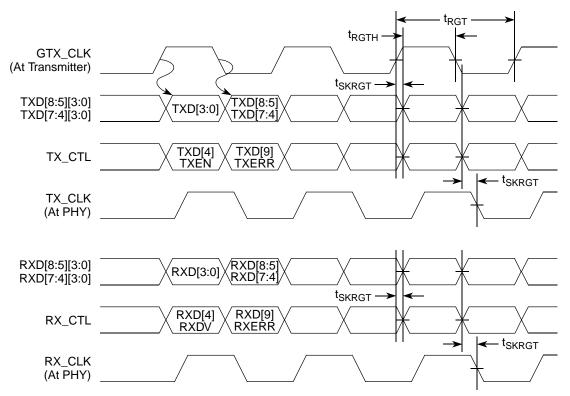


Figure 11. RGMII and RTBI AC Timing and Multiplexing Diagrams

# 8.2.3 RMII AC Timing Specifications

This section describes the RMII transmit and receive AC timing specifications.

# 8.2.3.1 RMII Transmit AC Timing Specifications

The RMII transmit AC timing specifications are in Table 29.

#### **Table 29. RMII Transmit AC Timing Specifications**

At recommended operating conditions with LV  $_{DD}$  of 3.3 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit
REF_CLK clock period	t <sub>RMT</sub>	15.0	20.0	25.0	ns
REF_CLK duty cycle	t <sub>RMTH</sub>	35	50	65	%
REF_CLK peak-to-peak jitter	t <sub>RMTJ</sub>	_	_	250	ps
Rise time REF_CLK (20%–80%)	t <sub>RMTR</sub>	1.0	_	2.0	ns

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### Table 29. RMII Transmit AC Timing Specifications (continued)

At recommended operating conditions with LV<sub>DD</sub> of 3.3 V  $\pm$  5%.

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit
Fall time REF_CLK (80%–20%)	t <sub>RMTF</sub>	1.0	_	2.0	ns
REF_CLK to RMII data TXD[1:0], TX_EN delay	t <sub>RMTDX</sub>	2.0	1	10.0	ns

#### Note:

Figure 12 shows the RMII transmit AC timing diagram.

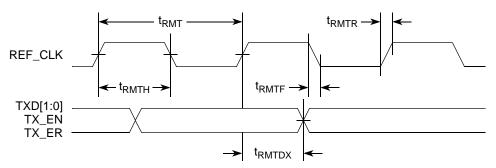


Figure 12. RMII Transmit AC Timing Diagram

# 8.2.3.2 RMII Receive AC Timing Specifications

Table 30 shows the RMII receive AC timing specifications.

#### **Table 30. RMII Receive AC Timing Specifications**

At recommended operating conditions with LV<sub>DD</sub> of 3.3 V  $\pm$  5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Typical	Max	Unit
Input low voltage at 3.3 LV <sub>DD</sub>	V <sub>IL</sub>	_	_	0.8	V
Input high voltage at 3.3 LV <sub>DD</sub>	V <sub>IH</sub>	2.0	_	_	V
REF_CLK clock period	t <sub>RMR</sub>	15.0	20.0	25.0	ns
REF_CLK duty cycle	t <sub>RMRH</sub>	35	50	65	%
REF_CLK peak-to-peak jitter	t <sub>RMRJ</sub>	_	_	250	ps
Rise time REF_CLK (20%–80%)	t <sub>RMRR</sub>	1.0	_	2.0	ns
Fall time REF_CLK (80%–20%)	t <sub>RMRF</sub>	1.0	_	2.0	ns

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>MTKHDX</sub> symbolizes MII transmit timing (MT) for the time t<sub>MTX</sub> clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of t<sub>MTX</sub> represents the MII(M) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

#### Table 30. RMII Receive AC Timing Specifications (continued)

At recommended operating conditions with LV<sub>DD</sub> of 3.3 V  $\pm$  5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Typical	Max	Unit
RXD[1:0], CRS_DV, RX_ER setup time to REF_CLK rising edge	t <sub>RMRDV</sub>	4.0	_	_	ns
RXD[1:0], CRS_DV, RX_ER hold time to REF_CLK rising edge	t <sub>RMRDX</sub>	2.0	_	_	ns

#### Note:

Figure 13 provides the AC test load for eTSEC.

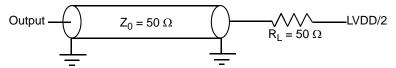


Figure 13. eTSEC AC Test Load

Figure 14 shows the RMII receive AC timing diagram.

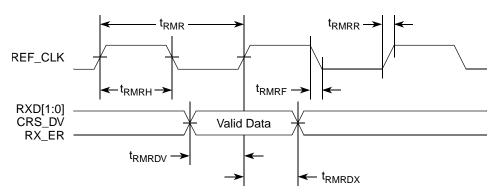


Figure 14. RMII Receive AC Timing Diagram

# 8.3 Management Interface Electrical Characteristics

The electrical characteristics specified here apply to MII management interface signals MDIO (management data input/output) and MDC (management data clock).

Figure 15 provides the AC test load for eTSEC.

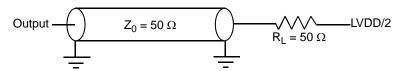


Figure 15. eTSEC AC Test Load

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>MRDVKH</sub> symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>MRX</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>MRDXKL</sub> symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>MRX</sub> clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t<sub>MRX</sub> represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

# 8.3.1 MII Management DC Electrical Characteristics

The MDC and MDIO are defined to operate at a supply voltage of 2.5 V or 3.3 V. The DC electrical characteristics for MDIO and MDC are provided in Table 31 and Table 32.

Table 31. MII Management DC Electrical Characteristics When Powered at 2.5 V

Parameter	Conditions		Symbol	Min	Max	Unit
Supply voltage (2.5 V)	_		LV <sub>DD1</sub>	2.37	2.63	V
Output high voltage	$I_{OH} = -1.0 \text{ mA}$	LV <sub>DD1</sub> = Min	V <sub>OH</sub>	2.00	LV <sub>DD1</sub> + 0.3	V
Output low voltage	I <sub>OL</sub> = 1.0 mA	LV <sub>DD1</sub> = Min	V <sub>OL</sub>	GND - 0.3	0.40	V
Input high voltage	_	LV <sub>DD1</sub> = Min	V <sub>IH</sub>	1.7	_	V
Input low voltage	_	LV <sub>DD1</sub> = Min	V <sub>IL</sub>	-0.3	0.70	V
Input high current	$V_{IN} = LV_{DD1}$		I <sub>IH</sub>	_	20	μΑ
Input low current	V <sub>II</sub>	N = LV <sub>DD1</sub>	I <sub>IL</sub>	-15	_	μΑ

Table 32. MII Management DC Electrical Characteristics When Powered at 3.3 V

Parameter	Conditions		Symbol	Min	Max	Unit
Supply voltage (3.3 V)	_		LV <sub>DD1</sub>	3.135	3.465	V
Output high voltage	I <sub>OH</sub> = -1.0 mA	LV <sub>DD1</sub> = Min	V <sub>OH</sub>	2.10	LV <sub>DD1</sub> + 0.3	V
Output low voltage	I <sub>OL</sub> = 1.0 mA	LV <sub>DD1</sub> = Min	V <sub>OL</sub>	GND	0.50	V
Input high voltage	_	_	V <sub>IH</sub>	2.00	_	V
Input low voltage	_	_	V <sub>IL</sub>	_	0.80	V
Input high current	LV <sub>DD1</sub> = Max	V <sub>IN</sub> <sup>1</sup> = 2.1 V	I <sub>IH</sub>	_	30	μА
Input low current	LV <sub>DD1</sub> = Max	V <sub>IN</sub> = 0.5 V	I <sub>IL</sub>	-600	_	μА

# 8.3.2 MII Management AC Electrical Specifications

Table 33 provides the MII management AC timing specifications.

**Table 33. MII Management AC Timing Specifications** 

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit	Notes
MDC frequency	f <sub>MDC</sub>	2.5	_	8.3	MHz	2, 3
MDC period	t <sub>MDC</sub>	80	_	400	ns	_
MDC clock pulse width high	t <sub>MDCH</sub>	32	_	_	ns	_
MDC to MDIO valid	t <sub>MDKHDV</sub>	$2 \times (t_{plb\_clk} \times 8)$		_	ns	5
MDC to MDIO delay	t <sub>MDKHDX</sub>	10	_	$2 \times (t_{plb\_clk} \times 8)$	ns	3, 5
MDIO to MDC setup time	t <sub>MDDVKH</sub>	5	_	_	ns	_
MDIO to MDC hold time	t <sub>MDDXKH</sub>	0	_	_	ns	_

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 33. MII Management AC Timing Specifications (continued)

Parameter	Symbol <sup>1</sup>	Min	Typical	Max	Unit	Notes
MDC rise time (20%–80%)	t <sub>MDCR</sub>	_	_	10	ns	4
MDC fall time (80%–20%)	t <sub>MDCF</sub>		1	10	ns	4

#### Note:

- The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>MDKHDX</sub> symbolizes management data timing (MD) for the time t<sub>MDC</sub> from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also, t<sub>MDDVKH</sub> symbolizes management data timing (MD) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>MDC</sub> clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- <sup>2</sup> This parameter is dependent on the system clock speed. (The maximum frequency is the maximum platform frequency divided by 64.)
- <sup>3</sup> This parameter is dependent on the system clock speed. (That is, for a system clock of 267 MHz, the maximum frequency is 8.3 MHz and the minimum frequency is 1.2 MHz; for a system clock of 375 MHz, the maximum frequency is 11.7 MHz and the minimum frequency is 1.7 MHz.)
- <sup>4</sup> Guaranteed by design.
- <sup>5</sup> t<sub>plb\_clk</sub> is the platform (CSB) clock divided according to the SCCR[TSEC1CM].

Figure 16 shows the MII management AC timing diagram.

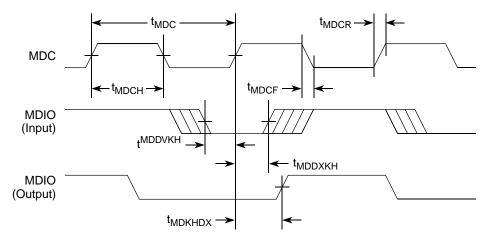


Figure 16. MII Management Interface Timing Diagram

# 9 USB

This section provides the AC and DC electrical characteristics for the USB dual-role controllers.

# 9.1 USB DC Electrical Characteristics

Table 34 provides the DC electrical characteristics for the ULPI interface at recommended  $OV_{DD} = 3.3 \text{ V} \pm 165 \text{ mV}$ .

Table 34. USB DC Electrical Characteristics

Parameter	Symbol	Min	Max	Unit	Notes
High-level input voltage	V <sub>IH</sub>	2	OV <sub>DD</sub> + 0.3	V	1
Low-level input voltage	V <sub>IL</sub>	-0.3	0.8	V	1
Input current	I <sub>IN</sub>	_	±30	μΑ	2
High-level output voltage, $I_{OH} = -100 \mu A$	V <sub>OH</sub>	OV <sub>DD</sub> - 0.2	_	V	_
Low-level output voltage, $I_{OL} = 100 \mu A$	V <sub>OL</sub>	_	0.2	V	_

#### Note:

# 9.2 USB AC Electrical Specifications

Table 35 describes the general timing parameters of the USB interface of the device.

Table 35. USB General Timing Parameters (ULPI Mode Only)

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
USB clock cycle time	t <sub>USCK</sub>	15	_	ns	2, 3, 4, 5
Input setup to USB clock—all inputs	t <sub>USIVKH</sub>	4	_	ns	2, 3, 4, 5
Input hold to USB clock—all inputs	t <sub>USIXKH</sub>	1	_	ns	2, 3, 4, 5
USB clock to output valid—all outputs	t <sub>uskhov</sub>	_	7	ns	2, 3, 4, 5
Output hold from USB clock—all outputs	t <sub>USKHOX</sub>	2	_	ns	2, 3, 4, 5

#### Note:

- <sup>2</sup> All timings are in reference to the USB clock, USBDR\_CLK.
- <sup>3</sup> All signals are measured from  $OV_{DD}/2$  of the rising edge of the USB clock to  $0.4 \times OV_{DD}$  of the signal in question for 3.3-V signaling levels.
- <sup>4</sup> Input timings are measured at the pin.
- <sup>5</sup> For active/float timing measurements, the high impedance or off state is defined to be when the total current delivered through the component pin is less than or equal to that of the leakage current specification.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

 $<sup>^{1}</sup>$  The minimum  $V_{IL}$  and maximum  $V_{IH}$  values are based on the respective minimum and maximum  $OV_{IN}$  values found in Table 3.

<sup>&</sup>lt;sup>2</sup> The symbol OV<sub>IN</sub> represents the input voltage of the supply and is referenced in Table 3.

The symbols for timing specifications follow the pattern of t<sub>(First two letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(First two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>USIXKH</sub> symbolizes USB timing (US) for the input (I) to go invalid (X) with respect to the time the USB clock reference (K) goes high (H). Also, t<sub>USKHOX</sub> symbolizes USB timing (US) for the USB clock reference (K) to go high (H) with respect to the output (O) going invalid (X) or output hold time.

Figure 17 and Figure 18 provide the AC test load and signals for the USB, respectively.

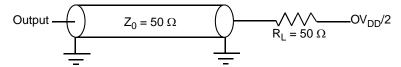


Figure 17. USB AC Test Load

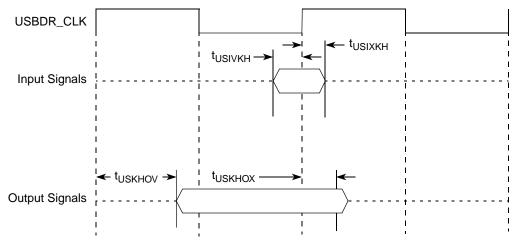


Figure 18. USB Interface Timing Diagram

# 10 Local Bus

This section describes the DC and AC electrical specifications for the local bus interface of the MPC8379E.

# 10.1 Local Bus DC Electrical Characteristics

Table 36, Table 37, and Table 38 provide the DC electrical characteristics for the local bus interface.

### Table 36. Local Bus DC Electrical Characteristics (LBV<sub>DD</sub> = 3.3 V)

At recommended operating conditions with LBV  $_{\rm DD}$  = 3.3 V.

Parameter	Conditions		Symbol	Min	Max	Unit
Supply voltage 3.3 V	_		LBV <sub>DD</sub>	3.135	3.465	V
Output high voltage	$I_{OH} = -4.0 \text{ mA}$	LBV <sub>DD</sub> = Min	V <sub>OH</sub>	2.40	_	V
Output low voltage	I <sub>OL</sub> = 4.0 mA	LBV <sub>DD</sub> = Min	V <sub>OL</sub>	_	0.50	V
Input high voltage	_	_	V <sub>IH</sub>	2.0	LBV <sub>DD</sub> + 0.3	V
Input low voltage	_	_	V <sub>IL</sub>	-0.3	0.90	V
Input high current	$V_{IN}^{1} = LBV_{DD}^{1}$		I <sub>IH</sub>	_	30	μΑ
Input low current	V <sub>IN</sub> <sup>1</sup> = 0	GND	I <sub>IL</sub>	-30	_	μΑ

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 37. Local Bus DC Electrical Characteristics (LBV<sub>DD</sub> = 2.5 V)

At recommended operating conditions with LBV $_{DD}$  = 2.5 V.

Parameter	Conditions		Symbol	Min	Max	Unit
Supply voltage 2.5 V	_	_	LBV <sub>DD</sub>	2.37	2.73	V
Output high voltage	$I_{OH} = -1.0 \text{ mA}$	LBV <sub>DD</sub> = Min	V <sub>OH</sub>	2.00	_	V
Output low voltage	I <sub>OL</sub> = 1.0 mA	LBV <sub>DD</sub> = Min	V <sub>OL</sub>	_	0.40	V
Input high voltage	_	LBV <sub>DD</sub> = Min	V <sub>IH</sub>	1.7	LBV <sub>DD</sub> + 0.3	V
Input low voltage	_	LBV <sub>DD</sub> = Min	V <sub>IL</sub>	-0.3	0.70	V
Input high current	$V_{IN}^{1} = LBV_{DD}$		I <sub>IH</sub>	_	20	μΑ
Input low current	V <sub>IN</sub> <sup>1</sup> =	= GND	I <sub>IL</sub>	-20	_	μΑ

Table 38. Local Bus DC Electrical Characteristics (LBV<sub>DD</sub> = 1.8 V)

At recommended operating conditions with LBV $_{\rm DD}$  = 1.8 V.

Parameter	Conditions		Symbol	Min	Max	Unit
Supply voltage 1.8 V	<del>-</del>		LBV <sub>DD</sub>	1.71	1.89	V
Output high voltage	$I_{OH} = -1.0 \text{ mA}$	LBV <sub>DD</sub> = Min	V <sub>OH</sub>	LBV <sub>DD</sub> - 0.45	_	V
Output low voltage	I <sub>OL</sub> = 1.0 mA	LBV <sub>DD</sub> = Min	V <sub>OL</sub>	_	0.45	V
Input high voltage	_	LBV <sub>DD</sub> = Min	V <sub>IH</sub>	$0.65 \times \text{LBV}_{\text{DD}}$	LBV <sub>DD</sub> + 0.3	V
Input low voltage	_	LBV <sub>DD</sub> = Min	V <sub>IL</sub>	-0.3	$0.35 \times \text{LBV}_{\text{DD}}$	V
Input high current	$V_{IN}^{1} = LBV_{DD}$		I <sub>IH</sub>	_	10	μΑ
Input low current	V <sub>IN</sub> <sup>1</sup> =	= GND	I <sub>IL</sub>	-10	_	μА

# 10.2 Local Bus AC Electrical Specifications

Table 39 describes the general timing parameters of the local bus interface of the device when in PLL enable mode.

Table 39. Local Bus General Timing Parameters—PLL Enable Mode

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus cycle time	t <sub>LBK</sub>	7.5	15	ns	2
Input setup to local bus clock (except LUPWAIT/LGTA)	t <sub>LBIVKH</sub>	1.5	_	ns	3, 4
Input hold from local bus clock	t <sub>LBIXKH</sub>	1.0	_	ns	3, 4
LUPWAIT/LGTA input setup to local bus clock	t <sub>LBIVKH1</sub>	1.5	_	ns	3, 4
LALE output fall to LAD output transition (LATCH hold time)	t <sub>LBOTOT1</sub>	1.5	_	ns	5
LALE output fall to LAD output transition (LATCH hold time)	t <sub>LBOTOT2</sub>	3	_	ns	6
LALE output fall to LAD output transition (LATCH hold time)	t <sub>LBOTOT3</sub>	2.5	_	ns	7
Local bus clock to LALE rise	t <sub>LBKHLR</sub>	_	4.5	ns	_
Local bus clock to output valid (except LALE)	t <sub>LBKHOV</sub>	_	4.5	ns	3

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **Local Bus**

#### Table 39. Local Bus General Timing Parameters—PLL Enable Mode (continued)

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus clock to output high impedance for LAD/LDP	t <sub>LBKHOZ</sub>	_	3.8	ns	3, 8
Output hold from local bus clock for LAD/LDP	t <sub>LBKHOX</sub>	1		ns	3

#### Note:

- The symbols used for timing specifications herein follow the pattern of t<sub>(First two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(First two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>LBIXKH1</sub> symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t<sub>LBK</sub> clock reference (K) goes high (H), in this case for clock one(1). Also, t<sub>LBKHOX</sub> symbolizes local bus timing (LB) for the t<sub>LBK</sub> clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
- $^2$  All timings are in reference to rising edge of LSYNC\_IN at LBV  $_{DD}/2$  and the 0.4  $\times$  LBV  $_{DD}$  of the signal in question.
- $^3$  All signals are measured from LBV<sub>DD</sub>/2 of the rising/falling edge of LSYNC\_IN to  $0.5 \times \text{LBV}_{DD}$  of the signal in question.
- <sup>4</sup> Input timings are measured at the pin.
- t<sub>LBOTOT1</sub> should be used when LBCR[AHD] is set and the load on LALE output pin is at least 10pF less than the load on LAD output pins.
- 6 t<sub>LBOTOT2</sub> should be used when LBCR[AHD] is not set and the load on LALE output pin is at least 10pF less than the load on LAD output pins.
- <sup>7</sup> t<sub>LBOTOT3</sub> should be used when LBCR[AHD] is not set and the load on LALE output pin equals to the load on LAD output pins.
- <sup>8</sup> For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Freescale Semiconductor

36

Table 40 describes the general timing parameters of the local bus interface of the device when in PLL bypass mode.

Table 40. Local Bus General Timing Parameters—PLL Bypass Mode

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus cycle time	t <sub>LBK</sub>	15	_	ns	2
Input setup to local bus clock	t <sub>LBIVKH</sub>	7.0	_	ns	3, 4
Input hold from local bus clock	t <sub>LBIXKH</sub>	1.0	_	ns	3, 4
LALE output fall to LAD output transition (LATCH hold time)	t <sub>LBOTOT1</sub>	1.5	_	ns	5
LALE output fall to LAD output transition (LATCH hold time)	t <sub>LBOTOT2</sub>	3.0	_	ns	6
LALE output fall to LAD output transition (LATCH hold time)	t <sub>LBOTOT3</sub>	2.5	_	ns	7
Local bus clock to LALE rise	t <sub>LBKHLR</sub>	_	4.5	ns	_
Local bus clock to output valid	t <sub>LBKHOV</sub>	_	3.0	ns	3
Local bus clock to output high impedance for LAD/LDP	t <sub>LBKHOZ</sub>	_	4.0	ns	3, 8

#### Note:

- The symbols used for timing specifications herein follow the pattern of t<sub>(First two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(First two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>LBIXKH1</sub> symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t<sub>LBK</sub> clock reference (K) goes high (H), in this case for clock one(1). Also, t<sub>LBKHOX</sub> symbolizes local bus timing (LB) for the t<sub>LBK</sub> clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
- <sup>2</sup> All timings are in reference to falling edge of LCLK0 (for all outputs and for LCLK0 and LUPWAIT inputs) or rising edge of LCLK0 (for all other inputs).
- All signals are measured from LBV<sub>DD</sub>/2 of the rising/falling edge of LCLK0 to 0.4 × LBV<sub>DD</sub> of the signal in question for 3.3-V signaling levels.
- <sup>4</sup> Input timings are measured at the pin.
- t<sub>LBOTOT1</sub> should be used when LBCR[AHD] is set and the load on LALE output pin is at least 10pF less than the load on LAD output pins.
- t<sub>LBOTOT2</sub> should be used when LBCR[AHD] is not set and the load on LALE output pin is at least 10pF less than the load on LAD output pins.
- $^7$   $_{
  m I_{BOTOT3}}$  should be used when LBCR[AHD] is not set and the load on LALE output pin equals to the load on LAD output pins.
- <sup>8</sup> For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.

Figure 19 provides the AC test load for the local bus.

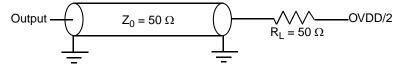


Figure 19. Local Bus AC Test Load

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Figure 20 through Figure 25 show the local bus signals.

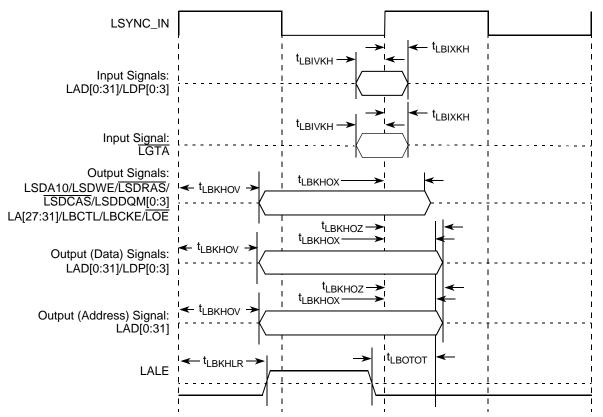


Figure 20. Local Bus Signals, Non-special Signals Only (PLL Enable Mode)

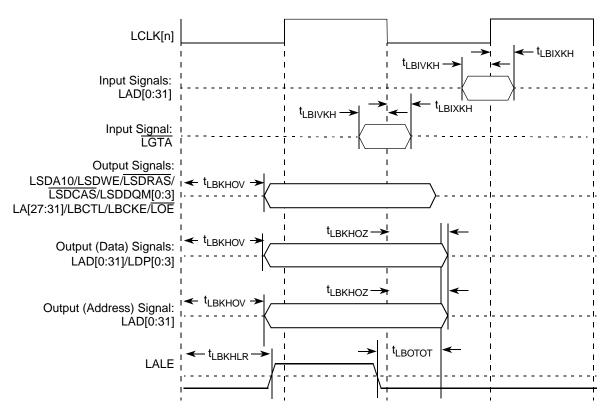


Figure 21. Local Bus Signals, Non-special Signals Only (PLL Bypass Mode)

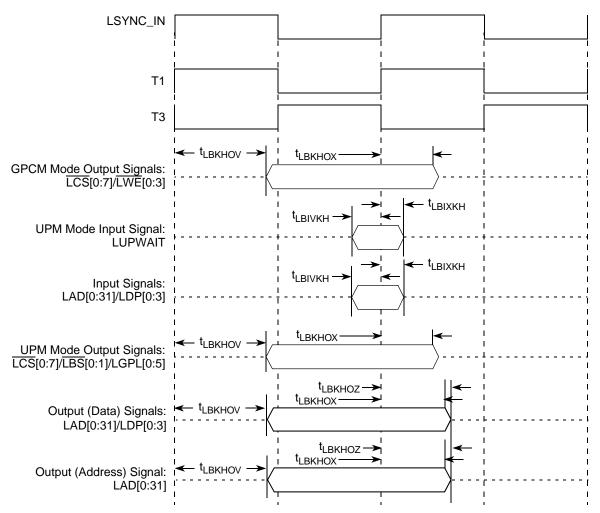


Figure 22. Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 2 (PLL Enable Mode)

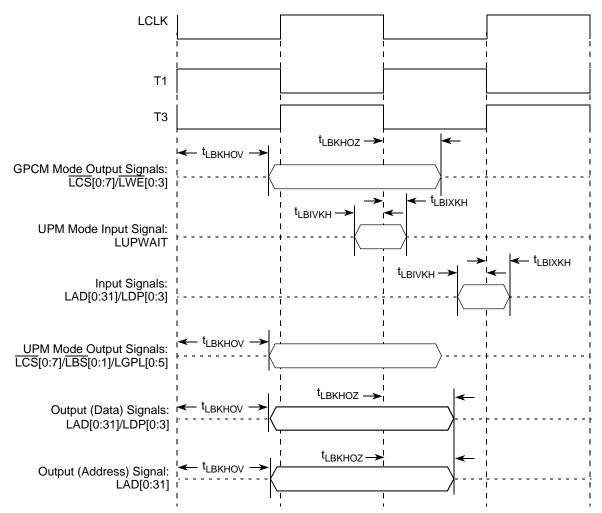


Figure 23. Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 2 (PLL Bypass Mode)

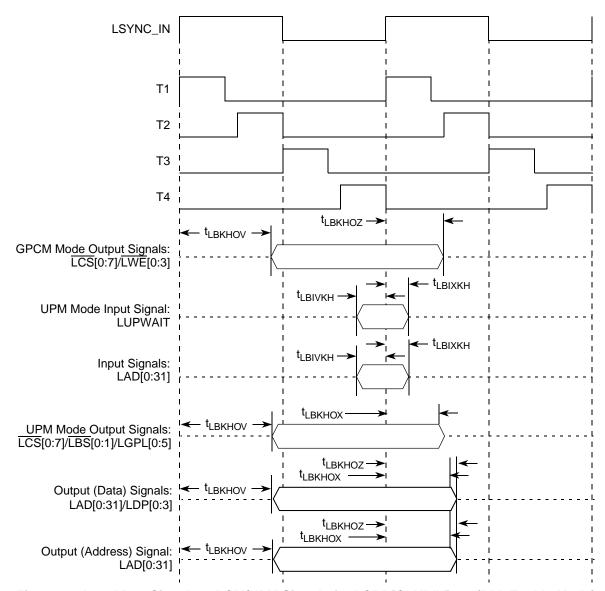


Figure 24. Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 4 (PLL Enable Mode)

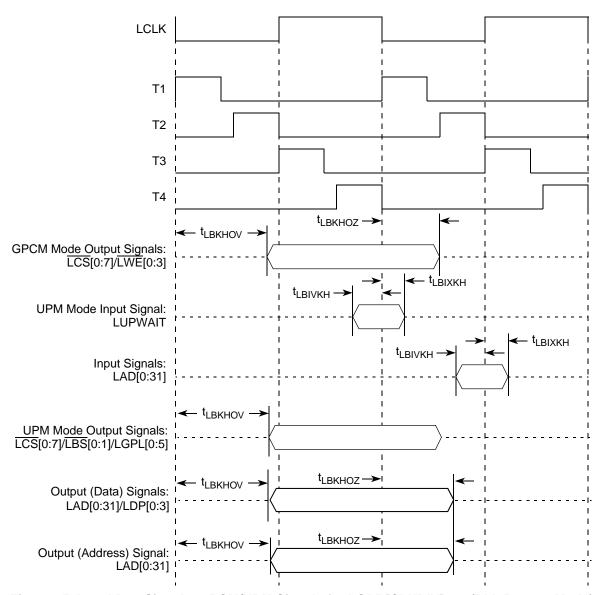


Figure 25. Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 4 (PLL Bypass Mode)

# 11 Enhanced Secure Digital Host Controller (eSDHC)

This section describes the DC and AC electrical specifications for the eSDHC (SD/MMC) interface of the MPC8379E.

The eSDHC controller always uses the falling edge of the SD\_CLK in order to drive the SD\_DAT[0:3]/CMD as outputs and sample the SD\_DAT[0:3] as inputs. This behavior is true for both full-and high-speed modes.

Note that this is a non-standard implementation, as the SD card specification assumes that in high-speed mode, data is driven at the rising edge of the clock.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **Enhanced Secure Digital Host Controller (eSDHC)**

Due to the special implementation of the eSDHC, there are constraints regarding the clock and data signals propagation delay on the user board. The constraints are for minimum and maximum delays, as well as skew between the CLK and DAT/CMD signals.

In full speed mode, there is no need to add special delay on the data or clock signals. The user should make sure to meet the timing requirements as described further within this document.

If the system is designed to support both high-speed and full-speed cards, the high-speed constraints should be fulfilled. If the systems is designed to operate up to 25 MHz only, full-speed mode is recommended.

### 11.1 eSDHC DC Electrical Characteristics

Table 41 provides the DC electrical characteristics for the eSDHC (SD/MMC) interface of the device.

Parameter	Symbol	Condition	Min	Max	Unit
Input high voltage	V <sub>IH</sub>	_	0.625 × OV <sub>DD</sub>	OV <sub>DD</sub> + 0.3	V
Input low voltage	V <sub>IL</sub>	_	-0.3	$0.25 \times \text{OV}_{\text{DD}}$	V
Input current	I <sub>IN</sub>	_	_	±30	μΑ
Output high voltage	V <sub>OH</sub>	$I_{OH} = -100 \text{ uA},$ at $OV_{DD}(\text{min})$	$0.75 \times \text{OV}_{\text{DD}}$	_	V
Output low voltage	V <sub>OL</sub>	$I_{OL} = +100 \text{ uA},$ at $OV_{DD}(min)$	_	0.125 × OV <sub>DD</sub>	V

Table 41. eSDHC interface DC Electrical Characteristics

# 11.2 eSDHC AC Timing Specifications (Full-Speed Mode)

This section describes the AC electrical specifications for the eSDHC (SD/MMC) interface of the device. Table 42 provides the eSDHC AC timing specifications for full-speed mode as defined in Figure 27 and Figure 28.

Table 42. eSDHC AC Timing Specifications for Full-Speed Mode

At recommended operating conditions  $OV_{DD} = 3.3 \text{ V} \pm 165 \text{ mV}$ .

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
SD_CLK clock frequency—full speed mode	f <sub>SFSCK</sub>	0	25	MHz	_
SD_CLK clock cycle	t <sub>SFSCK</sub>	40	_	ns	_
SD_CLK clock frequency—identification mode	f <sub>SIDCK</sub>	0	400	KHz	_
SD_CLK clock low time	t <sub>SFSCKL</sub>	15	_	ns	2
SD_CLK clock high time	t <sub>SFSCKH</sub>	15	_	ns	2
SD_CLK clock rise and fall times	t <sub>SFSCKR</sub> / t <sub>SFSCKF</sub>	_	5	ns	2
Input setup times: SD_CMD, SD_DATx, SD_CD to SD_CLK	<sup>t</sup> SFSIVKH	5	_	ns	2

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### Table 42. eSDHC AC Timing Specifications for Full-Speed Mode (continued)

At recommended operating conditions  $OV_{DD} = 3.3 \text{ V} \pm 165 \text{ mV}$ .

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Input hold times: SD_CMD, SD_DATx, SD_CD to SD_CLK	t <sub>SFSIXKH</sub>	0	_	ns	2
SD_CLK delay within device	t <sub>INT_CLK_DLY</sub>	1.5	_	ns	4
Output valid: SD_CLK to SD_CMD, SD_DATx valid	t <sub>SFSKHOV</sub>	_	4	ns	2
Output hold: SD_CLK to SD_CMD, SD_DATx valid	t <sub>SFSKHOX</sub>	0	_	_	_
SD card input setup	t <sub>ISU</sub>	5	_	ns	3
SD card input hold	t <sub>IH</sub>	5	_	ns	3
SD card output valid	t <sub>ODLY</sub>	_	14	ns	3
SD card output hold	t <sub>OH</sub>	0	_	ns	3

#### Notes:

- The symbols used for timing specifications herein follow the pattern of t<sub>(first three letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(first three letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>SFSIXKH</sub> symbolizes eSDHC full mode speed device timing (SFS) input (I) to go invalid (X) with respect to the clock reference (K) going to high (H). Also t<sub>SFSKHOV</sub> symbolizes eSDHC full speed timing (SFS) for the clock reference (K) to go high (H), with respect to the output (O) going valid (V) or data output valid time. Note that, in general, the clock reference symbol representation is based on five letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- <sup>2</sup> Measured at capacitive load of 40 pF.
- <sup>3</sup> For reference only, according to the SD card specifications.
- <sup>4</sup> Average, for reference only.

Figure 26 provides the eSDHC clock input timing diagram.

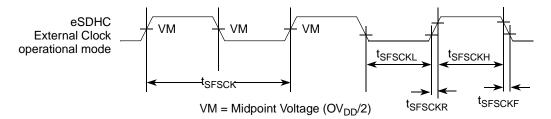


Figure 26. eSDHC Clock Input Timing Diagram

### 11.2.1 Full-Speed Output Path (Write)

Figure 27 provides the data and command output timing diagram.

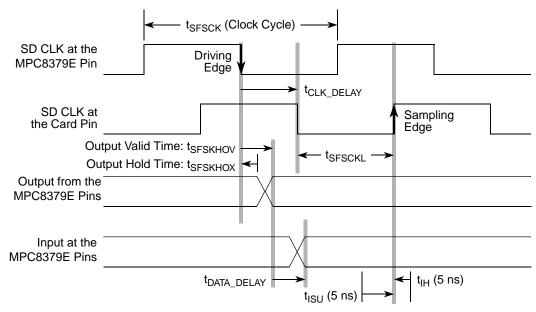


Figure 27. Full Speed Output Path

### 11.2.1.1 Full-Speed Write Meeting Setup (Maximum Delay)

The following equations show how to calculate the allowed skew range between the SD\_CLK and SD\_DAT/CMD signals on the PCB.

No clock delay:

$$t_{SFSKHOV} + t_{DATA\_DELAY} + t_{ISU} < t_{SFSCKL}$$
 Eqn. 1

With clock delay:

$$t_{SFSKHOV} + t_{DATA\_DELAY} + t_{ISU} < t_{SFSCKL} + t_{CLK\_DELAY}$$
 Eqn. 2

$$t_{DATA\_DELAY} + t_{SFSCKL} < t_{SFSCK} + t_{CLK\_DELAY} - t_{ISU} - t_{SFSKHOV}$$
 Eqn. 3

This means that data can be delayed versus clock up to 11 ns in ideal case of  $t_{SESCKL} = 20$  ns:

$$t_{DATA\_DELAY} + 20 < 40 + t_{CLK\_DELAY} - 5 - 4$$
  
 $t_{DATA\_DELAY} < 11 + t_{CLK\_DELAY}$ 

# 11.2.1.2 Full-Speed Write Meeting Hold (Minimum Delay)

The following equations show how to calculate the allowed skew range between the SD\_CLK and SD\_DAT/CMD signals on the PCB.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Eqn. 5

$$t_{CLK}$$
 DELAY +  $t_{IH}$  -  $t_{SFSKHOX}$  <  $t_{SFSCKL}$ +  $t_{DATA}$  DELAY

This means that clock can be delayed versus data up to 15 ns (external delay line) in ideal case of  $t_{SFSCLKL} = 20$  ns:

$$t_{CLK\_DELAY} + 5 - 0 < 20 + t_{DATA\_DELAY}$$
  
 $t_{CLK\_DELAY} < 15 + t_{DATA\_DELAY}$ 

### 11.2.1.3 Full-Speed Write Combined Formula

The following equation is the combined formula to calculate the allowed skew range between the SD\_CLK and SD\_DAT/CMD signals on the PCB.

# 11.2.2 Full-Speed Input Path (Read)

Figure 28 provides the data and command input timing diagram.

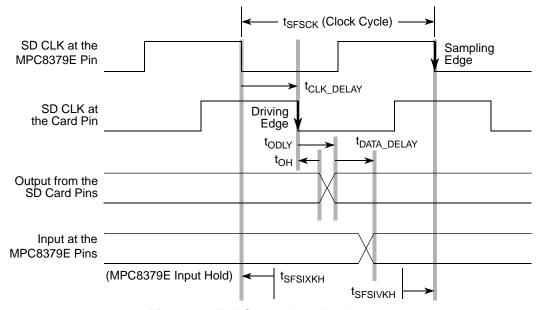


Figure 28. Full Speed Input Path

# 11.2.2.1 Full-Speed Read Meeting Setup (Maximum Delay)

The following equations show how to calculate the allowed combined propagation delay range of the SD\_CLK and SD\_DAT/CMD signals on the PCB.

$$t_{CLK\_DELAY} + t_{DATA\_DELAY} + t_{ODLY} + t_{SFSIVKH} < t_{SFSCK}$$
 Eqn. 7
$$t_{CLK\_DELAY} + t_{DATA\_DELAY} < t_{SFSCK} - t_{ODLY} - t_{SFSIVKH} - t_{INT\_CLK\_DLY}$$
 Eqn. 8

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### 11.2.2.2 Full-Speed Read Meeting Hold (Minimum Delay)

There is no minimum delay constraint due to the full clock cycle between the driving and sampling of data.

$$t_{CLK\_DELAY} + t_{OH} + t_{DATA\_DELAY} > t_{SFSIXKH}$$

Eqn. 9

This means that Data + Clock delay must be greater than -2 ns. This is always fulfilled.

# 11.3 eSDHC AC Timing Specifications (High-Speed Mode)

Table 43 provides the eSDHC AC timing specifications for high-speed mode as defined in Figure 30 and Figure 31.

Table 43. eSDHC AC Timing Specifications for High-Speed Mode

At recommended operating conditions  $OV_{DD} = 3.3 \text{ V} \pm 165 \text{ mV}$ .

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
SD_CLK clock frequency—high speed mode	f <sub>SHSCK</sub>	0	50	MHz	_
SD_CLK clock cycle	t <sub>SFSCK</sub>	20	_	ns	_
SD_CLK clock frequency—identification mode	f <sub>SIDCK</sub>	0	400	KHz	_
SD_CLK clock low time	t <sub>SHSCKL</sub>	7	_	ns	2
SD_CLK clock high time	t <sub>SHSCKH</sub>	7	_	ns	2
SD_CLK clock rise and fall times	t <sub>SHSCKR/</sub> t <sub>SHSCKF</sub>		3	ns	2
Input setup times: SD_CMD, SD_DATx, SD_CD to SD_CLK	t <sub>SHSIVKH</sub>	5	_	ns	2
Input hold times: SD_CMD, SD_DATx, SD_CD to SD_CLK	t <sub>SHSIXKH</sub>	0	_	ns	2
Output delay time: SD_CLK to SD_CMD, SD_DATx valid	t <sub>SHSKHOV</sub>	_	4	ns	2
Output Hold time: SD_CLK to SD_CMD, SD_DATx invalid	t <sub>SHSKHOX</sub>	0	_	ns	2
SD_CLK delay within device	t <sub>INT_CLK_DLY</sub>	1.5	_	ns	4
SD Card Input Setup	t <sub>ISU</sub>	6	_	ns	3
SD Card Input Hold	t <sub>IH</sub>	2	_	ns	3
SD Card Output Valid	t <sub>ODLY</sub>	_	14	ns	3

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### Table 43. eSDHC AC Timing Specifications for High-Speed Mode (continued)

At recommended operating conditions  $OV_{DD} = 3.3 \text{ V} \pm 165 \text{ mV}$ .

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
SD Card Output Hold	t <sub>OH</sub>	2.5		ns	3

#### Note:

- The symbols used for timing specifications herein follow the pattern of t<sub>(first three letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(first three letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>SFSIXKH</sub> symbolizes eSDHC full mode speed device timing (SFS) input (I) to go invalid (X) with respect to the clock reference (K) going to high (H). Also t<sub>SFSKHOV</sub> symbolizes eSDHC full speed timing (SFS) for the clock reference (K) to go high (H), with respect to the output (O) going valid (V) or data output valid time. Note that, in general, the clock reference symbol representation is based on five letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- <sup>2</sup> Measured at capacitive load of 40 pF.
- <sup>3</sup> For reference only, according to the SD card specifications.
- <sup>4</sup> Average, for reference only.

Figure 29 provides the eSDHC clock input timing diagram.

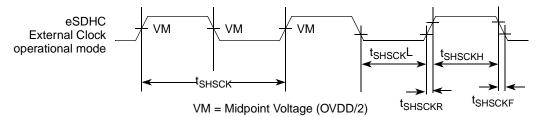


Figure 29. eSDHC Clock Input Timing Diagram

#### **High-Speed Output Path (Write)** 11.3.1

Figure 30 provides the data and command output timing diagram.

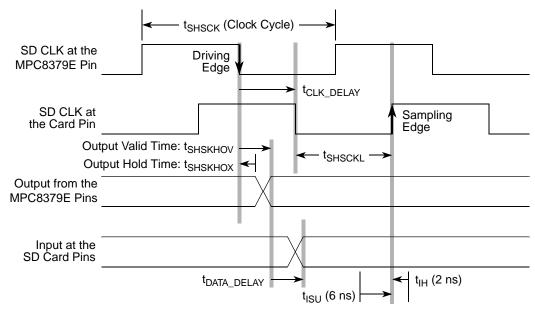


Figure 30. High Speed Output Path

#### 11.3.1.1 **High-Speed Write Meeting Setup (Maximum Delay)**

The following equations show how to calculate the allowed skew range between the SD\_CLK and SD\_DAT/CMD signals on the PCB.

Zero clock delay:

With clock delay:

$$t_{SHSKHOV} + t_{DATA\_DELAY} + t_{ISU} < t_{SHSCKL}$$
 Eqn. 10

$$t_{SHSKHOV} + t_{DATA\_DELAY} + t_{ISU} < t_{SHSCKL} + t_{CLK\_DELAY}$$
 Eqn. 11
$$t_{DATA\_DELAY} - t_{CLK\_DELAY} < t_{SHSCKL} - t_{ISU} - t_{SHSKHOV}$$
 Eqn. 12

This means that data delay should be equal or less than the clock delay in the ideal case where  $t_{SHSCLKL} = 10 \text{ ns}$ :

$$t_{DATA\_DELAY} - t_{CLK\_DELAY} < 10 - 6 - 4$$
  
 $t_{DATA\_DELAY} - t_{CLK\_DELAY} < 0$ 

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Freescale Semiconductor

50

### 11.3.1.2 High-Speed Write Meeting Hold (Minimum Delay)

The following equations show how to calculate the allowed skew range between the SD\_CLK and SD\_DAT/CMD signals on the PCB.

$$t_{CLK\_DELAY} < t_{SHSCKL} + t_{SHSKHOX} + t_{DATA\_DELAY} - t_{IH}$$
 Eqn. 13

$$t_{CLK\_DELAY} - t_{DATA\_DELAY} < t_{SHSCKL} + t_{SHSKHOX} - t_{IH}$$
 Eqn. 14

This means that clock can be delayed versus data up to 8 ns (external delay line) in ideal case of  $t_{SHSCLKL} = 10$  ns:

$$t_{CLK\_DELAY} - t_{DATA\_DELAY} < 10 + 0 - 2$$
$$t_{CLK\_DELAY} - t_{DATA\_DELAY} < 8$$

# 11.3.2 High-Speed Input Path (Read)

Figure 31 provides the data and command input timing diagram.

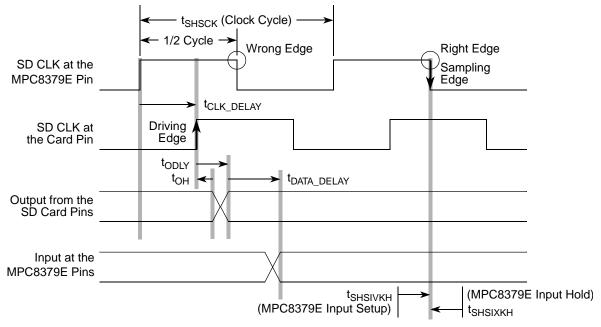


Figure 31. High-Speed Input Path

For the input path, the device eSDHC expects to sample the data 1.5 internal clock cycles after it was driven by the SD card. Since in this mode the SD card drives the data at the rising edge of the clock, a sufficient delay to the clock and the data must exist to ensure it will not be sampled at the wrong internal clock falling edge. Note that the internal clock which is guaranteed to be 50% duty cycle is used to sample the data, and therefore used in the equations.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### 11.3.2.1 High-Speed Read Meeting Setup (Maximum Delay)

The following equations show how to calculate the allowed combined propagation delay range of the SD\_CLK and SD\_DAT/CMD signals on the PCB.

$$t_{CLK}$$
 DELAY +  $t_{DATA}$  DELAY +  $t_{ODLY}$  +  $t_{SHSIVKH}$  < 1.5  $\times$   $t_{SHSCK}$  Eqn. 15

$$t_{CLK\_DELAY} + t_{DATA\_DELAY} < 1.5 \times t_{SHSCK} - t_{ODLY} - t_{SHSIVKH}$$
 Eqn. 16

This means that Data + Clock delay can be up to 11 ns for a 20 ns clock cycle:

$$\begin{aligned} t_{CLK\_DELAY} + t_{DATA\_DELAY} &< 30 - 14 - 5 \\ t_{CLK\_DELAY} + t_{DATA\_DELAY} &< 11 \end{aligned}$$

### 11.3.2.2 High-Speed Read Meeting Hold (Minimum Delay)

The following equations show how to calculate the allowed combined propagation delay range of the SD CLK and SD DAT/CMD signals on the PCB.

$$0.5 \times t_{SHSCK} < t_{CLK\_DELAY} + t_{DATA\_DELAY} + t_{OH} - t_{SHSIXKH} + t_{INT\_CLK\_DLY}$$
 Eqn. 17

$$0.5 \times t_{SHSCK} - t_{OH} + t_{SHSIXKH} - t_{INT}$$
 CLK DLY <  $t_{CLK}$  DELAY +  $t_{DATA}$  DELAY Eqn. 18

This means that Data + Clock delay must be greater than ~6 ns for a 20 ns clock cycle:

$$10-2.5+(-1.5) < t_{CLK\_DELAY} + t_{DATA\_DELAY}$$
 
$$6 < t_{CLK\_DELAY} + t_{DATA\_DELAY}$$

# 11.3.2.3 High-Speed Read Combined Formula

The following equation is the combined formula to calculate the propagation delay range of the SD\_CLK and SD\_DAT/CMD signals on the PCB.

$$0.5 \times t_{SHSCK} - t_{OH} + t_{SHSIXKH} < t_{CLK\_DELAY} + t_{DATA\_DELAY} < 1.5 \times t_{SHSCK} - t_{ODLY} - t_{SHSIVKH}$$
 Eqn. 19

# 12 JTAG

This section describes the DC and AC electrical specifications for the IEEE 1149.1 (JTAG) interface of the MPC8379E.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### 12.1 JTAG DC Electrical Characteristics

Table 44 provides the DC electrical characteristics for the IEEE 1149.1 (JTAG) interface of the MPC8379E.

Table 44. JTAG interface DC Electrical Characteristics

Parameter	Symbol	Condition	Min	Max	Unit
Input high voltage	V <sub>IH</sub>	_	2.5	OV <sub>DD</sub> + 0.3	V
Input low voltage	V <sub>IL</sub>	_	-0.3	0.8	V
Input current	I <sub>IN</sub>	_	_	±30	μА
Output high voltage	V <sub>OH</sub>	$I_{OH} = -8.0 \text{ mA}$	2.4	_	V
Output low voltage	V <sub>OL</sub>	$I_{OL} = 8.0 \text{ mA}$	_	0.5	V
Output low voltage	V <sub>OL</sub>	I <sub>OL</sub> = 3.2 mA	_	0.4	V

# 12.2 JTAG AC Timing Specifications

This section describes the AC electrical specifications for the IEEE 1149.1 (JTAG) interface of the device. Table 45 provides the JTAG AC timing specifications as defined in Figure 33 through Figure 36.

Table 45. JTAG AC Timing Specifications (Independent of CLKIN) 1

Parameter	Symbol <sup>2</sup>	Min	Max	Unit	Notes
JTAG external clock frequency of operation	$f_{JTG}$	0	33.3	MHz	_
JTAG external clock cycle time	t <sub>JTG</sub>	30	_	ns	_
JTAG external clock pulse width measured at 1.4 V	t <sub>JTKHKL</sub>	15	_	ns	_
JTAG external clock rise and fall times	t <sub>JTGR</sub> & t <sub>JTGF</sub>	0	2	ns	_
TRST assert time	t <sub>TRST</sub>	25	_	ns	3
Input setup times: Boundary-scan data TMS, TDI		4 4	_ _	ns	4
Input hold times:  Boundary-scan data TMS, TDI		10 10		ns	4
Valid times:  Boundary-scan data TDO	0	2 2	11 11	ns	_
Output hold times:  Boundary-scan data TDO	OTTLEDA	2 2	_ _	ns	_

Table 45. JTAG AC Timing Specifications (Independent of CLKIN) <sup>1</sup> (continued)

Parameter	Symbol <sup>2</sup>	Min	Max	Unit	Notes
JTAG external clock to output high impedance:  Boundary-scan data TDO	<sup>t</sup> JTKLDZ <sup>t</sup> JTKLOZ	2 2	19 9	ns	5

#### Notes:

- All outputs are measured from the midpoint voltage of the falling/rising edge of t<sub>TCLK</sub> to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50 Ω load (see Figure 17). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
- The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>JTDVKH</sub> symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the t<sub>JTG</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>JTDXKH</sub> symbolizes JTAG timing (JT) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>JTG</sub> clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- <sup>3</sup> TRST is an asynchronous level sensitive signal. The setup time is for test purposes only.
- 4 Non-JTAG signal input timing with respect to t<sub>TCLK</sub>.
- <sup>5</sup> Non-JTAG signal output timing with respect to t<sub>TCLK</sub>.

Figure 32 provides the AC test load for TDO and the boundary-scan outputs of the device.

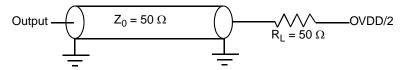


Figure 32. AC Test Load for the JTAG Interface

Figure 33 provides the JTAG clock input timing diagram.

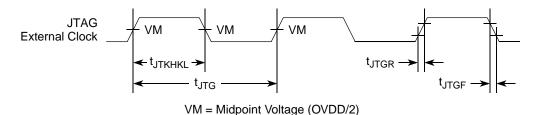


Figure 33. JTAG Clock Input Timing Diagram

Figure 34 provides the  $\overline{TRST}$  timing diagram.

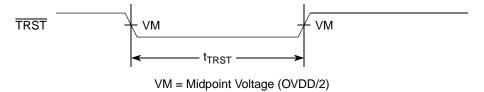
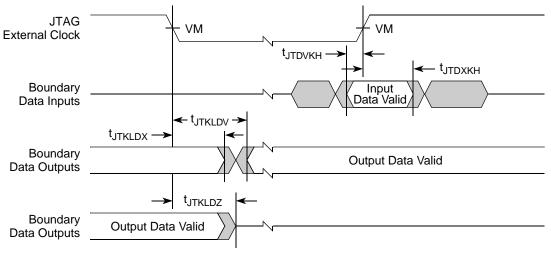


Figure 34. TRST Timing Diagram

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Figure 35 provides the boundary-scan timing diagram.



VM = Midpoint Voltage (OVDD/2)

Figure 35. Boundary-Scan Timing Diagram

Figure 36 provides the test access port timing diagram.

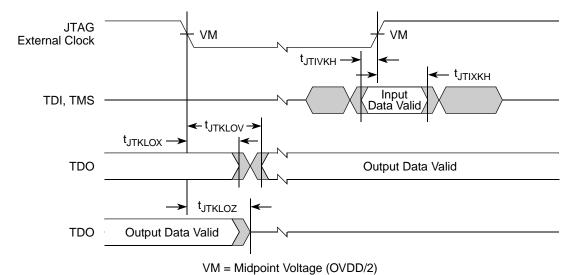


Figure 36. Test Access Port Timing Diagram

# 13 I<sup>2</sup>C

This section describes the DC and AC electrical characteristics for the I<sup>2</sup>C interface of the MPC8379E.

# 13.1 I<sup>2</sup>C DC Electrical Characteristics

Table 46 provides the DC electrical characteristics for the I<sup>2</sup>C interface of the MPC8379E.

### Table 46. I<sup>2</sup>C DC Electrical Characteristics

At recommended operating conditions with  $OV_{DD}$  of 3.3 V  $\pm$  165 mV.

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage level	V <sub>IH</sub>	$0.7 \times \text{OV}_{\text{DD}}$	OV <sub>DD</sub> + 0.3	V	_
Input low voltage level	V <sub>IL</sub>	-0.3	$0.3 \times \text{OV}_{\text{DD}}$	V	_
Low level output voltage	V <sub>OL</sub>	0	$0.2 \times \text{OV}_{\text{DD}}$	V	1
Output fall time from $V_{IH}(min)$ to $V_{IL}(max)$ with a bus capacitance from 10 to 400 pF	t <sub>I2KLKV</sub>	20 + 0.1 × C <sub>B</sub>	250	ns	2
Pulse width of spikes which must be suppressed by the input filter	t <sub>I2KHKL</sub>	0	50	ns	3
Capacitance for each I/O pin	C <sub>I</sub>	_	10	pF	_
Input current (0 $V \le V_{IN} \le OV_{DD}$ )	I <sub>IN</sub>	_	± 30	μА	4

#### Note

# 13.2 I<sup>2</sup>C AC Electrical Specifications

Table 47 provides the AC timing parameters for the I<sup>2</sup>C interface of the device.

### Table 47. I<sup>2</sup>C AC Electrical Specifications

All values refer to  $V_{IH}$  (min) and  $V_{IL}$  (max) levels (see Table 46).

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
SCL clock frequency	f <sub>I2C</sub>	0	400	kHz	_
Low period of the SCL clock	t <sub>I2CL</sub>	1.3	_	μS	_
High period of the SCL clock	t <sub>I2CH</sub>	0.6	_	μS	_
Setup time for a repeated START condition	t <sub>I2SVKH</sub>	0.6	_	μS	_
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t <sub>I2SXKL</sub>	0.6	_	μS	_
Data setup time	t <sub>I2DVKH</sub>	100	_	ns	_

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> Output voltage (open drain or open collector) condition = 3 mA sink current.

 $<sup>^{2}</sup>$  C<sub>B</sub> = capacitance of one bus line in pF.

Refer to the MPC8379E PowerQUICC II Pro Integrated Host Processor Reference Manual for information on the digital filter used.

<sup>&</sup>lt;sup>4</sup> I/O pins will obstruct the SDA and SCL lines if OV<sub>DD</sub> is switched off.

### Table 47. I<sup>2</sup>C AC Electrical Specifications (continued)

All values refer to V<sub>IH</sub> (min) and V<sub>II</sub> (max) levels (see Table 46).

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Data hold time  CBUS compatible masters  I <sup>2</sup> C bus devices	t <sub>I2DXKL</sub>	0	 0.9	μS	2, 3
Setup time for STOP condition	t <sub>I2PVKH</sub>	0.6	_	μS	_
Bus free time between a STOP and START condition	t <sub>I2KHDX</sub>	1.3	_	μS	_
Noise margin at the LOW level for each connected device (including hysteresis)	V <sub>NL</sub>	$0.1 \times \text{OV}_{\text{DD}}$	_	V	_
Noise margin at the HIGH level for each connected device (including hysteresis)	V <sub>NH</sub>	$0.2 \times \text{OV}_{\text{DD}}$	_	V	_

#### Note:

- The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>12DVKH</sub> symbolizes I<sup>2</sup>C timing (I2) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>12C</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>12SXKL</sub> symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the start condition (S) went invalid (X) relative to the t<sub>12C</sub> clock reference (K) going to the low (L) state or hold time. Also, t<sub>12PVKH</sub> symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the stop condition (P) reaching the valid state (V) relative to the t<sub>12C</sub> clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- <sup>2</sup> MPC8379E provides a hold time of at least 300 ns for the SDA signal (referred to the V<sub>IHmin</sub> of the SCL signal) to bridge the undefined region of the falling edge of SCL.
- <sup>3</sup> The maximum t<sub>I2DVKH</sub> has only to be met if the device does not stretch the LOW period (t<sub>I2CL</sub>) of the SCL signal.

Figure 37 provides the AC test load for the I<sup>2</sup>C.

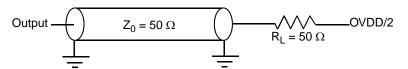


Figure 37. I<sup>2</sup>C AC Test Load

Figure 38 shows the AC timing diagram for the I<sup>2</sup>C bus.

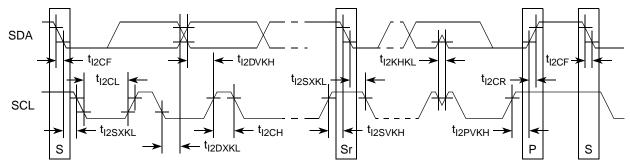


Figure 38. I<sup>2</sup>C Bus AC Timing Diagram

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### **14 PCI**

This section describes the DC and AC electrical specifications for the PCI bus of the MPC8379E.

### 14.1 PCI DC Electrical Characteristics

Table 48 provides the DC electrical characteristics for the PCI interface of the device. The DC characteristics of the PORESET signal, which can be used as PCI RST in applications where the device is a PCI agent, deviates from the standard PCI levels.

**Parameter** Condition **Symbol** Max Unit Min High-level input voltage  $V_{OUT} \ge V_{OH}$  (min) or  $V_{IH}$  $0.5 \times OV_{DD}$  $OV_{DD} + 0.5$ ٧ Low-level input voltage  $V_{OUT} \le V_{OL}$  (max)  $V_{IL}$ -0.5 $0.3 \times OV_{DD}$ ٧ High-level output voltage  $I_{OH} = -500 \mu A$  $V_{OH}$  $0.9 \times OV_{DD}$ ٧  $0.1 \times OV_{DD}$ Low-level output voltage  $I_{OI} = 1500 \, \mu A$ ٧  $V_{OI}$ Input current  $0 \text{ V} \leq V_{IN} \leq OV_{DD}$ ± 30 μΑ  $I_{IN}$ 

Table 48. PCI DC Electrical Characteristics

#### Note:

58

Downloaded from **Elcodis.com** electronic components distributor

# 14.2 PCI AC Electrical Specifications

This section describes the general AC timing parameters of the PCI bus of the device. Note that the PCI\_CLK/PCI\_SYNC\_IN or CLKIN signal is used as the PCI input clock depending on whether the MPC8379E is configured as a host or agent device. CLKIN is used when the device is in host mode.

Table 49 shows the PCI AC timing specifications at 66 MHz.

### Table 49. PCI AC Timing Specifications at 66 MHz

PCI\_SYNC\_IN clock input levels are with next levels: VIL = 0.1  $\times$  OV<sub>DD</sub>, VIH = 0.7  $\times$  OV<sub>DD</sub>.

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Clock to output valid	t <sub>PCKHOV</sub>	_	6.0	ns	2
Output hold from clock	t <sub>PCKHOX</sub>	1	_	ns	2
Clock to output high impedance	t <sub>PCKHOZ</sub>	_	14	ns	2, 3
Input setup to clock	t <sub>PCIVKH</sub>	3.0	_	ns	2, 4

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

ullet The symbol  $V_{IN}$ , in this case, represents the  $OV_{IN}$  symbol referenced in Table 2.

### Table 49. PCI AC Timing Specifications at 66 MHz (continued)

PCI\_SYNC\_IN clock input levels are with next levels: VIL =  $0.1 \times OV_{DD}$ , VIH =  $0.7 \times OV_{DD}$ .

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Input hold from cock	t <sub>PCIXKH</sub>	0.25	_	ns	2, 4, 6
Output clock skew	t <sub>PCKOSK</sub>	_	0.5	ns	5

#### Notes:

- Note that the symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state) (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>PCIVKH</sub> symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI\_SYNC\_IN clock, t<sub>SYS</sub>, reference (K) going to the high (H) state or setup time. Also, t<sub>PCRHFV</sub> symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
- <sup>2</sup> See the timing measurement conditions in the *PCI* 2.3 Local Bus Specifications.
- <sup>3</sup> For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- <sup>4</sup> Input timings are measured at the pin.
- <sup>5</sup> PCI specifications allows 1 ns skew for 66 MHz but includes the total allowed skew, board, connectors, etc.
- <sup>6</sup> Value does not comply with the *PCI 2.3 Local Bus Specifications*.

### Table 50 shows the PCI AC timing specifications at 33 MHz.

### Table 50. PCI AC Timing Specifications at 33 MHz

PCI\_SYNC\_IN clock input levels are with next levels: VIL =  $0.1 \times \text{OV}_{\text{DD}}$ ,  $\text{V}_{\text{IH}} = 0.7 \times \text{OV}_{\text{DD}}$ .

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Clock to output valid	t <sub>PCKHOV</sub>	_	11	ns	2
Output hold from clock	t <sub>PCKHOX</sub>	2	_	ns	2
Clock to output high impedance	t <sub>PCKHOZ</sub>	_	14	ns	2, 3
Input setup to clock	t <sub>PCIVKH</sub>	3.0	_	ns	2, 4
Input hold from clock	t <sub>PCIXKH</sub>	0.25	_	ns	2, 4, 6
Output clock skew	t <sub>PCKOSK</sub>	_	0.5	ns	5

### Note:

- Note that the symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>PCIVKH</sub> symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI\_SYNC\_IN clock, t<sub>SYS</sub>, reference (K) going to the high (H) state or setup time. Also, t<sub>PCRHFV</sub> symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
- <sup>2</sup> See the timing measurement conditions in the PCI 2.3 Local Bus Specifications.
- <sup>3</sup> For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- <sup>4</sup> Input timings are measured at the pin.
- <sup>5</sup> PCI specifications allows 2 ns skew for 33 MHz but includes the total allowed skew, board, connectors, etc.
- <sup>6</sup> Value does not comply with the PCI 2.3 Local Bus Specifications.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Figure 39 provides the AC test load for PCI.

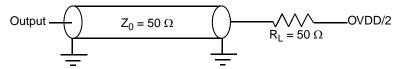


Figure 39. PCI AC Test Load

Figure 40 shows the PCI input AC timing conditions.

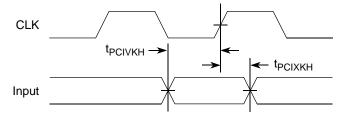


Figure 40. PCI Input AC Timing Measurement Conditions

Figure 41 shows the PCI output AC timing conditions.

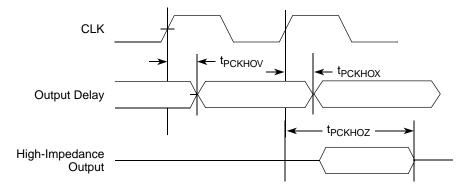


Figure 41. PCI Output AC Timing Measurement Condition

# 15 Serial ATA (SATA)

This section describes the DC and AC electrical specifications for the serial ATA (SATA) of the MPC8379E. Note that the external cabled applications or long backplane applications (Gen1x and Gen2x) are not supported.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 15.1 Requirements for SATA REF\_CLK

The reference clock is a single ended input clock required for the SATA interface operation. The AC requirements for the SATA reference clock are listed in the Table 51.

Parameter	Condition	Symbol	Min	Typical	Max	Unit	Notes
SD_REF_CLK/ SD_REF_CLK frequency range	_	t <sub>CLK_REF</sub>	_	100/125/150	_	MHz	1
SD_REF_CLK/ SD_REF_CLK clock frequency tolerance	_	<sup>t</sup> CLK_TOL	-350	0	+350	ppm	_
SD_REF_CLK/ SD_REF_CLK reference clock duty cycle	Measured at 1.6V	t <sub>CLK_DUTY</sub>	40	50	60	%	_
SD_REF_CLK/ SD_REF_CLK cycle to cycle Clock jitter (period jitter)	Cycle-to-cycle at ref clock input	t <sub>CLK_CJ</sub>	_	_	100	ps	_
SD_REF_CLK/ SD_REF_CLK total reference clock jitter, phase jitter (peak-peak)	Peak-to-peak jitter at ref clock input	<sup>t</sup> CLK_PJ	<b>–</b> 50	_	+50	ps	2, 3

**Table 51. SATA Reference Clock Input Requirements** 

#### Note:

Figure 42 shows the SATA reference clock timing waveform.

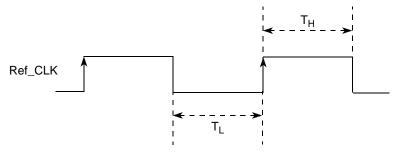


Figure 42. SATA Reference Clock Timing Waveform

# 15.2 Transmitter (Tx) Output Characteristics

This section discusses the Gen1i/1.5G and Gen2i/3G transmitter output characteristics for the SATA interface.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> Only 100/125/150 MHz have been tested, other in between values will not work correctly with the rest of the system.

<sup>&</sup>lt;sup>2</sup> In a frequency band from 150 kHz to 15 MHz at BER of 10<sup>-12</sup>.

<sup>&</sup>lt;sup>3</sup> Total peak to peak Deterministic Jitter "D<sub>J</sub>" should be less than or equal to 50 ps.

## 15.2.1 Gen1i/1.5G Transmitter Specifications

Table 52 provides the DC differential transmitter output DC characteristics for the SATA interface at Gen1i or 1.5 Gbits/s transmission.

Table 52. Gen1i/1.5G Transmitter (Tx) DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Tx differential output voltage	V <sub>SATA_TXDIFF</sub>	400	500	600	mV <sub>p-p</sub>	1
Tx differential pair impedance	Z <sub>SATA_TXDIFFIM</sub>	85	100	115	Ω	_

#### Note:

Table 53 provides the differential transmitter output AC characteristics for the SATA interface at Gen1i or 1.5 Gbits/s transmission.

Table 53. Gen1i/1.5G Transmitter AC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Channel speed	t <sub>CH_SPEED</sub>	_	1.5	_	Gbps	_
Unit interval	T <sub>UI</sub>	666.4333	666.667	670.2333	ps	_
Total jitter, data-data 5 Ul	U <sub>SATA_TXTJ5UI</sub>	_	_	0.355	UI <sub>p-p</sub>	1
Total jitter, data-data 250 UI	U <sub>SATA_TXTJ250UI</sub>	_	_	0.47	UI <sub>p-p</sub>	1
Deterministic jitter, data-data 5 UI	U <sub>SATA_TXDJ5UI</sub>	_	_	0.175	UI <sub>p-p</sub>	1
Deterministic jitter, data-data 250 UI	U <sub>SATA_TXDJ250UI</sub>	_	_	0.22	UI <sub>p-p</sub>	1

#### Note:

# 15.2.2 Gen2i/3G Transmitter Specifications

Table 54 provides the differential transmitter output DC characteristics for the SATA interface at Gen2i or 3.0 Gbits/s transmission.

Table 54. Gen 2i/3G Transmitter DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Tx differential output voltage	V <sub>SATA_TXDIFF</sub>	400	550	700	mV <sub>p-p</sub>	1
Tx differential pair impedance	Z <sub>SATA_TXDIFFIM</sub>	85	100	115	Ω	_

#### Note:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> Terminated by 50  $\Omega$  load.

Measured at Tx output pins peak to peak phase variation, random data pattern.

<sup>&</sup>lt;sup>1</sup> Terminated by 50  $\Omega$  load.

Table 55 provides the differential transmitter output AC characteristics for the SATA interface at Gen2i or 3.0 Gbits/s transmission.

Table 55. Gen 2i/3G Transmitter AC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Channel speed	t <sub>CH_SPEED</sub>	_	3.0	_	Gbps	_
Unit interval	T <sub>UI</sub>	333.2	333.33	335.11	ps	_
Total jitter f <sub>C3dB</sub> =f <sub>BAUD</sub> /10	U <sub>SATA_TXTJfB/10</sub>	_	_	0.3	UI <sub>p-p</sub>	1
Total jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /500	U <sub>SATA_TXTJfB/500</sub>	_	_	0.37	UI <sub>p-p</sub>	1
Total jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /1667	U <sub>SATA_TXTJfB/1667</sub>	_	_	0.55	UI <sub>p-p</sub>	1
Deterministic jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /10	U <sub>SATA_TXDJfB/10</sub>	_	_	0.17	UI <sub>p-p</sub>	1
Deterministic jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /500	U <sub>SATA_TXDJfB/500</sub>	_	_	0.19	UI <sub>p-p</sub>	1
Deterministic jitter $f_{C3dB} = f_{BAUD}/1667$	U <sub>SATA_TXDJfB/1667</sub>	_	_	0.35	UI <sub>p-p</sub>	1

#### Note:

# 15.3 Differential Receiver (Rx) Input Characteristics

This section discusses the Gen1i/1.5G and Gen2i/3G differential receiver input AC characteristics.

# 15.3.1 Gen1i/1.5G Receiver Specifications

Table 56 provides the Gen1i or 1.5 Gbits/s differential receiver input DC characteristics for the SATA interface.

Table 56. Gen1i/1.5G Receiver Input DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential input voltage	V <sub>SATA_RXDIFF</sub>	240	500	600	mV <sub>p-p</sub>	1
Differential Rx input impedance	Z <sub>SATA_RXSEIM</sub>	85	100	115	Ω	_

#### Note:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> Measured at Tx output pins peak to peak phase variation, random data pattern.

<sup>&</sup>lt;sup>1</sup> Voltage relative to common of either signal comprising a differential pair.

#### Serial ATA (SATA)

Table 57 provides the Gen1i or 1.5 Gbits/s differential receiver input AC characteristics for the SATA interface.

Table 57. Gen 1i/1.5G Receiver AC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Unit interval	T <sub>UI</sub>	666.4333	666.667	670.2333	ps	_
Total jitter, data-data 5 UI	U <sub>SATA_TXTJ5UI</sub>	_	_	0.43	UI <sub>p-p</sub>	1
Total jitter, data-data 250 UI	U <sub>SATA_TXTJ250UI</sub>	_	_	0.60	UI <sub>p-p</sub>	1
Deterministic jitter, data-data 5 UI	U <sub>SATA_TXDJ5UI</sub>		_	0.25	UI <sub>p-p</sub>	1
Deterministic jitter, data-data 250 UI	U <sub>SATA_TXDJ250UI</sub>	1	_	0.35	UI <sub>p-p</sub>	1

#### Note:

# 15.3.2 Gen2i/3G Receiver (Rx) Specifications

Table 58 provides the Gen2i or 3 Gbits/s differential receiver input DC characteristics for the SATA interface.

Table 58. Gen2i/3G Receiver Input DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential input voltage	V <sub>SATA_RXDIFF</sub>	275	500	750	mVp-p	1
Differential RX input impedance	Z <sub>SATA_RXSEIM</sub>	85	100	115	Ω	_

#### Note:

Table 59 provides the differential receiver output AC characteristics for the SATA interface at Gen2i or 3.0 Gbits/s transmission.

Table 59. Gen 2i/3G Receiver AC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Channel Speed	t <sub>CH_SPEED</sub>	_	3.0	_	Gbps	_
Unit Interval	T <sub>UI</sub>	333.2	333.33	335.11	ps	_
Total jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /10	U <sub>SATA_TXTJfB/10</sub>	_	_	0.46	UI <sub>p-p</sub>	1
Total jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /500	U <sub>SATA_TXTJfB/500</sub>	_	_	0.60	UI <sub>p-p</sub>	1
Total jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /1667	U <sub>SATA_TXTJfB/1667</sub>	_	_	0.65	UI <sub>p-p</sub>	1

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> Measured at Tx output pins peak to peak phase variation, random data pattern.

<sup>&</sup>lt;sup>1</sup> Voltage relative to common of either signal comprising a differential pair.

Table 59. Gen 2i/3G Receiver AC Specifications (continued)

Parameter	Symbol	Min	Typical	Max	Units	Notes
Deterministic jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /10	U <sub>SATA_TXDJfB/10</sub>	_	_	0.35	UI <sub>p-p</sub>	1
Deterministic jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /500	U <sub>SATA_TXDJfB/500</sub>	_	_	0.42	UI <sub>p-p</sub>	1
Deterministic jitter f <sub>C3dB</sub> = f <sub>BAUD</sub> /1667	U <sub>SATA_TXDJfB/1667</sub>	_	_	0.35	UI <sub>p-p</sub>	1

#### Note:

## 16 Timers

This section describes the DC and AC electrical specifications for the timers of the MPC8379E.

### 16.1 Timers DC Electrical Characteristics

Table 60 provides the DC electrical characteristics for the device timers pins, including TIN, TOUT, TGATE, and RTC\_CLK.

Table 60. Timers DC Electrical Characteristics

Parameter	Condition	Symbol	Min	Max	Unit
Output high voltage	$I_{OH} = -6.0 \text{ mA}$	V <sub>OH</sub>	2.4	_	V
Output low voltage	I <sub>OL</sub> = 6.0 mA	V <sub>OL</sub>	_	0.5	V
Output low voltage	I <sub>OL</sub> = 3.2 mA	V <sub>OL</sub>	_	0.4	V
Input high voltage	_	V <sub>IH</sub>	2.0	OV <sub>DD</sub> + 0.3	V
Input low voltage	_	V <sub>IL</sub>	-0.3	0.8	V
Input current	$0 \text{ V} \leq \text{V}_{IN} \leq \text{OV}_{DD}$	I <sub>IN</sub>	_	± 30	μΑ

# 16.2 Timers AC Timing Specifications

Table 61 provides the timers input and output AC timing specifications.

Table 61. Timers Input AC Timing Specifications 1

Parameter	Symbol <sup>2</sup>	Min	Unit
Timers inputs—minimum pulse width	t <sub>TIWID</sub>	20	ns

#### Note:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> Measured at Tx output pins peak to peak phase variation, random data pattern.

Input specifications are measured from the 50% level of the signal to the 50% level of the rising edge of CLKIN. Timings are measured at the pin.

<sup>&</sup>lt;sup>2</sup> Timers inputs and outputs are asynchronous to any visible clock. Timers outputs should be synchronized before use by any external synchronous logic. Timers inputs are required to be valid for at least t<sub>TIWID</sub> ns to ensure proper operation

Figure 43 provides the AC test load for the timers.

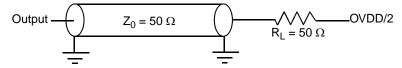


Figure 43. Timers AC Test Load

### **17 GPIO**

This section describes the DC and AC electrical specifications for the GPIO of the MPC8379E.

### 17.1 GPIO DC Electrical Characteristics

Table 62 provides the DC electrical characteristics for the device GPIO.

#### **Table 62. GPIO DC Electrical Characteristics**

This specification applies when operating at 3.3 V ± 165 mV supply.

Parameter	Condition	Symbol	Min	Max	Unit
Output high voltage	$I_{OH} = -6.0 \text{ mA}$	V <sub>OH</sub>	2.4	_	V
Output low voltage	I <sub>OL</sub> = 6.0 mA	V <sub>OL</sub>	_	0.5	V
Output low voltage	I <sub>OL</sub> = 3.2 mA	V <sub>OL</sub>	_	0.4	V
Input high voltage	_	V <sub>IH</sub>	2.0	OV <sub>DD</sub> + 0.3	V
Input low voltage	_	V <sub>IL</sub>	-0.3	0.8	V
Input current	$0 \text{ V} \leq V_{IN} \leq OV_{DD}$	I <sub>IN</sub>	_	± 30	μΑ

# 17.2 GPIO AC Timing Specifications

Table 63 provides the GPIO input and output AC timing specifications.

**Table 63. GPIO Input AC Timing Specifications** 

Parameter	Symbol	Min	Unit
GPIO inputs—minimum pulse width	t <sub>PIWID</sub>	20	ns

#### Note:

- 1. Input specifications are measured from the 50% level of the signal to the 50% level of the rising edge of SYS\_CLKIN. Timings are measured at the pin.
- 2. GPIO inputs and outputs are asynchronous to any visible clock. GPIO outputs should be synchronized before use by any external synchronous logic. GPIO inputs are required to be valid for at least t<sub>PIWID</sub> ns to ensure proper operation.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Figure 44 provides the AC test load for the GPIO.

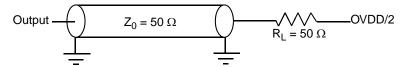


Figure 44. GPIO AC Test Load

### **18 IPIC**

This section describes the DC and AC electrical specifications for the external interrupt pins of the MPC8379E.

### 18.1 IPIC DC Electrical Characteristics

Table 64 provides the DC electrical characteristics for the external interrupt pins of the MPC8379E.

Condition **Symbol Parameter** Min Max Unit Input high voltage  $V_{IH}$ 2.0  $OV_{DD} + 0.3$ Input low voltage -0.38.0 ٧  $V_{IL}$ Input current ±30 μΑ  $I_{IN}$ 0.5 ٧ Output low voltage  $I_{OI} = 6.0 \text{ mA}$  $V_{OI}$ Output low voltage  $I_{OL} = 3.2 \text{ mA}$ 0.4 V  $V_{OL}$ 

**Table 64. IPIC DC Electrical Characteristics** 

#### Note:

- 1. This table applies for pins IRQ[0:7], IRQ\_OUT, MCP\_OUT.
- 2. IRQ\_OUT and MCP\_OUT are open drain pins, thus V<sub>OH</sub> is not relevant for those pins.

# 18.2 IPIC AC Timing Specifications

Table 65 provides the IPIC input and output AC timing specifications.

**Table 65. IPIC Input AC Timing Specifications** 

Parameter	Symbol	Min	Unit
IPIC inputs—minimum pulse width	t <sub>PIWID</sub>	20	ns

#### Note:

- 1. Input specifications are measured from the 50% level of the signal to the 50% level of the rising edge of CLKIN. Timings are measured at the pin.
- 2. IPIC inputs and outputs are asynchronous to any visible clock. IPIC outputs should be synchronized before use by any external synchronous logic. IPIC inputs are required to be valid for at least t<sub>PIWID</sub> ns to ensure proper operation when working in edge triggered mode.

# 19 SPI

This section describes the DC and AC electrical specifications for the SPI of the MPC8379E.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### 19.1 SPI DC Electrical Characteristics

Table 66 provides the DC electrical characteristics for the device SPI.

Table 66. SPI DC Electrical Characteristics

Parameter	Condition	Symbol	Min	Max	Unit
Input high voltage	_	V <sub>IH</sub>	2.0	OV <sub>DD</sub> + 0.3	V
Input low voltage	_	V <sub>IL</sub>	-0.3	0.8	V
Input current	_	I <sub>IN</sub>	_	± 30	μА
Output high voltage	$I_{OH} = -8.0 \text{ mA}$	V <sub>OH</sub>	2.4	_	V
Output low voltage	I <sub>OL</sub> = 8.0 mA	V <sub>OL</sub>	_	0.5	V
Output low voltage	I <sub>OL</sub> = 3.2 mA	V <sub>OL</sub>	_	0.4	V

# 19.2 SPI AC Timing Specifications

Table 67 provides the SPI input and output AC timing specifications.

**Table 67. SPI AC Timing Specifications** 

Parameter	Symbol <sup>1</sup>	Min	Max	Unit
SPI outputs—Master mode (internal clock) delay	t <sub>NIKHOV</sub>	0.5	6	ns
SPI outputs—Slave mode (external clock) delay	t <sub>NEKHOV</sub>	2	8	ns
SPI inputs—Master mode (internal clock) input setup time	t <sub>NIIVKH</sub>	4	_	ns
SPI inputs—Master mode (internal clock) input hold time	t <sub>NIIXKH</sub>	0	_	ns
SPI inputs—Slave mode (external clock) input setup time	t <sub>NEIVKH</sub>	4	_	ns
SPI inputs—Slave mode (external clock) input hold time	t <sub>NEIXKH</sub>	2	_	ns

#### Note:

- The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)</sub> (reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>NIKHOV</sub> symbolizes the internal timing (NI) for the time SPICLK clock reference (K) goes to the high state (H) until outputs (O) are invalid (X).
- 2. Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin. The maximum SPICLK input frequency is 66.666 MHz.

Figure 45 provides the AC test load for the SPI.

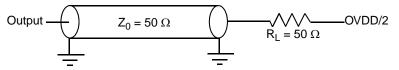
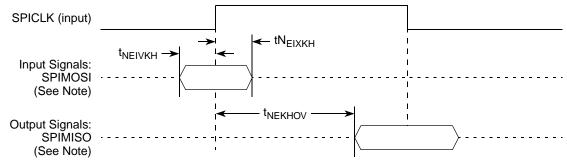


Figure 45. SPI AC Test Load

Figure 46 through Figure 47 represent the AC timing from Table 67. Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

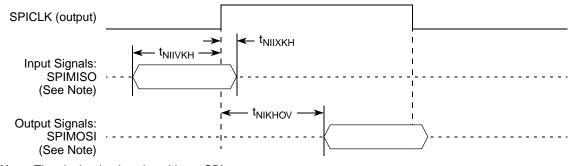
Figure 46 shows the SPI timing in slave mode (external clock).



Note: The clock edge is selectable on SPI.

Figure 46. SPI AC Timing in Slave Mode (External Clock) Diagram

Figure 47 shows the SPI timing in master mode (internal clock).



Note: The clock edge is selectable on SPI.

Figure 47. SPI AC Timing in Master Mode (Internal Clock) Diagram

# 20 High-Speed Serial Interfaces (HSSI)

The MPC8379E features two serializer/deserializer (SerDes) interfaces to be used for high-speed serial interconnect applications. See Table 1 for the interfaces supported.

This section describes the common portion of SerDes DC electrical specifications, which is the DC requirement for SerDes reference clocks. The SerDes data lane's transmitter and receiver reference circuits are also shown.

# 20.1 Signal Terms Definition

The SerDes utilizes differential signaling to transfer data across the serial link. This section defines terms used in the description and specification of differential signals.

Figure 48 shows how the signals are defined. For illustration purpose, only one SerDes lane is used for description. The figure shows waveform for either a transmitter output ( $SDn_TX$  and  $\overline{SDn_TX}$ ) or a receiver input ( $SDn_RX$  and  $\overline{SDn_RX}$ ). Each signal swings between A volts and B volts where A > B.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **High-Speed Serial Interfaces (HSSI)**

Using this waveform, the definitions are as follows. To simplify illustration, the following definitions assume that the SerDes transmitter and receiver operate in a fully symmetrical differential signaling environment.

### **Single-Ended Swing**

The transmitter output signals and the receiver input signals  $SDn_TX$ ,  $\overline{SDn_TX}$ ,  $SDn_RX$  and SDn\_RX each have a peak-to-peak swing of A – B volts. This is also referred as each signal wire's single-ended swing.

### **Differential Output Voltage, VOD** (or **Differential Output Swing**):

The differential output voltage (or swing) of the transmitter, V<sub>OD</sub>, is defined as the difference of the two complimentary output voltages:  $V_{SDn TX} - V_{\overline{SDn TX}}$ . The  $V_{OD}$  value can be either positive or negative.

### **Differential Input Voltage, V**<sub>ID</sub> (or **Differential Input Swing**):

The differential input voltage (or swing) of the receiver, V<sub>ID</sub>, is defined as the difference of the two complimentary input voltages:  $V_{SDn} RX - V_{\overline{SDn} RX}$ . The  $V_{ID}$  value can be either positive or negative.

## Differential Peak Voltage, V<sub>DIFFp</sub>

The peak value of the differential transmitter output signal or the differential receiver input signal is defined as differential peak voltage,  $V_{DIFFp} = |A - B|$  volts.

# Differential Peak-to-Peak, V<sub>DIFFp-p</sub>

Since the differential output signal of the transmitter and the differential input signal of the receiver each range from A - B to -(A - B) volts, the peak-to-peak value of the differential transmitter output signal or the differential receiver input signal is defined as differential peak-to-peak voltage,  $V_{DIFFp-p} = 2 \times V_{DIFFp} = 2 \times |(A - B)|$  volts, which is twice of differential swing in amplitude, or twice of the differential peak. For example, the output differential peak-peak voltage can also be calculated as  $V_{TX-DIFFp-p} = 2 \times |V_{OD}|$ .

### **Differential Waveform**

The differential waveform is constructed by subtracting the inverting signal ( $\overline{SDn_TTX}$ , for example) from the non-inverting signal (SDn TX, for example) within a differential pair. There is only one signal trace curve in a differential waveform. The voltage represented in the differential waveform is not referenced to ground. Refer to Figure 57 as an example for differential waveform.

### **Common Mode Voltage, V<sub>cm</sub>**

The common mode voltage is equal to one half of the sum of the voltages between each conductor of a balanced interchange circuit and ground. In this example, for SerDes output,  $V_{cm out} = (V_{SDn TX} + V_{\overline{SDn TX}}) \div 2 = (A + B) \div 2$ , which is the arithmetic mean of the two

complimentary output voltages within a differential pair. In a system, the common mode voltage may often differ from one component's output to the other's input. Sometimes it may be even different between the receiver input and driver output circuits within the same component. It is also referred as the DC offset in some occasion.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

70

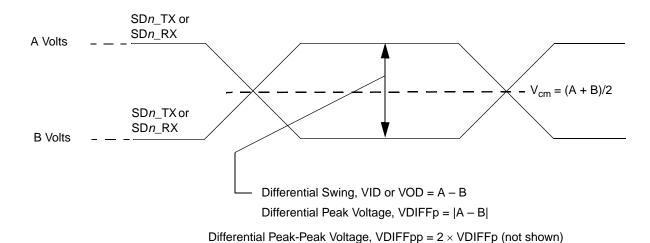


Figure 48. Differential Voltage Definitions for Transmitter or Receiver

To illustrate these definitions using real values, consider the case of a CML (Current Mode Logic) transmitter that has a common mode voltage of 2.25 V and each of its outputs, TD and  $\overline{\text{TD}}$ , has a swing that goes between 2.5 V and 2.0 V. Using these values, the peak-to-peak voltage swing of each signal (TD or  $\overline{\text{TD}}$ ) is 500 mV<sub>p-p</sub>, which is referred as the single-ended swing for each signal. In this example, since the differential signaling environment is fully symmetrical, the transmitter output's differential swing (V<sub>OD</sub>) has the same amplitude as each signal's single-ended swing. The differential output signal ranges between 500 mV and –500 mV, in other words, V<sub>OD</sub> is 500 mV in one phase and –500 mV in the other phase. The peak differential voltage (V<sub>DIFFp</sub>) is 500 mV. The peak-to-peak differential voltage (V<sub>DIFFp-p</sub>) is 1000 mV<sub>p-p</sub>.

### 20.2 SerDes Reference Clocks

The SerDes reference clock inputs are applied to an internal PLL whose output creates the clock used by the corresponding SerDes lanes. The SerDes reference clocks inputs are SD1\_REF\_CLK and SD1\_REF\_CLK for both lanes of SerDes1, and SD2\_REF\_CLK and SD2\_REF\_CLK for both lanes of SerDes2.

The following sections describe the SerDes reference clock requirements and some application information.

### 20.2.1 SerDes Reference Clock Receiver Characteristics

Figure 49 shows a receiver reference diagram of the SerDes reference clocks.

- SerDes Reference Clock Receiver Reference Circuit Structure
  - The SD*n*\_REF\_CLK and SD*n*\_REF\_CLK are internally AC-coupled differential inputs as shown in Figure 49. Each differential clock input (SD*n*\_REF\_CLK or SD*n*\_REF\_CLK) has a 50 Ω termination to SGND\_SRDS*n* (xcorevss) followed by on-chip AC-coupling.
  - The external reference clock driver must be able to drive this termination.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **High-Speed Serial Interfaces (HSSI)**

- The SerDes reference clock input can be either differential or single-ended. Refer to the Differential Mode and Single-ended Mode description below for further detailed requirements.
- The maximum average current requirement that also determines the common mode voltage range
  - When the SerDes reference clock differential inputs are DC coupled externally with the clock driver chip, the maximum average current allowed for each input pin is 8 mA. In this case, the exact common mode input voltage is not critical as long as it is within the range allowed by the maximum average current of 8 mA (refer to the following bullet for more detail), since the input is AC-coupled on-chip.
  - This current limitation sets the maximum common mode input voltage to be less than 0.4 V (0.4 V ÷ 50 = 8 mA) while the minimum common mode input level is 0.1 V above SGND\_SRDSn (xcorevss). For example, a clock with a 50/50 duty cycle can be produced by a clock driver with output driven by its current source from 0 mA to 16 mA (0–0.8 V), such that each phase of the differential input has a single-ended swing from 0 V to 800 mV with the common mode voltage at 400 mV.
  - If the device driving the SDn\_REF\_CLK and  $\overline{\text{SD}n}$ \_REF\_CLK inputs cannot drive 50  $\Omega$  to SGND\_SRDSn (xcorevss) DC, or it exceeds the maximum input current limitations, then it must be AC-coupled off-chip.
- The input amplitude requirement
  - This requirement is described in detail in the following sections.

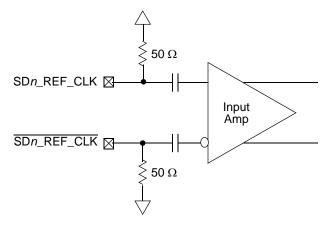


Figure 49. Receiver of SerDes Reference Clocks

# 20.2.2 DC Level Requirement for SerDes Reference Clocks

The DC level requirement for the device SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs as described below.

#### Differential Mode

— The input amplitude of the differential clock must be between 400 mV and 1600 mV differential peak-peak (or between 200 mV and 800 mV differential peak). In other words, each signal wire of the differential pair must have a single-ended swing less than 800 mV and

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

- greater than 200 mV. This requirement is the same for both external DC-coupled or AC-coupled connection.
- For external DC-coupled connection, as described in Section 20.2.1, "SerDes Reference Clock Receiver Characteristics," the maximum average current requirements sets the requirement for average voltage (common mode voltage) to be between 100 mV and 400 mV. Figure 50 shows the SerDes reference clock input requirement for DC-coupled connection scheme.
- For **external AC-coupled** connection, there is no common mode voltage requirement for the clock driver. Since the external AC-coupling capacitor blocks the DC level, the clock driver and the SerDes reference clock receiver operate in different command mode voltages. The SerDes reference clock receiver in this connection scheme has its common mode voltage set to SGND\_SRDSn. Each signal wire of the differential inputs is allowed to swing below and above the command mode voltage (SGND\_SRDSn). Figure 51 shows the SerDes reference clock input requirement for AC-coupled connection scheme.

## Single-ended Mode

- The reference clock can also be single-ended. The SD\_REF\_CLK input amplitude (single-ended swing) must be between 400 mV and 800 mV $_{p-p}$  (from  $V_{min}$  to  $V_{max}$ ) with  $\overline{SDn_REF_CLK}$  either left unconnected or tied to ground.
- The SDn\_REF\_CLK input average voltage must be between 200 mV and 400 mV. Figure 52 shows the SerDes reference clock input requirement for single-ended signaling mode.
- To meet the input amplitude requirement, the reference clock inputs might need to be DC or AC-coupled externally. For the best noise performance, the reference of the clock could be DC or AC-coupled into the unused phase (SDn\_REF\_CLK) through the same source impedance as the clock input (SDn\_REF\_CLK) in use.

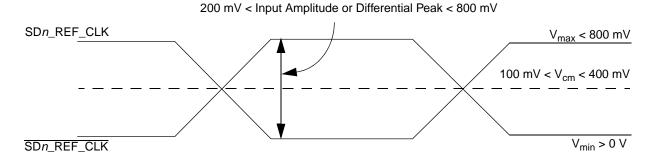


Figure 50. Differential Reference Clock Input DC Requirements (External DC-Coupled)

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

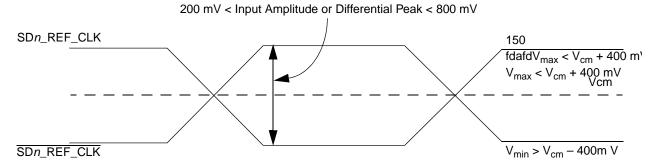


Figure 51. Differential Reference Clock Input DC Requirements (External AC-Coupled)

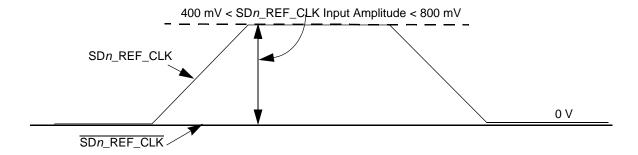


Figure 52. Single-Ended Reference Clock Input DC Requirements

## 20.2.3 Interfacing With Other Differential Signaling Levels

The following list provides information about interfacing with other differential signaling levels.

- With on-chip termination to SGND\_SRDSn (xcorevss), the differential reference clocks inputs are HCSL (high-speed current steering logic) compatible DC-coupled.
- Many other low voltage differential type outputs like LVDS (low voltage differential signaling) can
  be used but may need to be AC-coupled due to the limited common mode input range allowed
  (100 mV to 400 mV) for DC-coupled connection.
- LVPECL outputs can produce signal with too large amplitude and may need to be DC-biased at clock driver output first, then followed with series attenuation resistor to reduce the amplitude, in addition to AC-coupling.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

### **NOTE**

Figure 53 to Figure 56 below are for conceptual reference only. Due to the fact that clock driver chip's internal structure, output impedance, and termination requirements are different between various clock driver chip manufacturers, it is very possible that the clock circuit reference designs provided by the clock driver chip vendor are different from what is shown below. They might also vary from one vendor to the other. Therefore, Freescale Semiconductor can neither provide the optimal clock driver reference circuits, nor guarantee the correctness of the following clock driver connection reference circuits. The system designer is recommended to contact the selected clock driver chip vendor for the optimal reference circuits with the device SerDes reference clock receiver requirement provided in this document.

Figure 53 shows the SerDes reference clock connection reference circuits for HCSL type clock driver. It assumes that the DC levels of the clock driver chip is compatible with device SerDes reference clock input's DC requirement.

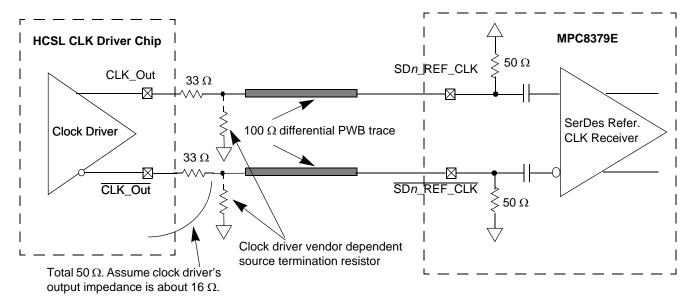


Figure 53. DC-Coupled Differential Connection with HCSL Clock Driver (Reference Only)

Figure 54 shows the SerDes reference clock connection reference circuits for LVDS type clock driver. Since LVDS clock driver's common-mode voltage is higher than the device SerDes reference clock input's allowed range (100 to 400 mV), AC-coupled connection scheme must be used. It assumes the LVDS

#### **High-Speed Serial Interfaces (HSSI)**

output driver features a  $50-\Omega$  termination resistor. It also assumes that the LVDS transmitter establishes its own common mode level without relying on the receiver or other external component.

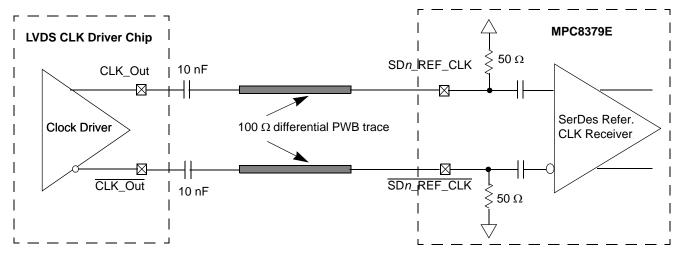


Figure 54. AC-Coupled Differential Connection with LVDS Clock Driver (Reference Only)

Figure 55 shows the SerDes reference clock connection reference circuits for LVPECL type clock driver. Since LVPECL driver's DC levels (both common mode voltages and output swing) are incompatible with device SerDes reference clock input's DC requirement, AC-coupling has to be used. Figure 55 assumes that the LVPECL clock driver's output impedance is  $50 \Omega$ . R1 is used to DC-bias the LVPECL outputs prior to AC-coupling. Its value could be ranged from  $140 \Omega$  to  $240 \Omega$  depending on clock driver vendor's requirement. R2 is used together with the SerDes reference clock receiver's  $50 \Omega$  termination resistor to attenuate the LVPECL output's differential peak level such that it meets the device SerDes reference clock's differential input amplitude requirement (between 200 mV and 800 mV differential peak). For example, if the LVPECL output's differential peak is 900 mV and the desired SerDes reference clock input amplitude is selected as 600 mV, the attenuation factor is 0.67, which requires  $R2 = 25 \Omega$ . Please consult

clock driver chip manufacturer to verify whether this connection scheme is compatible with a particular clock driver chip.

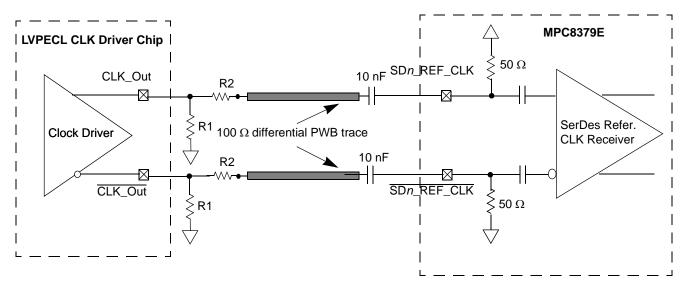


Figure 55. AC-Coupled Differential Connection with LVPECL Clock Driver (Reference Only)

Figure 56 shows the SerDes reference clock connection reference circuits for a single-ended clock driver. It assumes the DC levels of the clock driver are compatible with device SerDes reference clock input's DC requirement.

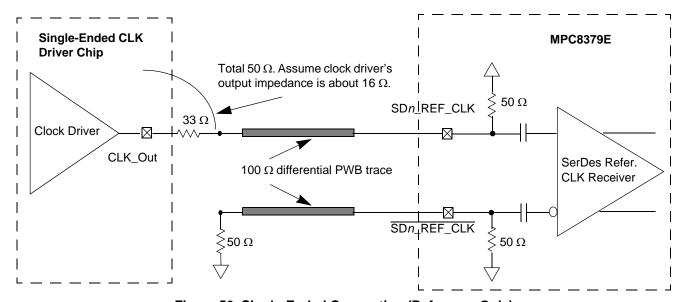


Figure 56. Single-Ended Connection (Reference Only)

# 20.2.4 AC Requirements for SerDes Reference Clocks

The clock driver selected should provide a high quality reference clock with low phase noise and cycle-to-cycle jitter. Phase noise less than 100 KHz can be tracked by the PLL and data recovery loops and is less of a problem. Phase noise above 15 MHz is filtered by the PLL. The most problematic phase noise

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **High-Speed Serial Interfaces (HSSI)**

occurs in the 1–15 MHz range. The source impedance of the clock driver should be 50  $\Omega$  to match the transmission line and reduce reflections which are a source of noise to the system.

Table 68 describes some AC parameters common to SATA protocols.

### **Table 68. SerDes Reference Clock Common AC Parameters**

At recommended operating conditions with XV<sub>DD SRDS</sub> or XV<sub>DD SRDS</sub> = 1.0 V  $\pm$  5%.

Parameter	Symbol	Min	Max	Unit	Notes
Rising Edge Rate	Rise Edge Rate	1.0	4.0	V/ns	2, 3
Falling Edge Rate	Fall Edge Rate	1.0	4.0	V/ns	2, 3
Differential Input High Voltage	V <sub>IH</sub>	200	_	mV	2
Differential Input Low Voltage	V <sub>IL</sub>	_	-200	mV	2
Rising edge rate (SDn_REF_CLK) to falling edge rate (SDn_REF_CLK) matching	Rise-Fall Matching	-	20	%	1, 4

#### Note:

- Measurement taken from single ended waveform.
- <sup>2</sup> Measurement taken from differential waveform.
- Measured from –200 mV to +200 mV on the differential waveform (derived from SDn\_REF\_CLK minus SDn\_REF\_CLK). The signal must be monotonic through the measurement region for rise and fall time. The 400 mV measurement window is centered on the differential zero crossing. See Figure 57.
- <sup>4</sup> Matching applies to rising edge rate for SD*n*\_REF\_CLK and falling edge rate for SD*n*\_REF\_CLK. It is measured using a 200 mV window centered on the median cross point where SDn\_REF\_CLK rising meets SD*n*\_REF\_CLK falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations. The Rise Edge Rate of SD*n*\_REF\_CLK should be compared to the Fall Edge Rate of SD*n*\_REF\_CLK, the maximum allowed difference should not exceed 20% of the slowest edge rate. See Figure 58.

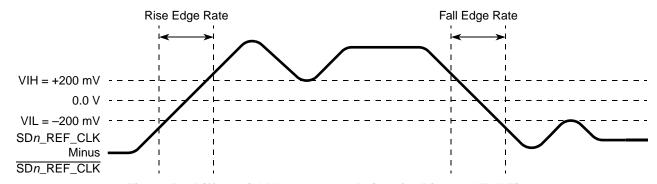


Figure 57. Differential Measurement Points for Rise and Fall Time

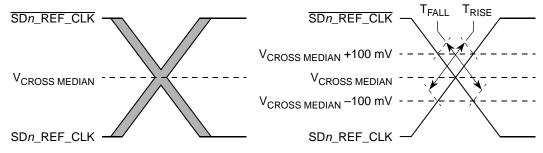


Figure 58. Single-Ended Measurement Points for Rise and Fall Time Matching

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

79

## 20.3 SerDes Transmitter and Receiver Reference Circuits

Figure 59 shows the reference circuits for SerDes data lane's transmitter and receiver.

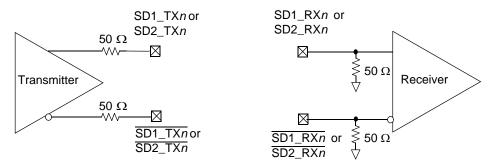


Figure 59. SerDes Transmitter and Receiver Reference Circuits

The DC and AC specification of SerDes data lanes are defined in each interface protocol section below in this document based on the application usage:

- Section 8, "Ethernet: Enhanced Three-Speed Ethernet (eTSEC)"
- Section 15, "Serial ATA (SATA)"

Note that an external AC coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in specification of each protocol section.

# 21 Package and Pin Listings

This section details package parameters, pin assignments, and dimensions.

# 21.1 Package Parameters for the MPC8379E TePBGA II

The package parameters are provided in the following list. The package type is 31 mm  $\times$  31 mm, 689 plastic ball grid array (TePBGA II).

Package outline  $31 \text{ mm} \times 31 \text{ mm}$ 

Interconnects 689
Pitch 1.00 mm

Module height (typical) 2.0 mm to 2.46 mm (maximum)

Solder Balls 3.5% Ag, 96.5% Sn

Ball diameter (typical) 0.60 mm

Figure 60 shows the mechanical dimensions and bottom surface nomenclature of the TEPBGA II package.

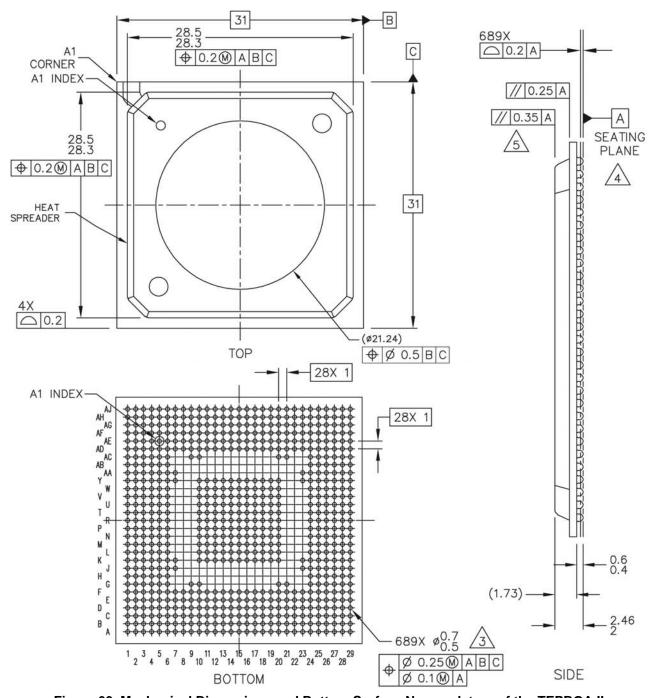


Figure 60. Mechanical Dimensions and Bottom Surface Nomenclature of the TEPBGA II

## Note:

- All dimensions are in millimeters.
- <sup>2</sup> Dimensioning and tolerancing per ASME Y14. 5M-1994.
- <sup>3</sup> Maximum solder ball diameter measured parallel to Datum A.
- <sup>4</sup> Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
- <sup>5</sup> Parallelism measurement should exclude any effect of mark on top surface of package.

#### MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 21.2 Pinout Listings

Table 69 provides the pinout listing for the TePBGA II package.

Table 69. TePBGA II Pinout Listing

Signal	Package Pin Number	Pin Type	Power Supply	Notes
<u> </u>	Clock Signals	-		
CLKIN	K24	I	OVDD	_
PCI_CLK/PCI_SYNC_IN	C10	I	OVDD	_
PCI_SYNC_OUT	N24	0	OVDD	3
PCI_CLK0	L24	0	OVDD	_
PCI_CLK1	M24	0	OVDD	_
PCI_CLK2	M25	0	OVDD	_
PCI_CLK3	M26	0	OVDD	_
PCI_CLK4	L26	0	OVDD	_
RTC/PIT_CLOCK	AF11	I	OVDD	_
1	DDR SDRAM Memory Inter	face		
MAO	U3	0	GVDD	_
MA1	U1	0	GVDD	_
MA2	T5	0	GVDD	_
MA3	Т3	0	GVDD	_
MA4	T2	0	GVDD	_
MA5	T1	0	GVDD	_
MA6	R1	0	GVDD	_
MA7	P2	0	GVDD	_
MA8	P1	0	GVDD	_
MA9	N4	0	GVDD	_
MA10	V3	0	GVDD	_
MA11	M5	0	GVDD	_
MA12	N1	0	GVDD	_
MA13	M2	0	GVDD	_
MA14	M1	0	GVDD	_
MBA0	U5	0	GVDD	_
MBA1	U4	0	GVDD	_
MBA2	M3	0	GVDD	_
MCAS_B	W5	0	GVDD	_

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
MCK_B0	H1	0	GVDD	_
MCK_B1	K1	0	GVDD	_
MCK_B2	V1	0	GVDD	_
MCK_B3	W2	0	GVDD	_
MCK_B4	AA1	0	GVDD	_
MCK_B5	AB2	0	GVDD	_
MCK0	J1	0	GVDD	_
MCK1	L1	0	GVDD	_
MCK2	V2	0	GVDD	_
MCK3	W1	0	GVDD	_
MCK4	Y1	0	GVDD	_
MCK5	AB1	0	GVDD	_
MCKE0	M4	0	GVDD	3
MCKE1	R5	0	GVDD	3
MCS_B0	W3	0	GVDD	_
MCS_B1	P3	0	GVDD	_
MCS_B2	T4	0	GVDD	_
MCS_B3	R4	0	GVDD	_
MDIC0	AH8	I/O	GVDD	9
MDIC1	AJ8	I/O	GVDD	9
MDM0	B6	0	GVDD	_
MDM1	B2	0	GVDD	_
MDM2	E2	0	GVDD	_
MDM3	E1	0	GVDD	_
MDM4	Y6	0	GVDD	_
MDM5	AC6	0	GVDD	_
MDM6	AE6	0	GVDD	_
MDM7	AJ4	0	GVDD	_
MDM8	L6	0	GVDD	_
MDQ0	A8	I/O	GVDD	11
MDQ1	A6	I/O	GVDD	11
MDQ2	C7	I/O	GVDD	11
MDQ3	D8	I/O	GVDD	11

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
MDQ4	A7	I/O	GVDD	11
MDQ5	A5	I/O	GVDD	11
MDQ6	A3	I/O	GVDD	11
MDQ7	C6	I/O	GVDD	11
MDQ8	D7	I/O	GVDD	11
MDQ9	E8	I/O	GVDD	11
MDQ10	B1	I/O	GVDD	11
MDQ11	D5	I/O	GVDD	11
MDQ12	В3	I/O	GVDD	11
MDQ13	D6	I/O	GVDD	11
MDQ14	C3	I/O	GVDD	11
MDQ15	C2	I/O	GVDD	11
MDQ16	D4	I/O	GVDD	11
MDQ17	E6	I/O	GVDD	11
MDQ18	F6	I/O	GVDD	11
MDQ19	G4	I/O	GVDD	11
MDQ20	F8	I/O	GVDD	11
MDQ21	E4	I/O	GVDD	11
MDQ22	C1	I/O	GVDD	11
MDQ23	G6	I/O	GVDD	11
MDQ24	F2	I/O	GVDD	11
MDQ25	G5	I/O	GVDD	11
MDQ26	H6	I/O	GVDD	11
MDQ27	H4	I/O	GVDD	11
MDQ28	D1	I/O	GVDD	11
MDQ29	G3	I/O	GVDD	11
MDQ30	H5	I/O	GVDD	11
MDQ31	F1	I/O	GVDD	11
MDQ32	W6	I/O	GVDD	11
MDQ33	AC1	I/O	GVDD	11
MDQ34	AC3	I/O	GVDD	11
MDQ35	AE1	I/O	GVDD	11
MDQ36	V6	I/O	GVDD	11

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
MDQ37	Y5	I/O	GVDD	11
MDQ38	AA4	I/O	GVDD	11
MDQ39	AB6	I/O	GVDD	11
MDQ40	AD3	I/O	GVDD	11
MDQ41	AC4	I/O	GVDD	11
MDQ42	AD4	I/O	GVDD	11
MDQ43	AF1	I/O	GVDD	11
MDQ44	AE4	I/O	GVDD	11
MDQ45	AC5	I/O	GVDD	11
MDQ46	AE2	I/O	GVDD	11
MDQ47	AE3	I/O	GVDD	11
MDQ48	AG1	I/O	GVDD	11
MDQ49	AG2	I/O	GVDD	11
MDQ50	AG3	I/O	GVDD	11
MDQ51	AF5	I/O	GVDD	11
MDQ52	AE5	I/O	GVDD	11
MDQ53	AD7	I/O	GVDD	11
MDQ54	AH2	I/O	GVDD	11
MDQ55	AG4	I/O	GVDD	11
MDQ56	AH3	I/O	GVDD	11
MDQ57	AG5	I/O	GVDD	11
MDQ58	AF8	I/O	GVDD	11
MDQ59	AJ5	I/O	GVDD	11
MDQ60	AF6	I/O	GVDD	11
MDQ61	AF7	I/O	GVDD	11
MDQ62	AH6	I/O	GVDD	11
MDQ63	AH7	I/O	GVDD	11
MDQS0	C8	I/O	GVDD	11
MDQS1	C4	I/O	GVDD	11
MDQS2	E3	I/O	GVDD	11
MDQS3	G2	I/O	GVDD	11
MDQS4	AB5	I/O	GVDD	11
MDQS5	AD1	I/O	GVDD	11

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
MDQS6	AH1	I/O	GVDD	11
MDQS7	AJ3	I/O	GVDD	11
MDQS8	G1	I/O	GVDD	11
MECC0/MSRCID0	J6	I/O	GVDD	_
MECC1/MSRCID1	J3	I/O	GVDD	_
MECC2/MSRCID2	K2	I/O	GVDD	_
MECC3/MSRCID3	K3	I/O	GVDD	_
MECC4/MSRCID4	J5	I/O	GVDD	_
MECC5/MDVAL	J2	I/O	GVDD	_
MECC6	L5	I/O	GVDD	_
MECC7	L2	I/O	GVDD	_
MODT0	N5	0	GVDD	6
MODT1	U6	0	GVDD	6
MODT2	M6	0	GVDD	6
MODT3	P6	0	GVDD	6
MRAS_B	AA3	0	GVDD	_
MVREF1	K4	I	GVDD	11
MVREF2	W4	I	GVDD	11
MWE_B	Y2	0	GVDD	_
·	DUART Interface			
UART_SIN1/ MSRCID2/LSRCID2	L28	I/O	OVDD	_
UART_SOUT1/ MSRCID0/LSRCID0	L27	0	OVDD	_
UART_CTS_B[1]/ MSRCID4/LSRCID4	K26	I/O	OVDD	_
UART_RTS_B1	N27	0	OVDD	_
UART_SIN2/ MSRCID3/LSRCID3	K27	I/O	OVDD	
UART_SOUT2/ MSRCID1/LSRCID1	K28	0	OVDD	_
UART_CTS_B[2]/ MDVAL/LDVAL	K29	I/O	OVDD	_
	L29	0	OVDD	

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
LAD0	E24	I/O	LBVDD	_
LAD1	G28	I/O	LBVDD	_
LAD2	H25	I/O	LBVDD	_
LAD3	F26	I/O	LBVDD	_
LAD4	C26	I/O	LBVDD	_
LAD5	J28	I/O	LBVDD	_
LAD6	F21	I/O	LBVDD	_
LAD7	F23	I/O	LBVDD	_
LAD8	E25	I/O	LBVDD	_
LAD9	E26	I/O	LBVDD	_
LAD10	A23	I/O	LBVDD	_
LAD11	F24	I/O	LBVDD	_
LAD12	G24	I/O	LBVDD	_
LAD13	F25	I/O	LBVDD	_
LAD14	H28	I/O	LBVDD	_
LAD15	G25	I/O	LBVDD	_
LA11/LAD16	F27	I/O	LBVDD	_
LA12/LAD17	B21	I/O	LBVDD	_
LA13/LAD18	A25	I/O	LBVDD	_
LA14/LAD19	C28	I/O	LBVDD	_
LA15/LAD20	H24	I/O	LBVDD	_
LA16/LAD21	E23	I/O	LBVDD	_
LA17/LAD22	B28	I/O	LBVDD	_
LA18/LAD23	D28	I/O	LBVDD	_
LA19/LAD24	A27	I/O	LBVDD	_
LA20/LAD25	C25	I/O	LBVDD	_
LA21/LAD26	B27	I/O	LBVDD	_
LA22/LAD27	H27	I/O	LBVDD	_
LA23/LAD28	E21	I/O	LBVDD	_
LA24/LAD29	F20	I/O	LBVDD	_
LA25/LAD30	D29	I/O	LBVDD	_
LA26/LAD31	E20	I/O	LBVDD	_
LA27	H26	0	LBVDD	_

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
LA28	C29	0	LBVDD	_
LA29	E28	0	LBVDD	_
LA30	B26	0	LBVDD	_
LA31	J25	0	LBVDD	_
LA10/LALE	H29	0	LBVDD	_
LBCTL	A22	0	LBVDD	_
LCLK0	B22	0	LBVDD	_
LCLK1	C23	0	LBVDD	_
LCLK2	B23	0	LBVDD	_
LCS_B0	D25	0	LBVDD	_
LCS_B1	F19	0	LBVDD	_
LCS_B2	C27	0	LBVDD	_
LCS_B3	D24	0	LBVDD	_
LCS_B4/LDP0	C24	I/O	LBVDD	_
LCS_B5/LDP1	B29	I/O	LBVDD	_
LA7/LCS_B6/LDP2	E29	I/O	LBVDD	_
LA8/LCS_B7/LDP3	F29	I/O	LBVDD	_
LFCLE/LGPL0	D21	0	LBVDD	_
LFALE/LGPL1	A26	0	LBVDD	_
LFRE_B/LGPL2/LOE_B	F22	0	LBVDD	_
LFWP_B/LGPL3	C21	0	LBVDD	_
LGPL4/LFRB_B/LGTA_B/ LUPWAIT/LPBSE	J29	I/O	LBVDD	_
LA9/LGPL5	G29	0	LBVDD	_
LSYNC_IN	A21	I	LBVDD	_
LSYNC_OUT	D23	0	LBVDD	_
LWE_B0/LFWE0/LBS_B0	E22	0	LBVDD	_
LWE_B1/LFWE1/LBS_B1	B25	0	LBVDD	_
LWE_B2/LFWE2/LBS_B2	E27	0	LBVDD	_
LWE_B3/LFWE3/LBS_B3	F28	0	LBVDD	_
	eTSEC1/GPIO1/GPIO2/CFG_RESET	Interface	•	
TSEC1_COL/GPIO2[20]	AF22	I/O	LVDD1	17
TSEC1_CRS/GPIO2[21]	AE20	I/O	LVDD1	17

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
TSEC1_GTX_CLK	AJ25	0	LVDD1	17
TSEC1_RX_CLK	AG22	I	LVDD1	17
TSEC1_RX_DV	AD19	I	LVDD1	17
TSEC1_RX_ER/GPIO2[25]	AD20	I/O	LVDD1	17
TSEC1_RXD0	AD22	I	LVDD1	17
TSEC1_RXD1	AE21	I	LVDD1	17
TSEC1_RXD2	AE22	I	LVDD1	17
TSEC1_RXD3	AD21	I	LVDD1	17
TSEC1_TX_CLK	AJ22	I	LVDD1	17
TSEC1_TX_EN	AG23	0	LVDD1	17
TSEC1_TX_ER/CFG_LBMUX	AH22	I/O	LVDD1	17
TSEC1_TXD0/ CFG_RESET_SOURCE[0]	AD23	I/O	LVDD1	17
TSEC1_TXD1/ CFG_RESET_SOURCE[1]	AE23	I/O	LVDD1	17
TSEC1_TXD2/ CFG_RESET_SOURCE[2]	AF23	I/O	LVDD1	17
TSEC1_TXD3/ CFG_RESET_SOURCE[3]	AJ24	I/O	LVDD1	17
EC_GTX_CLK125	AH24	I	LVDD1	17
EC_MDC/CFG_CLKIN_DIV	AJ21	I/O	LVDD1	17
EC_MDIO	AH21	I/O	LVDD1	17
·	eTSEC2/GPIO1 Interface	e	·	
TSEC2_COL/GPIO1[21]/ TSEC1_TMR_TRIG1	AJ27	I/O	LVDD2	17
TSEC2_CRS/GPIO1[22]/ TSEC1_TMR_TRIG2	AG29	I/O	LVDD2	17
TSEC2_GTX_CLK	AF28	0	LVDD2	17
TSEC2_RX_CLK/ TSEC1_TMR_CLK	AF25	I	LVDD2	17
TSEC2_RX_DV/GPIO1[23]	AF26	I/O	LVDD2	17
TSEC2_RX_ER/GPIO1[25]	AG25	I/O	LVDD2	17
TSEC2_RXD0/GPIO1[16]	AE28	I/O	LVDD2	17
TSEC2_RXD1/GPIO1[15]	AE29	I/O	LVDD2	17
TSEC2_RXD2/GPIO1[14]	AH26	I/O	LVDD2	17

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
TSEC2_RXD3/GPIO1[13]	AH25	I/O	LVDD2	17
TSEC2_TX_CLK/GPIO2[24]/ TSEC1_TMR_GCLK	AG28	I/O	LVDD2	17
TSEC2_TX_EN/GPIO1[12]/ TSEC1_TMR_ALARM2	AJ26	I/O	LVDD2	17
TSEC2_TX_ER/GPIO1[24]/ TSEC1_TMR_ALARM1	AG26	I/O	LVDD2	17
TSEC2_TXD0/GPIO1[20]	AH28	I/O	LVDD2	17
TSEC2_TXD1/GPIO1[19]/ TSEC1_TMR_PP1	AF27	I/O	LVDD2	17
TSEC2_TXD2/GPIO1[18]/ TSEC1_TMR_PP2	AJ28	I/O	LVDD2	17
TSEC2_TXD3/GPIO1[17]/ TSEC1_TMR_PP3	AF29	I/O	LVDD2	17
	GPIO1 Interface	·		
GPIO1[0]/GTM1_TIN1/ GTM2_TIN2/DREQ0_B	P25	I/O	OVDD	_
GPIO1[1]/GTM1_TGATE1_B/ GTM2_TGATE2_B/DACK0_B	N25	I/O	OVDD	_
GPIO1[2]/GTM1_TOUT1_B/ DDONE0_B	N26	I/O	OVDD	_
GPIO1[3]/GTM1_TIN2/ GTM2_TIN1/DREQ1_B	В9	I/O	OVDD	_
GPIO1[4]/GTM1_TGATE2_B/ GTM2_TGATE1_B/DACK1_B	N29	I/O	OVDD	_
GPIO1[5]/GTM1_TOUT2_B/ GTM2_TOUT1_B/DDONE1_B	M29	I/O	OVDD	_
GPIO1[6]/GTM1_TIN3/ GTM2_TIN4/DREQ2_B	A9	I/O	OVDD	_
GPIO1[7]/GTM1_TGATE3_B/ GTM2_TGATE4_B/DACK2_B	B10	I/O	OVDD	_
GPIO1[8]/GTM1_TOUT3_B/ DDONE2_B	J26	I/O	OVDD	_
GPIO1[9]/GTM1_TIN4/ GTM2_TIN3/DREQ3_B	J24	I/O	OVDD	_
GPIO1[10]/GTM1_TGATE4_B/ GTM2_TGATE3_B/DACK3_B	J27	I/O	OVDD	_
GPIO1[11]/GTM1_TOUT4_B/ GTM2_TOUT3_B/DDONE3_B	P24	I/O	OVDD	_

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	USB/GPIO2 Interface	1		
USBDR_CLK/GPIO2[23]	AJ11	I/O	OVDD	_
USBDR_DIR_DPPULLUP/ GPIO2[9]	AG12	I/O	OVDD	_
USBDR_NXT/GPIO2[8]	AJ10	I/O	OVDD	_
USBDR_PCTL0/GPIO2[11]/ SD_DAT2	AF10	I/O	OVDD	_
USBDR_PCTL1/GPIO2[22]/ SD_DAT3	AE9	I/O	OVDD	_
USBDR_PWRFAULT/ GPIO2[10]/SD_DAT1	AG13	I/O	OVDD	_
USBDR_STP_SUSPEND	AH12	0	OVDD	12
USBDR_D0_ENABLEN/ GPIO2[0]	AG10	I/O	OVDD	_
USBDR_D1_SER_TXD/ GPIO2[1]	AF13	I/O	OVDD	_
USBDR_D2_VMO_SE0/ GPIO2[2]	AG11	I/O	OVDD	_
USBDR_D3_SPEED/GPIO2[3]	AH11	I/O	OVDD	_
USBDR_D4_DP/GPIO2[4]	AG9	I/O	OVDD	_
USBDR_D5_DM/GPIO2[5]	AF9	I/O	OVDD	_
USBDR_D6_SER_RCV/ GPIO2[6]	AH13	I/O	OVDD	_
USBDR_D7_DRVVBUS/ GPIO2[7]	AH10	I/O	OVDD	_
·	I <sup>2</sup> C Interface			1
IIC1_SCL	C12	I/O	OVDD	2
IIC1_SDA	B12	I/O	OVDD	2
IIC2_SCL	A10	I/O	OVDD	2
IIC2_SDA	A12	I/O	OVDD	2
	JTAG Interface	•		
TCK	B13	I	OVDD	_
TDI	E14	I	OVDD	4
TDO	C13	0	OVDD	3
TMS	A13	1	OVDD	4
TRST_B	E11	I	OVDD	4

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	PCI Signals			l
PCI_AD0	P26	I/O	OVDD	_
PCI_AD1	N28	I/O	OVDD	_
PCI_AD2	P29	I/O	OVDD	_
PCI_AD3	P27	I/O	OVDD	_
PCI_AD4	R26	I/O	OVDD	_
PCI_AD5	R29	I/O	OVDD	_
PCI_AD6	T24	I/O	OVDD	_
PCI_AD7	T25	I/O	OVDD	_
PCI_AD8	R27	I/O	OVDD	_
PCI_AD9	P28	I/O	OVDD	_
PCI_AD10	U25	I/O	OVDD	_
PCI_AD11	R28	I/O	OVDD	_
PCI_AD12	U26	I/O	OVDD	_
PCI_AD13	U24	I/O	OVDD	_
PCI_AD14	T29	I/O	OVDD	_
PCI_AD15	V24	I/O	OVDD	_
PCI_AD16	Y26	I/O	OVDD	_
PCI_AD17	V28	I/O	OVDD	_
PCI_AD18	AA25	I/O	OVDD	_
PCI_AD19	AA26	I/O	OVDD	_
PCI_AD20	W29	I/O	OVDD	_
PCI_AD21	AA24	I/O	OVDD	_
PCI_AD22	AA27	I/O	OVDD	_
PCI_AD23	AC26	I/O	OVDD	_
PCI_AD24	AB25	I/O	OVDD	_
PCI_AD25	AB24	I/O	OVDD	_
PCI_AD26	AA28	I/O	OVDD	_
PCI_AD27	AA29	I/O	OVDD	_
PCI_AD28	AC24	I/O	OVDD	_
PCI_AD29	AC25	I/O	OVDD	_
PCI_AD30	AB28	I/O	OVDD	_

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PCI_AD31	AE24	I/O	OVDD	_
PCI_C_BE_B0	T26	I/O	OVDD	_
PCI_C_BE_B1	T28	I/O	OVDD	_
PCI_C_BE_B2	V29	I/O	OVDD	_
PCI_C_BE_B3	Y29	I/O	OVDD	_
PCI_DEVSEL_B	U28	I/O	OVDD	5
PCI_FRAME_B	V27	I/O	OVDD	_
PCI_GNT_B0	AE27	I/O	OVDD	_
PCI_GNT_B[1]/ CPCI_HS_LED	AC28	0	OVDD	_
PCI_GNT_B[2]/ CPCI_HS_ENUM	AD27	0	OVDD	_
PCI_GNT_B[3]/PCI_PME	AC27	0	OVDD	_
PCI_GNT_B[4]	AE25	0	OVDD	_
PCI_IDSEL	W28	I	OVDD	5
PCI_INTA_B/IRQ_OUT_B	AD29	0	OVDD	2
PCI_IRDY_B	U29	I/O	OVDD	5
PCI_PAR	V25	I/O	OVDD	_
PCI_PERR_B	Y25	I/O	OVDD	5
PCI_REQ_B0	AE26	I/O	OVDD	_
PCI_REQ_B[1]/CPCI_HS_ES	AC29	I	OVDD	_
PCI_REQ_B2	AB29	I	OVDD	_
PCI_REQ_B3	AD26	I	OVDD	_
PCI_REQ_B4	W27	I	OVDD	_
PCI_RESET_OUT_B	AD28	0	OVDD	_
PCI_SERR_B	V26	I/O	OVDD	5
PCI_STOP_B	W26	I/O	OVDD	5
PCI_TRDY_B	Y24	I/O	OVDD	5
M66EN	AD15	I	OVDD	_
Р	rogrammable Interrupt Controller (	(PIC) Interface	•	
MCP_OUT_B	AD14	0	OVDD	2
IRQ_B0/MCP_IN_B/GPIO2[12]	F9	I/O	OVDD	_
IRQ_B1/GPIO2[13]	E9	I/O	OVDD	_

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
IRQ_B2/GPIO2[14]	F10	I/O	OVDD	_
IRQ_B3/GPIO2[15]	D9	I/O	OVDD	_
IRQ_B4/GPIO2[16]/SD_WP	C9	I/O	OVDD	_
IRQ_B5/GPIO2[17]/ USBDR_PWRFAULT	AE10	I/O	OVDD	_
IRQ_B6/GPIO2[18]	AD10	I/O	OVDD	_
IRQ_B7/GPIO2[19]	AD9	I/O	OVDD	_
	PMC Interface		1	
QUIESCE_B	D13	0	OVDD	_
	SerDes1 Interface	1	<u> </u>	
L1_SD_IMP_CAL_RX	AJ14	I	L1_XPADVDD	_
L1_SD_IMP_CAL_TX	AG19	I	L1_XPADVDD	_
L1_SD_REF_CLK	AJ17	I	L1_XPADVDD	_
L1_SD_REF_CLK_B	AH17	I	L1_XPADVDD	_
L1_SD_RXA_N	AJ15	I	L1_XPADVDD	_
L1_SD_RXA_P	AH15	I	L1_XPADVDD	_
L1_SD_RXE_N	AJ19	I	L1_XPADVDD	_
L1_SD_RXE_P	AH19	I	L1_XPADVDD	_
L1_SD_TXA_N	AF15	0	L1_XPADVDD	_
L1_SD_TXA_P	AE15	0	L1_XPADVDD	_
L1_SD_TXE_N	AF18	0	L1_XPADVDD	_
L1_SD_TXE_P	AE18	0	L1_XPADVDD	_
L1_SDAVDD_0	AJ18 SerDes PLL Power (1.0 or 1.05 V)		_	_
L1_SDAVSS_0	AG17	SerDes PLL GND	_	_
L1_XCOREVDD	AH14, AJ16, AF17, AH20, AJ20	SerDes Core Power (1.0 or 1.05 V)	_	_
L1_XCOREVSS	AG14, AG15, AG16, AH16, AG18, AG20	SerDes Core GND	_	_
L1_XPADVDD	AE16, AF16, AD18, AE19, AF19	SerDes I/O Power (1.0 or 1.05 V)	_	_

## Package and Pin Listings

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
L1_XPADVSS	AF14, AE17, AF20	SerDes I/O GND	_	_
	SerDes2 Interface	•		
L2_SD_IMP_CAL_RX	C19	ı	L2_XPADVDD	_
L2_SD_IMP_CAL_TX	C15	I	L2_XPADVDD	_
L2_SD_REF_CLK	B17	I	L2_XPADVDD	_
L2_SD_REF_CLK_B	A17	I	L2_XPADVDD	_
L2_SD_RXA_N	A19	I	L2_XPADVDD	_
L2_SD_RXA_P	B19	I	L2_XPADVDD	_
L2_SD_RXE_N	A15	I	L2_XPADVDD	_
L2_SD_RXE_P	B15	I	L2_XPADVDD	_
L2_SD_TXA_N	D18	0	L2_XPADVDD	_
L2_SD_TXA_P	E18	0	L2_XPADVDD	_
L2_SD_TXE_N	D15	0	L2_XPADVDD	_
L2_SD_TXE_P	E15	0	L2_XPADVDD	_
L2_SDAVDD_0	A16	SerDes PLL Power (1.0 or 1.05 V)	_	_
L2_SDAVSS_0	C17	SerDes PLL GND	_	_
L2_XCOREVDD	A14, B14, D17, B18, B20	SerDes Core Power (1.0 or 1.05 V)	_	_
L2_XCOREVSS	C14, C16, A18, C18, A20, C20	SerDes Core GND	_	_
L2_XPADVDD	D14, E16, F18, D19, E19	SerDes I/O Power (1.0 or 1.05 V)	_	_
L2_XPADVSS	D16, E17, D20	SerDes I/O GND	_	_
	SPI Interface			
SPICLK/SD_CLK	AH9	I/O	OVDD	_
SPIMISO/SD_DAT0	AD11	I/O	OVDD	_
SPIMOSI/SD_CMD	AJ9	I/O	OVDD	_
SPISEL_B/SD_CD	AE11	I	OVDD	_
	System Control Interface	e	<u> </u>	

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
SRESET_B	AD12	I/O	OVDD	2
HRESET_B	AE12	I/O	OVDD	1
PORESET_B	AE14	I	OVDD	_
	Test Interface			
TEST	E10	I	OVDD	10
TEST_SEL0	D10	I	OVDD	14
TEST_SEL1	D12	I	_	13
	Thermal Management	<u> </u>	<u> </u>	
Reserved	F15	I	_	15
	Power Supply Signals	1		
LVDD1	AC21, AG21, AH23	Power for eTSEC 1 I/O (2.5 V, 3.3 V)	LVDD1	_
LVDD2	AG24, AH27, AH29			_
LBVDD	G20, D22, A24, G26, D27, A28	Power for eLBC (3.3, 2.5, or 1.8 V)	LBVDD	_
VDD	K10, L10, M10, N10, P10, R10, T10, U10, V10, W10, Y10, K11, R11, Y11, K12, Y12, K13, Y13, K14, Y14, K15, L15, W15, Y15, K16, Y16, K17, Y17, K18, Y18, K19, R19, Y19, K20, L20, M20, N20, P20, R20, T20, U20, V20, W20, Y20	Power for Core (1.0 V or 1.5 V)	VDD	_
GND (VSS)	A1, AJ1, H2, N2, AA2, AD2, D3, R3, AF3, A4, F4, J4, L4, V4, Y4, AB4, B5, E5, P5, AH5, K6, T6, AA6, AD6, AG6, F7, J7, Y7, AJ7, B8, AE8, AG8, G9, AC9,B11, D11, F11, L11, M11, N11, P11, T11, U11, V11, W11, L12, M12, N12, P12, R12, T12, U12, V12, W12, E12, E13, L13, M13, N13, P13, R13, T13, U13, V13, W13, AE13, AJ13, F14, L14, M14, N14, P14, R14, T14, U14, V14, W14, M15, N15, P15, R15, T15, U15, V15, L16, M16, N16, P16, R16, T16, U16, V16, W16, L17, M17, N17, P17, R17, T17, U17, V17, W17, L18, M18, N18, P18, R18, T18, U18, V18, W18, L19, M19, N19, P19, T19, U19, V19, W19, AC20, G21, AF21, C22, J23, AA23, AJ23, B24, W24, AF24, K25, R25, AD25, D26, G27, M27, T27, Y27, AB27, AG27, A29, AJ29	_	_	_

Table 69. TePBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
AVDD_C	AD13	Power for e300 core PLL (1.0 V or 1.05 V)	_	16
AVDD_L	F13	Power for eLBC PLL (1.0 V or 1.05 V)		16
AVDD_P	F12	Power for system PLL (1.0 V or 1.05 V)	_	16
GVDD	A2, D2, R2, U2, AC2, AF2, AJ2, F3, H3, L3, N3, Y3, AB3, B4, P4, AF4, AH4, C5, F5, K5, V5, AA5, AD5, N6, R6, AJ6, B7, E7, K7, AA7, AE7, AG7, AD8	Power for DDR SDRAM I/O Voltage (2.5 or 1.8 V)	GVDD	_
OVDD	AC10, AF12, AJ12, K23, Y23, R24, AD24, L25, W25, AB26, U27, M28, Y28, G10, A11, C11	PCI, USB, and other Standard (3.3 V)	OVDD	_
	No Connect			
NC	F16, F17, AD16, AD17	_	_	8
	Pull Down			
Pull Down	B16, AH18	_	_	7

#### Note:

- <sup>1</sup> This pin is an open drain signal. A weak pull-up resistor (1 k $\Omega$ ) should be placed on this pin to OVDD.
- <sup>2</sup> This pin is an open drain signal. A weak pull-up resistor (2–10  $k\Omega$ ) should be placed on this pin to OVDD.
- <sup>3</sup> This output is actively driven during reset rather than being released to high impedance during reset.
- <sup>4</sup> These JTAG pins have weak internal pull-up P-FETs that are always enabled.
- This pin should have a weak pull up if the chip is in PCI host mode. Follow PCI Specification recommendation and see AN3665, "MPC837xE Design Checklist," for more details.
- <sup>6</sup> These are On Die Termination pins, used to control DDR2 memories internal termination resistance.
- $^{7}\,$  This pin must always be tied to GND using a 0  $\Omega$  resistor.
- <sup>8</sup> This pin must always be left not connected.
- <sup>9</sup> For DDR2 operation, it is recommended that MDIC0 be tied to GND using an 18.2  $\Omega$  resistor and MDIC1 be tied to DDR power using an 18.2  $\Omega$  resistor.
- <sup>10</sup> This pin must always be tied low. If it is left floating it may cause the device to malfunction.
- <sup>11</sup> See AN3665, "MPC837xE Design Checklist," for proper DDR termination.
- <sup>12</sup> This pin must not be pulled down during PORESET.
- <sup>13</sup> This pin must always be tied to GND.
- <sup>14</sup> This pin must always be tied to OVDD.
- <sup>15</sup> Open or tie to GND.
- <sup>16</sup> Voltage settings are dependent on the frequency used; see Table 3.
- <sup>17</sup> See AN3665, "MPC837xE Design Checklist," for proper eTSEC termination.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 22 Clocking

Figure 61 shows the internal distribution of clocks within the MPC8379E.

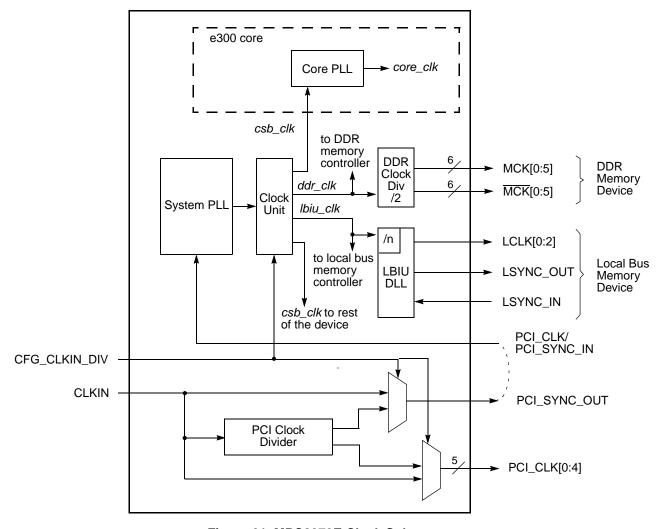


Figure 61. MPC8379E Clock Subsystem

The primary clock source for the device can be one of two inputs, CLKIN or PCI\_CLK, depending on whether the device is configured in PCI host or PCI agent mode. When the device is configured as a PCI host device, CLKIN is its primary input clock. CLKIN feeds the PCI clock divider (÷2) and the multiplexors for PCI\_SYNC\_OUT and PCI\_CLK\_OUT. The CFG\_CLKIN\_DIV configuration input selects whether CLKIN or CLKIN/2 is driven out on the PCI\_SYNC\_OUT signal. The OCCR[PCICOEn] parameters select whether CFG\_CLKIN\_DIV is driven out on the PCI\_CLK\_OUTn signals.

PCI\_SYNC\_OUT is connected externally to PCI\_SYNC\_IN to allow the internal clock subsystem to synchronize to the system PCI clocks. PCI\_SYNC\_OUT must be connected properly to PCI\_SYNC\_IN, with equal delay to all PCI agent devices in the system, to allow the device to function. When the device is configured as a PCI agent device, PCI\_CLK is the primary input clock. When the device is configured as a PCI agent device the CLKIN signal should be tied to GND.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### Clocking

As shown in Figure 61, the primary clock input (frequency) is multiplied up by the system phase-locked loop (PLL) and the clock unit to create the coherent system bus clock  $(csb\_clk)$ , the internal clock for the DDR controller  $(ddr\_clk)$ , and the internal clock for the local bus interface unit  $(lbiu\_clk)$ .

The *csb\_clk* frequency is derived from a complex set of factors that can be simplified into the following equation:

Eqn. 20

In PCI host mode, PCI\_SYNC\_IN  $\times$  (1 + CFG\_CLKIN\_DIV) is the CLKIN frequency.

The *csb\_clk* serves as the clock input to the e300 core. A second PLL inside the e300 core multiplies up the *csb\_clk* frequency to create the internal clock for the e300 core (*core\_clk*). The system and core PLL multipliers are selected by the SPMF and COREPLL fields in the reset configuration word low register (RCWLR) which is loaded at power-on reset or by one of the hard-coded reset options. See Chapter 4, "Reset, Clocking, and Initialization," in the *MPC8379E Reference Manual* for more information on the clock subsystem.

The internal *ddr clk* frequency is determined by the following equation:

$$ddr_clk = csb_clk \times (1 + RCWLR[DDRCM])$$

Egn. 21

Note that  $ddr\_clk$  is not the external memory bus frequency;  $ddr\_clk$  passes through the DDR clock divider (÷2) to create the differential DDR memory bus clock outputs (MCK and  $\overline{\text{MCK}}$ ). However, the data rate is the same frequency as  $ddr\_clk$ .

The internal *lbiu\_clk* frequency is determined by the following equation:

$$lbiu\_clk = csb\_clk \times (1 + RCWLR[LBCM])$$

Eqn. 22

Note that *lbiu\_clk* is not the external local bus frequency; *lbiu\_clk* passes through the LBIU clock divider to create the external local bus clock outputs (LCLK[0:2]). The eLBC clock divider ratio is controlled by LCRR[CLKDIV].

Some of the internal units may be required to be shut off or operate at lower frequency than the *csb\_clk* frequency. Those units have a default clock ratio that can be configured by a memory mapped register after the device comes out of reset. Table 70 specifies which units have a configurable clock frequency.

Table 70.	Configurable	Clock Units
-----------	--------------	-------------

Unit	Default Frequency	Options
eTSEC1, eTSEC2	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
eSDHC and I <sup>2</sup> C1 <sup>1</sup>	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
Security block	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
USB DR	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3
PCI and DMA complex	csb_clk	Off, csb_clk
SATA1, 2, 3, 4	csb_clk/3	Off, csb_clk, csb_clk/2, csb_clk/3

This only applies to I<sup>2</sup>C1 (I<sup>2</sup>C2 clock is not configurable).

#### MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 71 provides the operating frequencies for the TePBGA II package under recommended operating conditions (see Table 3).

Table 71. Operating Frequencies for TePBGA II

Parameter <sup>1</sup>	Minimum Operating Frequency (MHz)	Maximum Operating Frequency (MHz)
e300 core frequency (core_clk)	333	800
Coherent system bus frequency (csb_clk)	133	400
DDR2 memory bus frequency (MCK) <sup>2</sup>	125	200
DDR1 memory bus frequency (MCK) <sup>2</sup>	167	333
Local bus frequency (LCLKn) <sup>3</sup>	_	133
Local bus controller frequency (lbc_clk)	_	400
PCI input frequency (CLKIN or PCI_CLK)	25	66
eTSEC frequency	_	400
Security encryption controller frequency	_	200
USB controller frequency	_	200
eSDHC controller frequency	_	200
SATA controller frequency	_	200

#### Note:

## 22.1 System PLL Configuration

The system PLL is controlled by the RCWLR[SPMF] parameter. The system PLL VCO frequency depends on RCWLR[DDRCM] and RCWLR[LBCM]. Table 72 shows the multiplication factor encodings for the system PLL.

#### NOTE

If RCWLR[DDRCM] and RCWLR[LBCM] are both cleared, the system PLL VCO frequency = (CSB frequency) × (System PLL VCO Divider).

If either RCWLR[DDRCM] or RCWLR[LBCM] are set, the system PLL VCO frequency =  $2 \times (CSB \text{ frequency}) \times (System \text{ PLL VCO Divider})$ .

The VCO divider needs to be set properly so that the System PLL VCO frequency is in the range of 400–800 MHz.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

The CLKIN frequency, RCWLR[SPMF], and RCWLR[COREPLL] settings must be chosen such that the resulting csb\_clk, MCK, LCLK[0:2], and core\_clk frequencies do not exceed their respective maximum or minimum operating frequencies. The value of SCCR[xCM] must be programmed such that the maximum internal operating frequency of the Security core, USB modules, SATA, and eSDHC will not exceed their respective value listed in this table.

<sup>&</sup>lt;sup>2</sup> The DDR data rate is 2× the DDR memory bus frequency.

The local bus frequency is ½, ¼, or 1/8 of the *lbiu\_clk* frequency (depending on LCRR[CLKDIV]) which is in turn 1x or 2x the *csb\_clk* frequency (depending on RCWLR[LBCM]).

**Table 72. System PLL Multiplication Factors** 

RCWLR[SPMF]	System PLL Multiplication Factor
0000	Reserved
0001	Reserved
0010	× 2
0011	× 3
0100	× 4
0101	× 5
0110	× 6
0111–1111	× 7 to × 15

As described in Section 22, "Clocking," The LBIUCM, DDRCM, and SPMF parameters in the reset configuration word low and the CFG\_CLKIN\_DIV configuration input signal select the ratio between the primary clock input (CLKIN or PCI\_CLK) and the internal coherent system bus clock (*csb\_clk*). Table 74 and Table 75 show the expected frequency values for the CSB frequency for select *csb\_clk* to CLKIN/PCI\_SYNC\_IN ratios.

The RCWLR[SVCOD] denotes the system PLL VCO internal frequency as shown in Table 73.

Table 73. System PLL VCO Divider

RCWLR[SVCOD]	VCO Division Factor
00	4
01	8
10	2
11	1

**Table 74. CSB Frequency Options for Host Mode** 

		Input Clo		lock Frequency	(MHz) <sup>2</sup>	
CFG_CLKIN_DIV at Reset <sup>1</sup>	SPMF	csb_clk: Input Clock Ratio <sup>2</sup>	25	33.33	66.67	
		-	csb_clk Frequency (MHz)		ИHz)	
High	0010	2:1			133	
High	0011	3:1			200	
High	0100	4:1		133	267	
High	0101	5 : 1		167	333	
High	0110	6:1	150	200	400	

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

**Table 74. CSB Frequency Options for Host Mode (continued)** 

		Input		Clock Frequency (	MHz) <sup>2</sup>	
CFG_CLKIN_DIV at Reset <sup>1</sup>	SPMF	csb_clk : Input Clock Ratio <sup>2</sup>	25	33.33	66.67	
			csk	o_ <i>clk</i> Frequency (N	(MHz)	
High	0111	7:1	175	233		
High	1000	8:1	200	267		
High	1001	9:1	225	300		
High	1010	10 : 1	250	333		
High	1011	11 : 1	275	367		
High	1100	12:1	300	400		
High	1101	13 : 1	325			
High	1110	14 : 1	350			
High	1111	15 : 1	375			

<sup>&</sup>lt;sup>1</sup> CFG\_CLKIN\_DIV select the ratio between CLKIN and PCI\_SYNC\_OUT.

**Table 75. CSB Frequency Options for Agent Mode** 

			Input (	Clock Frequency	(MHz) <sup>2</sup>
CFG_CLKIN_DIV at reset <sup>1</sup>	SPMF csb_clk: Input Clock Ratio <sup>2</sup>		25	33.33	66.67
			csb	_clk Frequency (	MHz)
Low	0010	2:1			133
Low	0011	3:1			200
Low	0100	4:1		133	267
Low	0101	5:1		167	333
Low	0110	6 : 1	150	200	400
Low	0111	7:1	175	233	
Low	1000	8:1	200	267	
Low	1001	9:1	225	300	
Low	1010	10 : 1	250	333	
Low	1011	11 : 1	275	367	
Low	1100	12 : 1	300	400	
Low	1101	13:1	325		
Low	1110	14 : 1	350		
Low	1111	15 : 1	375		

<sup>&</sup>lt;sup>2</sup> CLKIN is the input clock in host mode; PCI\_CLK is the input clock in agent mode.

#### Clocking

# 22.2 Core PLL Configuration

RCWLR[COREPLL] selects the ratio between the internal coherent system bus clock (*csb\_clk*) and the e300 core clock (*core\_clk*). Table 76 shows the encodings for RCWLR[COREPLL]. COREPLL values that are not listed in Table 76 should be considered as reserved.

#### NOTE

Core VCO frequency = core frequency  $\times$  VCO divider VCO divider has to be set properly so that the core VCO frequency is in the range of 800–1600 MHz.

Table 76. e300 Core PLL Configuration

RC	CWLR[COREPLL]		and aller och alle Datio	VCO Divider <sup>1</sup>
0–1	2–5	6	- core_clk: csb_clk Ratio	VCO Divider
nn	0000	0	PLL bypassed (PLL off, csb_clk clocks core directly)	PLL bypassed (PLL off, csb_clk clocks core directly)
11	nnnn	n	n/a	n/a
00	0001	0	1:1	2
01	0001	0	1:1	4
10	0001	0	1:1	8
00	0001	1	1.5:1	2
01	0001	1	1.5:1	4
10	0001	1	1.5:1	8
00	0010	0	2:1	2
01	0010	0	2:1	4
10	0010	0	2:1	8
00	0010	1	2.5:1	2
01	0010	1	2.5:1	4
10	0010	1	2.5:1	8
00	0011	0	3:1	2
01	0011	0	3:1	4
10	0011	0	3:1	8
00	0011	1	3.5:1	2
01	0011	1	3.5:1	4
10	0011	1	3.5:1	8

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

<sup>&</sup>lt;sup>1</sup> CFG\_CLKIN\_DIV doubles csb\_clk if set high.

<sup>&</sup>lt;sup>2</sup> CLKIN is the input clock in host mode; PCI\_CLK is the input clock in agent mode.

Table 76. e300 Core PLL Configuration (continued)

RC	CWLR[COREPLL]		core_clk: csb_clk Ratio	VCO Divider <sup>1</sup>		
0–1	2–5	6	COI E_CIK : CSD_CIK INALIO	VOO DIVIGEI		
00	0100	0	4:1	2		
01	0100	0	4:1	4		
10	0100	0	4:1	8		

#### Note:

# 22.3 Suggested PLL Configurations

Table 77 shows suggested PLL configurations for different input clocks (LBCM = 0).

**Table 77. Example Clock Frequency Combinations** 

								eLBC <sup>1</sup> e300 Core			e <sup>1</sup>				
Ref <sup>1</sup>	LBCM	DDRCM	SVCOD	SPMF	Sys VCO <sup>1,2</sup>	CSB <sup>1,3</sup>	DDR data rate <sup>1,4</sup>	/2	/4	/8	× 1	× 1.5	× 2	× 2.5	× <b>3</b>
25.0	0	1	2	5	500	125	250	62.5	31.3	15.6		_		_	375
25.0	0	1	2	6	600	150	300	75 <sup>6</sup>	37.5	18.8		_		375	450
33.3	0	1	2	5	667	167	333	83.3 <sup>6</sup>	41.6	20.8		_	333	416	500
33.3	0	1	2	4	533	133	267	66.7	33.3	16.7		_		333	400
48.0	0	1	2	3	576	144	288	72 <sup>6</sup>	36	18	_	_	_	360	432
66.7	0	1	2	2	533	133	266	66.7	33.3	16.7	_	_	_	333	400
25.0	0	0	4	8	800	200	200	100 <sup>6</sup>	50	25	_	_	400	500	600
33.3	0	0	2	8	533	266.7	267	133 <sup>6</sup>	66.7	33.3	_	400	533	667	800
50.0	0	0	4	4	800	200	200	100 <sup>6</sup>	50	25	_	_	400	500	600
50.0	0	0	2	8	800	400	400 <sup>5</sup>	_	100 <sup>6</sup>	50	_	600	800	_	_
66.7	0	0	2	4	533	266.7	267	133 <sup>6</sup>	66.7	33.3	_	400	533	667	800
66.7	0	0	2	5	667	333	333	_	83.3 <sup>6</sup>	41.6	333	500	667	_	_
66.7	0	0	2	6	800	400	400 <sup>5</sup>	_	100 <sup>6</sup>	50	400	600	800	_	_

#### Note:

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Core VCO frequency = Core frequency × VCO divider. Note that VCO divider has to be set properly so that the core VCO frequency is in the range of 800–1600 MHz.

<sup>&</sup>lt;sup>1</sup> Values in MHz.

<sup>&</sup>lt;sup>2</sup> System PLL VCO range: 400-800 MHz.

<sup>&</sup>lt;sup>3</sup> CSB frequencies less than 133 MHz will not support Gigabit Ethernet rates.

 $<sup>^{\</sup>rm 4}\,$  Minimum data rate for DDR2 is 250 MHz and for DDR1 is 167 MHz.

<sup>&</sup>lt;sup>5</sup> Applies to DDR2 only.

<sup>&</sup>lt;sup>6</sup> Applies to eLBC PLL-enabled mode only.

## 23 Thermal

This section describes the thermal specifications of the MPC8379E.

## 23.1 Thermal Characteristics

Table 78 provides the package thermal characteristics for the 689 31 × 31mm TePBGA II package.

Table 78. Package Thermal Characteristics for TePBGA II

Parameter	Symbol	Value	Unit	Notes
Junction-to-ambient natural convection on single layer board (1s)	$R_{\theta JA}$	21	°C/W	1, 2
Junction-to-ambient natural convection on four layer board (2s2p)	$R_{\theta JA}$	15	°C/W	1, 2, 3
Junction-to-ambient (at 200 ft/min) on single layer board (1s)	$R_{\theta JMA}$	16	°C/W	1, 3
Junction-to-ambient (at 200 ft/min) on four layer board (2s2p)	$R_{\theta JMA}$	12	°C/W	1, 3
Junction-to-board thermal	$R_{\theta JB}$	8	°C/W	4
Junction-to-case thermal	$R_{\theta JC}$	6	°C/W	5
Junction-to-package natural convection on top	ΨЈТ	6	°C/W	6

#### Note:

# 23.2 Thermal Management Information

For the following sections,  $P_D = (V_{DD} \times I_{DD}) + P_{I/O}$  where  $P_{I/O}$  is the power dissipation of the I/O drivers.

# 23.2.1 Estimation of Junction Temperature with Junction-to-Ambient Thermal Resistance

An estimation of the chip junction temperature,  $T_J$ , can be obtained from the equation:

$$T_J = T_A + (R_{\theta JA} \times P_D)$$
  
where:

 $T_I$  = junction temperature (°C)

 $T_A$  = ambient temperature for the package (°C)

 $R_{\theta JA}$  = junction to ambient thermal resistance (°C/W)

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

<sup>&</sup>lt;sup>2</sup> Per JEDEC JESD51-2 with the single layer board horizontal. Board meets JESD51-9 specification.

<sup>&</sup>lt;sup>3</sup> Per JEDEC JESD51-6 with the board horizontal.

Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

<sup>&</sup>lt;sup>6</sup> Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

$$P_D$$
 = power dissipation in the package (W)

The junction to ambient thermal resistance is an industry-standard value that provides a quick and easy estimation of thermal performance. Generally, the value obtained on a single layer board is appropriate for a tightly packed printed circuit board. The value obtained on the board with the internal planes is usually appropriate if the board has low power dissipation and the components are well separated. Test cases have demonstrated that errors of a factor of two (in the quantity  $T_J - T_A$ ) are possible.

# 23.2.2 Estimation of Junction Temperature with Junction-to-Board Thermal Resistance

#### NOTE

The heat sink cannot be mounted on the package.

The thermal performance of a device cannot be adequately predicted from the junction to ambient thermal resistance. The thermal performance of any component is strongly dependent on the power dissipation of surrounding components. In addition, the ambient temperature varies widely within the application. For many natural convection and especially closed box applications, the board temperature at the perimeter (edge) of the package is approximately the same as the local air temperature near the device. Specifying the local ambient conditions explicitly as the board temperature provides a more precise description of the local ambient conditions that determine the temperature of the device.

At a known board temperature, the junction temperature is estimated using the following equation:

$$T_J = T_A + (R_{\theta JB} \times P_D)$$
 where: 
$$T_A = \text{ambient temperature for the package (°C)}$$
 
$$R_{\theta JB} = \text{junction to board thermal resistance (°C/W) per JESD51-8}$$
 
$$P_D = \text{power dissipation in the package (W)}$$

When the heat loss from the package case to the air can be ignored, acceptable predictions of junction temperature can be made. The application board should be similar to the thermal test condition: the component is soldered to a board with internal planes.

# 23.2.3 Experimental Determination of Junction Temperature NOTE

The heat sink cannot be mounted on the package.

To determine the junction temperature of the device in the application after prototypes are available, use the thermal characterization parameter ( $\Psi_{JT}$ ) to determine the junction temperature and a measure of the temperature at the top center of the package case using the following equation:

$$T_J = T_T + (\Psi_{JT} \times P_D)$$
 where: 
$$T_J = \text{junction temperature (°C)}$$
  $T_T = \text{thermocouple temperature on top of package (°C)}$ 

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Thermal

 $\Psi_{JT}$  = junction to ambient thermal resistance (°C/W)  $P_D$  = power dissipation in the package (W)

The thermal characterization parameter is measured per the JESD51-2 specification using a 40 gauge type T thermocouple epoxied to the top center of the package case. The thermocouple should be positioned so that the thermocouple junction rests on the package. A small amount of epoxy is placed over the thermocouple junction and over about 1 mm of wire extending from the junction. The thermocouple wire is placed flat against the package case to avoid measurement errors caused by cooling effects of the thermocouple wire.

## 23.2.4 Heat Sinks and Junction-to-Case Thermal Resistance

For the power values the device is expected to operate at, it is anticipated that a heat sink will be required. A preliminary estimate of heat sink performance can be obtained from the following first first-cut approach. The thermal resistance is expressed as the sum of a junction to case thermal resistance and a case-to-ambient thermal resistance:

 $R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$  where:  $R_{\theta JA} = \text{junction to ambient thermal resistance (°C/W)}$   $R_{\theta JC} = \text{junction to case thermal resistance (°C/W)}$   $R_{\theta CA} = \text{case to ambient thermal resistance (°C/W)}$ 

 $R_{\theta JC}$  is device-related and cannot be influenced by the user. The user controls the thermal environment to change the case to ambient thermal resistance,  $R_{\theta CA}$ . For instance, the user can change the size of the heat sink, the air flow around the device, the interface material, the mounting arrangement on printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device.

This first-cut approach overestimates the heat sink size required, since heat flow through the board is not accounted for, which can be as much as one-third to one-half of the power generated in the package.

Accurate thermal design requires thermal modeling of the application environment using computational fluid dynamics software which can model both the conduction cooling through the package and board and the convection cooling due to the air moving through the application. Simplified thermal models of the packages can be assembled using the junction-to-case and junction-to-board thermal resistances listed in the thermal resistance table. More detailed thermal models can be made available on request.

The thermal performance of devices with heat sinks has been simulated with a few commercially available heat sinks. The heat sink choice is determined by the application environment (temperature, air flow, adjacent component power dissipation) and the physical space available. Because of the wide variety of application environments, a single standard heat sink applicable to all cannot be specified.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Table 79 shows the heat sink thermal resistance for TePBGA II package with heat sinks, simulated in a standard JEDEC environment, per JESD 51-6.

Table 79. Thermal Resistance with Heat Sink in Open Flow (TePBGA II)

		Thermal Resistance
Heat Sink Assuming Thermal Grease	Air Flow	(°/W)
AAVID $30 \times 30 \times 9.4$ mm Pin Fin	Natural Convection	13.1
	0.5 m/s	10.6
	1 m/s	9.3
	2 m/s	8.2
	4 m/s	7.5
AAVID 31 $ imes$ 35 $ imes$ 23 mm Pin Fin	Natural Convection	11.1
	0.5 m/s	8.5
	1 m/s	7.7
	2 m/s	7.2
	4 m/s	6.8
AAVID 43× 41× 16.5mm Pin Fin	Natural Convection	11.3
	0.5 m/s	9.0
	1 m/s	7.8
	2 m/s	7.0
	4 m/s	6.5
Wakefield, $53 \times 53 \times 25$ mm Pin Fin	Natural Convection	9.7
	0.5 m/s	7.7
	1 m/s	6.8
	2 m/s	6.4
	4 m/s	6.1

Heat sink vendors include the following:

Aavid Thermalloy www.aavidthermalloy.com Alpha Novatech www.alphanovatech.com

International Electronic Research Corporation (IERC) www.ctscorp.com

Millennium Electronics (MEI) www.mei-thermal.com

### MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **Thermal**

Tyco Electronics Chip Coolers<sup>TM</sup> www.chipcoolers.com

Wakefield Engineering www.wakefield.com

Interface material vendors include the following:

Chomerics, Inc. www.chomerics.com

Dow-Corning Corporation Dow-Corning Electronic Materials www.dowcorning.com

Shin-Etsu MicroSi, Inc. www.microsi.com

The Bergquist Company www.bergquistcompany.com

## 23.3 Heat Sink Attachment

The device requires the use of heat sinks. When heat sinks are attached, an interface material is required, preferably thermal grease and a spring clip. The spring clip should connect to the printed circuit board, either to the board itself, to hooks soldered to the board, or to a plastic stiffener. Avoid attachment forces that can lift the edge of the package or peel the package from the board. Such peeling forces reduce the solder joint lifetime of the package. The recommended maximum compressive force on the top of the package is 10 lb force (4.5 kg force). Any adhesive attachment should attach to painted or plastic surfaces, and its performance should be verified under the application requirements.

# 23.3.1 Experimental Determination of the Junction Temperature with a Heat Sink

When a heat sink is used, the junction temperature is determined from a thermocouple inserted at the interface between the case of the package and the interface material. A clearance slot or hole is normally required in the heat sink. Minimize the size of the clearance to minimize the change in thermal performance caused by removing part of the thermal interface to the heat sink. Because of the experimental difficulties with this technique, many engineers measure the heat sink temperature and then back calculate the case temperature using a separate measurement of the thermal resistance of the interface. From this case temperature, the junction temperature is determined from the junction to case thermal resistance.

$$T_J = T_C + (R_{\theta JC} \times P_D)$$
 where: 
$$T_J = \text{junction temperature (°C)}$$
  $T_C = \text{case temperature of the package (°C)}$ 

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

 $R_{\theta JC}$  = junction to case thermal resistance (°C/W)  $P_D$  = power dissipation (W)

# 24 System Design Information

This section provides electrical and thermal design recommendations for successful application of the MPC8379E.

## 24.1 PLL Power Supply Filtering

Each of the PLLs listed above is provided with power through independent power supply pins. The  $AV_{DD}$  level should always be equivalent to  $V_{DD}$ , and preferably these voltages will be derived directly from  $V_{DD}$  through a low frequency filter scheme.

There are a number of ways to reliably provide power to the PLLs, but the recommended solution is to provide five independent filter circuits as illustrated in Figure 62, one to each of the five AV<sub>DD</sub> pins. By providing independent filters to each PLL, the opportunity to cause noise injection from one PLL to the other is reduced.

This circuit is intended to filter noise in the PLLs resonant frequency range from a 500 kHz to 10 MHz range. It should be built with surface mount capacitors with minimum Effective Series Inductance (ESL). Consistent with the recommendations of Dr. Howard Johnson in *High Speed Digital Design: A Handbook of Black Magic* (Prentice Hall, 1993), multiple small capacitors of equal value are recommended over a single large value capacitor.

Each circuit should be placed as close as possible to the specific  $AV_{DD}$  pin being supplied to minimize noise coupled from nearby circuits. It should be possible to route directly from the capacitors to the  $AV_{DD}$  pin, which is on the periphery of package, without the inductance of vias.

Figure 62 shows the PLL power supply filter circuit.

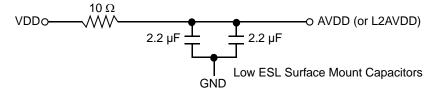


Figure 62. PLL Power Supply Filter Circuit

## 24.2 Decoupling Recommendations

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the device system, and the device itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each VDD, OVDD, GVDD, and LVDD pins of the device. These decoupling capacitors should receive their power from separate VDD, OVDD, GVDD, LVDD, and GND power planes in the PCB, utilizing short traces to minimize inductance. Capacitors may be placed directly under the device using a standard escape pattern. Others may surround the part.

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

#### **System Design Information**

These capacitors should have a value of 0.01 or 0.1 µF. Only ceramic SMT (surface mount technology) capacitors should be used to minimize lead inductance, preferably 0402 or 0603 sizes.

In addition, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the VDD, OVDD, GVDD, and LVDD planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They should also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors— $100-330~\mu F$  (AVX TPS tantalum or Sanyo OSCON).

## 24.3 Connection Recommendations

To ensure reliable operation, it is highly recommended that unused inputs be connected to an appropriate signal level. Unused active low inputs should be tied to OVDD, GVDD, or LVDD as required. Unused active high inputs should be connected to GND. All NC (no-connect) signals must remain unconnected.

Power and ground connections must be made to all external VDD, GVDD, LVDD, OVDD, and GND pins of the device.

## 24.4 Output Buffer DC Impedance

The device drivers are characterized over process, voltage, and temperature. For all buses, the driver is a push-pull single-ended driver type (open drain for  $I^2C$ ).

To measure  $Z_0$  for the single-ended drivers, an external resistor is connected from the chip pad to OVDD or GND. Then, the value of each resistor is varied until the pad voltage is  $OV_{DD}/2$  (see Figure 63). The output impedance is the average of two components, the resistances of the pull-up and pull-down devices. When data is held high, SW1 is closed (SW2 is open) and  $R_P$  is trimmed until the voltage at the pad equals  $OV_{DD}/2$ .  $R_P$  then becomes the resistance of the pull-up devices.  $R_P$  and  $R_N$  are designed to be close to each other in value. Then,  $Z_0 = (R_P + R_N)/2$ .

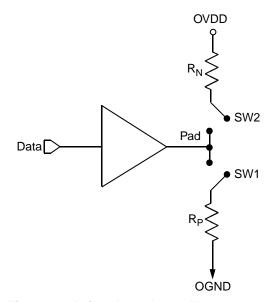


Figure 63. Driver Impedance Measurement

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

The value of this resistance and the strength of the driver's current source can be found by making two measurements. First, the output voltage is measured while driving logic 1 without an external differential termination resistor. The measured voltage is  $V_1 = R_{source} \times I_{source}$ . Second, the output voltage is measured while driving logic 1 with an external precision differential termination resistor of value  $R_{term}$ . The measured voltage is  $V_2 = (1/(1/R_1 + 1/R_2)) \times I_{source}$ . Solving for the output impedance gives  $R_{source} = R_{term} \times (V_1/V_2 - 1)$ . The drive current is then  $I_{source} = V_1/R_{source}$ .

Table 80 summarizes the signal impedance targets. The driver impedance are targeted at minimum  $V_{DD}$ , nominal  $OV_{DD}$ ,  $105^{\circ}C$ .

Impedance	Local Bus, Ethernet, DUART, Control, Configuration, Power Management	PCI Signals (not including PCI output clocks)	PCI Output Clocks (including PCI_SYNC_OUT)	DDR DRAM	Symbol	Unit
R <sub>N</sub>	42 Target	25 Target	42 Target	20 Target	Z <sub>0</sub>	W
R <sub>P</sub>	42 Target	25 Target	42 Target	20 Target	Z <sub>0</sub>	W
Differential	NA	NA	NA	NA	Z <sub>DIFF</sub>	W

**Table 80. Impedance Characteristics** 

**Note:** Nominal supply voltages. See Table 2,  $T_i = 105$ °C.

# 24.5 Configuration Pin Muxing

The device provides the user with power-on configuration options which can be set through the use of external pull-up or pull-down resistors of 4.7 k $\Omega$  on certain output pins (see customer visible configuration pins). These pins are generally used as output only pins in normal operation.

While HRESET is asserted however, these pins are treated as inputs. The value presented on these pins while HRESET is asserted, is latched when PORESET deasserts, at which time the input receiver is disabled and the I/O circuit takes on its normal function. Careful board layout with stubless connections to these pull-up/pull-down resistors coupled with the large value of the pull-up/pull-down resistor should minimize the disruption of signal quality or speed for output pins thus configured.

## 24.6 Pull-Up Resistor Requirements

The device requires high resistance pull-up resistors (10 k $\Omega$  is recommended) on open drain type pins including I<sup>2</sup>C pins and IPIC interrupt pins.

For more information on required pull-up resistors and the connections required for the JTAG interface, see AN3665, "MPC837xE Design Checklist."

# 25 Ordering Information

Ordering information for the parts fully covered by this specification document is provided in Section 25.1, "Part Numbers Fully Addressed by This Document."

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# 25.1 Part Numbers Fully Addressed by This Document

Table 81 provides the Freescale part numbering nomenclature for the MPC8379E. Note that the individual part numbers correspond to a maximum processor core frequency. For available frequencies, contact your local Freescale sales office. In addition to the processor frequency, the part numbering scheme also includes an application modifier which may specify special application conditions. Each part number also contains a revision code which refers to the die mask revision number.

**Table 81. Part Numbering Nomenclature** 

MPC	8379	E	С	ZQ	AF	D	A
Product Code	Part Identifier	Encryption Acceleration	Temperature Range <sup>1</sup>	Package <sup>2</sup>	e300 core Frequency <sup>3</sup>	DDR Data Rate	Revision Level
MPC	8379	Blank = Not included E = included	Blank = 0°C ( $T_a$ ) to 125°C ( $T_j$ ) C = -40°C ( $T_a$ ) to 125°C ( $T_j$ )		AN = 800 MHz AL = 667 MHz AJ = 533 MHz AG = 400 MHz	F = 333 MHz D = 266 MHz	Freescale

#### Note:

Table 82 lists the available core and DDR data rate frequency combinations.

Table 82. Available Parts (Core/DDR Data Rate)

MPC8377E	MPC8378E	MPC8379E
800 MHz/400 MHz	800 MHz/400 MHz	800 MHz/400 MHz
667 MHz/400 MHz	667 MHz/400 MHz	667 MHz/400 MHz
533 MHz/333 MHz	533 MHz/333 MHz	533 MHz/333 MHz
400 MHz/266 MHz	400 MHz/266 MHz	400 MHz/266 MHz

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

Contact local Freescale office on availability of parts with an extended temperature range.

<sup>&</sup>lt;sup>2</sup> See Section 21, "Package and Pin Listings," for more information on the available package type.

<sup>&</sup>lt;sup>3</sup> Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by Part Number Specifications may support other maximum core frequencies.

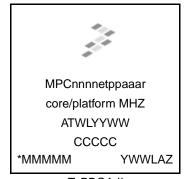
Table 83 shows the SVR and PVR settings by device.

Table 83. SVR and PVR Settings by Product Revision

<b>D</b> . 1		SI	/R	PVR		
Device	Package	Rev 1.0	Rev. 2.1	Rev. 1.0	Rev. 2.1	
MPC8377		0x80C7_0010	0x80C7_0021		0x8086_1011	
MPC8377E		0x80C6_0010	0x80C6_0021	0x8086_1010		
MPC8378	T-DDCA II	0x80C5_0010	0x80C5_0021			
MPC8378E	TePBGA II	0x80C4_0010	0x80C4_0021			
MPC8379		0x80C3_0010	0x80C3_0021			
MPC8379E		0x80C2_0010	0x80C2_0021			

# 25.2 Part Marking

Parts are marked as in the example shown in Figure 64.



TePBGA II

Notes:

ATWLYYWW is the traceability code.

CCCCC is the country code.

MMMMM is the mask number.

YWWLAZ is the assembly traceability code.

Figure 64. Freescale Part Marking for TePBGA II Devices

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

# **26 Document Revision History**

Table 84 provides a revision history for this hardware specification.

**Table 84. Document Revision History** 

Revision	Date	Substantive Change(s)
4	11/2010	<ul> <li>In Table 25, "RGMII and RTBI DC Electrical Characteristics," updated V<sub>IH</sub> min value to 1.7.</li> <li>In Table 40, "Local Bus General Timing Parameters—PLL Bypass Mode," added row for t<sub>LBKHLR</sub>.</li> <li>In Section 10.2, "Local Bus AC Electrical Specifications," and in Section 22, "Clocking," updated LCCR to LCRR.</li> <li>In Table 69, "TePBGA II Pinout Listing," added SD_WP to pin C9. Also clarified TEST_SEL0 and TEST_SEL1 pins—no change in functionality.</li> </ul>
3	03/2010	<ul> <li>Added Section 4.3, "eTSEC Gigabit Reference Clock Timing."</li> <li>In Table 34, "USB DC Electrical Characteristics," and Table 35, "USB General Timing Parameters (ULPI Mode Only)," added table footnotes.</li> <li>In Table 39, "Local Bus General Timing Parameters—PLL Enable Mode," and Table 40, "Local Bus General Timing Parameters—PLL Bypass Mode," corrected footnotes for t<sub>LBOTOT1</sub>, t<sub>LBOTOT2</sub>, t<sub>LBOTOT3</sub>.</li> <li>In Figure 22, "Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 2 (PLL Enable Mode)," and Figure 24, "Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 4 (PLL Enable Mode)," shifted "Input Signals: LAD[0:31]/LDP[0:3]" from the falling edge to the rising edge of LSYNC_IN.</li> <li>In Figure 60, "Mechanical Dimensions and Bottom Surface Nomenclature of the TEPBGA II," added heat spreader.</li> <li>In Section 24.6, "Pull-Up Resistor Requirements," removed "Ethernet Management MDIO pin" from list of open drain type pins.</li> <li>In Table 69, "TePBGA II Pinout Listing," updated the Pin Type column for AVDD_C, AVDD_L, and AVDD_P pins.</li> <li>In Table 69, "TePBGA II Pinout Listing," added Note 17 to eTSEC pins.</li> <li>In Table 69, "TePBGA II Pinout Listing," added Note 17 to eTSEC pins.</li> <li>In Table 69, "TePBGA II Pinout Listing," added Note 17 to eTSEC pins.</li> <li>In Table 81, "Part Numbering Nomenclature," removed footnote to "e300 core Frequency."</li> </ul>

MPC8379E PowerQUICC II Pro Processor Hardware Specifications, Rev. 4

**Table 84. Document Revision History (continued)** 

Revision	Date	Substantive Change(s)
2	10/2009	<ul> <li>In Table 3, "Recommended Operating Conditions," added "Operating temperature range" values.</li> <li>In Table 5, "MPC8377EMPC8378EMPC8379E Power Dissipation <sup>1</sup>," corrected maximal application for 800/400 MHz to 4.3 W.</li> <li>In Table 5, "MPC8377EMPC8378EMPC8379E Power Dissipation <sup>1</sup>," added a column for "Typical Application at T<sub>j</sub> = 65°C (W)".</li> <li>In Table 5, "MPC8377EMPC8378EMPC8379E Power Dissipation <sup>1</sup>," added a column for "Sleep Power at T<sub>j</sub> = 65°C (W)".</li> <li>In Table 11, removed overbar from CFG_CLKIN_DIV.</li> <li>In Table 11, removed overbar from CFG_CLKIN_DIV.</li> <li>In Table 17, "Current Draw Characteristics for MV<sub>REF</sub>," updated I<sub>MVREF</sub> maximum value for both DDR1 and DDR2 to 600 and 400 μA, respectively. Also, updated Note 1 and added Note 2.</li> <li>In Table 20, "DDR1 and DDR2 SDRAM Input AC Timing Specifications," column headings renamed to "Min" and "Max". Footnote 2 updated to state "T is the MCK clock period".</li> <li>In Table 20, "DDR1 and DDR2 SDRAM Input AC Timing Specifications," and Table 21, "DDR1 and DDR2 SDRAM Output AC Timing Specifications," clarified that the frequency parameters are data rates.</li> <li>In Table 29, "RMII Transmit AC Timing Specifications," updated t<sub>RMTDX</sub>I to 2.0 ns.</li> <li>In Table 57, Gen 1i/1.5G Transmitter AC Specifications," and Table 59, Gen 2i/3G Transmitter AC Specifications," corrected titles from "Transmitter" to "Receiver".</li> <li>In Table 69, "TePBGA II Pinout Listing," removed pin THERM0; it is now Reserved. Also added 1.05 V to VDD pin.</li> <li>In Table 71, "Operating Frequencies for TePBGA II," corrected "DDR2 memory bus frequency (MCK)" range to 125–200.</li> <li>In Table 76, "e300 Core PLL Configuration," added 3.5:1 and 4:1 core_clk: csb_clk ratio options.</li> <li>In Table 77, "Example Clock Frequency Combinations," updated column heading to "DDR data rate".</li> <li>In Section 19.2, "SPI AC Timing Specifications," corrected t<sub>NIKHOX</sub> and t<sub>NEKHOX</sub> respectively.</li> </ul>
1	02/2009	<ul> <li>In Table 3, "Recommended Operating Conditions," added two new rows for 800 MHz, and created two rows for SerDes. In addition, changed 666 to 667 MHz.</li> <li>In Table 5, "MPC8377EMPC8378EMPC8379E Power Dissipation <sup>1</sup>," added Notes 4 and 5. In addition, changed 666 to 667 MHz.</li> <li>In Table 13, "DDR2 SDRAM DC Electrical Characteristics for GV<sub>DD</sub>(typ) = 1.8 V," Table 21, "DDR1 and DDR2 SDRAM Output AC Timing Specifications," and Table 69, "TePBGA II Pinout Listing," added footnote to references to MVREF, MDQ, and MDQS, referencing AN3665, <i>MPC837xE Design Checklist</i>.</li> <li>In Table 21, updated t<sub>DDKHCX</sub> minimum value for 333 MHz to 2.40.</li> <li>In Table 69, "TePBGA II Pinout Listing," added footnote to USBDR_STP_SUSPEND and modified footnote 10 and added footnote 15.</li> <li>In Table 71, "Operating Frequencies for TePBGA II," changed 667 to 800 MHz for <i>core_clk</i>.</li> <li>In Table 77, "Example Clock Frequency Combinations," added 800 MHz cells for e300 core.</li> <li>Updated part numbering information in AF column in Table 81, "Part Numbering Nomenclature." In addition, modified extended temperature information in notes 1 and 4.</li> <li>In Table 82, "Available Parts (Core/DDR Data Rate)," added new row for 800/400 MHz.</li> </ul>
0	12/2008	Initial public release.

#### How to Reach Us:

#### Home Page:

www.freescale.com

#### Web Support:

http://www.freescale.com/support

#### **USA/Europe or Locations Not Listed:**

Freescale Semiconductor, Inc.
Technical Information Center, EL516
2100 East Elliot Road
Tempe, Arizona 85284
1-800-521-6274 or
+1-480-768-2130
www.freescale.com/support

#### Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH Technical Information Center Schatzbogen 7 81829 Muenchen, Germany +44 1296 380 456 (English) +46 8 52200080 (English) +49 89 92103 559 (German) +33 1 69 35 48 48 (French) www.freescale.com/support

#### Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku Tokyo 153-0064 Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

#### Asia/Pacific:

Freescale Semiconductor China Ltd. Exchange Building 23F No. 118 Jianguo Road Chaoyang District Beijing 100022 China +86 10 5879 8000 support.asia@freescale.com

#### For Literature Requests Only:

Freescale Semiconductor

Literature Distribution Center 1-800 441-2447 or +1-303-675-2140 Fax: +1-303-675-2150 LDCForFreescaleSemiconductor @hibbertgroup.com Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductor products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters which may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others. Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Freescale Semiconductor was negligent regarding the design or manufacture of the part.

Freescale, the Freescale logo, and PowerQUICC are trademarks of Freescale Semiconductor, Inc. Reg. U.S. Pat. & Tm. Off. All other product or service names are the property of their respective owners. The Power Architecture and Power.org word marks and the Power and Power.org logos and related marks are trademarks and service marks licensed by Power.org. 802.3, 802.3u, 802.3x, 802.3z, 802.3au, 802.3ab, 1588All other product or service names are the property of their respective owners.

© 2008-2010 Freescale Semiconductor, Inc. All rights reserved.

Document Number: MPC8379EEC

Rev. 4 11/2010



